

EFR32BG29 Wireless SoC Family Data Sheet

The EFR32BG29 Wireless family of SoCs is part of the EFR32 Wireless SoC portfolio. EFR32BG29 wireless SoCs are ideal for enabling energy-friendly Bluetooth networking for IoT devices.

The single-die solution combines a 76.8 MHz Cortex-M33 with a high-performance 2.4 GHz radio to provide an industry-leading, energy-efficient wireless, SoC for IoT connected applications.

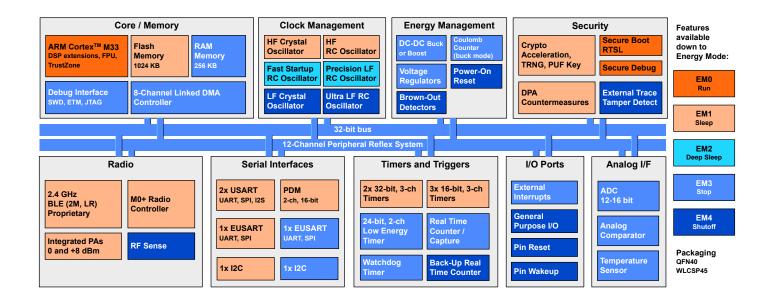
The devices are available with boost or buck DC-DC capabilities, enabling direct power from a wide variety of batteries.

EFR32BG29 applications include:

- Portable Medical
- · Home End Devices
- · Fleet/Asset Monitoring
- · Industrial Automation
- · Access Control
- · Bluetooth Mesh
- · Sports, Fitness, and Wellness Devices
- · Power Tools

KEY FEATURES

- 32-bit ARM® Cortex®-M33 core with 76.8 MHz maximum operating frequency
- · 1024 KB of flash and 256 KB of RAM
- Energy-efficient core with low active and sleep currents
- Integrated PA with up to 8 dBm (2.4 GHz) TX power
- Secure Vault™ High
- DC-DC supporting buck (1.8-3.8 V) or boost (1.2-1.7 V) operation
- · Available in WLCSP and QFN packaging



1. Feature List

The EFR32BG29 highlighted features are:

· Low-Power Wireless System-on-Chip

- High-performance 32-bit 76.8 MHz ARM Cortex[®]-M33 with DSP instruction and floating-point unit for efficient signal processing
- 1024 KB flash program memory
- · 256 KB RAM data memory
- · 2.4 GHz radio operation

· Radio Performance

- · -106.8 dBm sensitivity @ 125 kbps GFSK
- · -99 dBm sensitivity @ 1 Mbit/s GFSK
- -96.1 dBm sensitivity @ 2 Mbit/s GFSK
- · TX power up to 8 dBm

Low System Energy Consumption

- 3.6 mA RX current @ 1 Mbps GFSK (Buck DCDC, 3 V)
- 4 mA TX current @ 0 dBm output power (Buck DCDC, 3 V)
- 9 mA TX current @ 6 dBm output power (Buck DCDC, 3 V)
- 11 mA TX current @ 8 dBm output power (Buck DCDC, 3 V)
- 30 μA/MHz in Active Mode (EM0) at 76.8 MHz (Buck DCDC, 3 V)
- 3.4 µA EM2 DeepSleep current (256 KB RAM retention and RTC running from LFXO, Buck DCDC, 3 V)
- 1.5 µA EM2 DeepSleep current (16 KB RAM retention and RTC running from LFXO, Buck DCDC, 3 V)
- 0.16 µA EM4 current

Supported Modulation Format

- 2 (G)FSK with fully configurable shaping
- OQPSK DSSS
- (G)MSK

· Protocol Support

- Bluetooth Low Energy
- Proprietary

· Secure Vault High

- Hardware Cryptographic Acceleration for AES128/192/256, ChaCha20-Poly1305, SHA-1, SHA-2/256/384/512, ECDSA +ECDH(P-192, P-256, P-384, P-521), Ed25519 and Curve25519, J-PAKE, PBKDF2
- True Random Number Generator (TRNG)
- ARM® TrustZone®
- · Secure Boot (Root of Trust Secure Loader)
- Secure Debug Unlock
- · DPA Countermeasures
- · Secure Key Management with PUF
- Anti-Tamper
- · Secure Attestation
- Designed for PSA level 3 certification

· Wide Selection of MCU Peripherals

- Analog to Digital Converter (ADC)
 - 12-bit @ 1 Msps
 - · 16-bit @ 76.9 ksps
- Analog Comparator (ACMP)
- Up to 26 General Purpose I/O pins with output state retention and asynchronous interrupts
- · 8 Channel DMA Controller
- · 12 Channel Peripheral Reflex System (PRS)
- 2 × 32-bit Timer/Counter with 3 Compare/Capture/PWM channels
- 3 × 16-bit Timer/Counter with 3 Compare/Capture/PWM channels
- · 32-bit Real Time Counter
- · 24-bit Low-Energy Timer for waveform generation
- · 1 × Watchdog Timer
- 2 × Universal Synchronous/Asynchronous Receiver/Transmitter (UART/SPI/SmartCard (ISO 7816)/IrDA/I²S)
- 2 × Enhanced Universal Synchronous/Asynchronous Receiver/Transmitter (UART/SPI)
- 2 × I²C interface with SMBus support
- Digital microphone interface (PDM)
- Precision Low-Frequency RC Oscillator to replace 32 kHz sleep crystal
- · RFSENSE with selective OOK mode
- Die temperature sensor with +/-1.5 degree C accuracy after single-point calibration
- · Coulomb counter integrated into Buck DC-DC

Wide Operating Range

- · Devices with Buck DC-DC
 - 1.8 to 3.8 V supply range
 - -40 to 125 °C operating temperature
- · Devices with Boost DC-DC
 - · 1.2 to 1.7 V supply range
 - -20 to 55 °C operating temperature

Packages

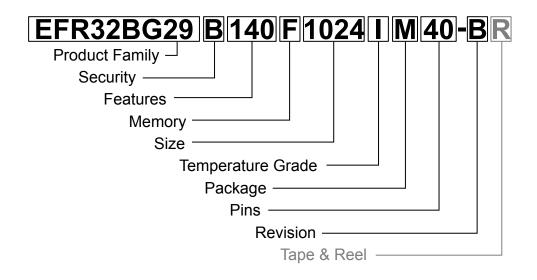
- QFN40 5 × 5 × 0.85 mm, 0.4 mm pitch
- WLCSP45 2.825 × 2.657 × 0.5 mm, 0.35 mm pitch (Boost DC-DC configuration)

2. Ordering Information

Table 2.1. Ordering Information

| Ordering Code | Protocol Stack | Max TX Power | DC-DC | Flash (KB) | RAM (KB) | GPIO | Package | Temp Range |
|--------------------------|---|-----------------|-------|---------------|-------------|------|---------|---------------|
| EFR32BG29B230F1024CM40-B | Bluetooth 5.xDirection Finding (AoA Transmitter)Proprietary | 6 dBm | Boost | 1024 | 256 | 25 | QFN40 | -20 to 55 °C |
| EFR32BG29B220F1024CJ45-B | Bluetooth 5.xDirection Finding (AoA Transmitter)Proprietary | 4 dBm | Boost | 1024 | 256 | 19 | WLCSP45 | -20 to 55 °C |
| EFR32BG29B140F1024IM40-B | Bluetooth 5.xDirection Finding (AoA Transmitter)Proprietary | 8 dBm | Buck | 1024 | 256 | 26 | QFN40 | -40 to 125 °C |

Bluetooth 5.x: As the Bluetooth standard evolves, Silicon Labs is regularly adding new features. For more information on supported Bluetooth capabilities, visit https://www.silabs.com/bluetooth-hardware.



| Field | Options | | | |
|--|---|--|--|--|
| Product Family | EFR32BG29: Wireless SoC Family | | | |
| Security | B: Secure Vault High | | | |
| f1 1: DC-DC Buck Converter 2: DC-DC Boost Converter f2 2: 4 dBm PA Transmit Power 3: 6 dBm PA Transmit Power 4: 8 dBm PA Transmit Power f3 0: 256 KB RAM | | | | |
| Memory | • F: Flash | | | |
| Size | Memory Size in KBytes | | | |
| Temperature Grade | • C: -20 to +55 °C • I: -40 to +125 °C | | | |
| Package | • M: QFN • J: WLCSP | | | |
| Pins | Number of Package Pins | | | |
| Revision | • B: Revision B | | | |
| Tape & Reel | • R: Tape & Reel (optional) | | | |

Figure 2.1. Ordering Code Key

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3. System Overview

3.1 Introduction

The EFR32 product family combines an energy-friendly MCU with a high-performance radio transceiver. The devices are well suited for secure connected IoT multi-protocol devices which require high performance and low energy consumption. This section gives a short introduction to the full radio and MCU system. A detailed functional description is available in the EFR32xG29 Reference Manual.

3.2 Radio

The EFR32BG29 Wireless features a highly configurable radio transceiver which supports the Bluetooth Low Energy wireless protocol.

3.2.1 Antenna Interface

The 2.4 GHz antenna interface consists of a single-ended pin (RF2G4_IO). The external components for the antenna interface in typical applications are shown in the RF Matching Networks section.

3.2.2 Fractional-N Frequency Synthesizer

The EFR32BG29 contains a high-performance, low phase noise, fully integrated fractional-N frequency synthesizer. The synthesizer is used in receive mode to generate the LO frequency for the down-conversion mixer. It is also used in transmit mode to directly generate the modulated RF carrier.

The fractional-N architecture provides excellent phase noise performance, frequency resolution better than 100 Hz, and low energy consumption. The synthesizer's fast frequency settling allows for very short receiver and transmitter wake up times to reduce system energy consumption.

3.2.3 Receiver Architecture

The EFR32BG29 uses a low-IF receiver architecture, which consists of a Low-Noise Amplifier (LNA) followed by an I/Q down-conversion mixer. The I/Q signals are further filtered and amplified before being sampled by the IF Analog-to-Digital Converter (IFADC).

The IF frequency is configurable from 150 to 1371 kHz. The IF can further be configured for high-side or low-side injection, providing flexibility with respect to known interferers at the image frequency.

The Automatic Gain Control (AGC) module adjusts the receiver gain to optimize performance and avoid saturation for excellent selectivity and blocking performance. The 2.4 GHz radio is calibrated at production to improve image rejection performance.

Demodulation is performed in the digital domain. The demodulator performs configurable decimation and channel filtering to allow receive bandwidths ranging from 0.1 to 2530 kHz. High carrier frequency and baud rate offsets are tolerated by active estimation and compensation. Advanced features supporting high-quality communication under adverse conditions include forward error correction by block and convolutional coding as well as Direct Sequence Spread Spectrum (DSSS).

A Received Signal Strength Indicator (RSSI) is available for signal quality metrics, level-based proximity detection, and RF channel access by Collision Avoidance (CA) or Listen Before Talk (LBT) algorithms. An RSSI capture value is associated with each received frame and the dynamic RSSI measurement can be monitored throughout reception.

3.2.4 Transmitter Architecture

The EFR32BG29 uses a direct-conversion transmitter architecture. For constant envelope modulation formats, the modulator controls phase and frequency modulation in the frequency synthesizer. Transmit symbols or chips are optionally shaped by a digital shaping filter. The shaping filter is fully configurable, including the BT product, and can be used to implement Gaussian or Raised Cosine shaping.

Carrier Sense Multiple Access - Collision Avoidance (CSMA-CA) or Listen Before Talk (LBT) algorithms can be automatically timed by the EFR32BG29. These algorithms are typically defined by regulatory standards to improve interoperability in a given bandwidth between devices that otherwise lack synchronized RF channel access.

3.2.5 Packet and State Trace

The EFR32BG29 Frame Controller has a packet and state trace unit that provides valuable information during the development phase. It features:

- · Non-intrusive trace of transmit data, receive data, and state information
- · Data observability on a single-pin UART data output or on a two-pin SPI data output
- · Configurable data output bitrate / baudrate
- · Multiplexed transmitted data, received data, and state / meta information in a single serial data stream

3.2.6 Data Buffering

The EFR32BG29 features an advanced Radio Buffer Controller (BUFC) capable of handling up to four buffers of adjustable size from 64 to 4096 bytes. Each buffer can be used for RX, TX, or for both. The buffer data is located in RAM, enabling zero-copy operations.

3.2.7 Radio Controller (RAC)

The RAC controls the top level state of the radio subsystem in the EFR32BG29. It performs the following tasks:

- · Precisely-timed control of enabling and disabling of the receiver and transmitter circuitry
- Run-time calibration of receiver, transmitter, and frequency synthesizer
- · Detailed frame transmission timing with optional LBT or CSMA-CA

3.2.8 RFSENSE Interface

The RFSENSE block allows the device to remain in EM2, EM3, or EM4 and wake when RF energy above a specified threshold is detected. When operated in selective mode, the RFSENSE block performs OOK preamble and sync word detection, preventing false wake-up events.

3.3 General Purpose Input/Output (GPIO)

EFR32BG29 has up to 26 GPIO pins. Each GPIO pin can be individually configured as either an output or input. More advanced configurations including open-drain, open-source, and glitch-filtering can be configured for each individual GPIO pin. The GPIO pins can be overridden by peripheral connections, like SPI communication. Each peripheral connection can be routed to several GPIO pins on the device. The input value of a GPIO pin can be routed through the Peripheral Reflex System (PRS) to other peripherals. The GPIO subsystem supports asynchronous external pin interrupts.

All of the pins on ports A and port B are EM2 capable. These pins may be used by low-energy peripherals in EM2/3 and may also be used as EM2/3 pin wake-ups. Pins on ports C and D are latched/retained in their current state when entering EM2 until EM2 exit upon which internal peripherals could once again drive those pads.

A few GPIOs also have wake functionality down to EM4. These pins are listed in the Alternate Function Table with the function GPIO.EM4WU.

3.4 Clocking

3.4.1 Clock Management Unit (CMU)

The CMU controls oscillators and clocks in the EFR32BG29. Individual enabling and disabling of clocks to all peripheral modules is performed by the CMU. The CMU also controls enabling and configuration of the oscillators. A high degree of flexibility allows software to optimize energy consumption in any specific application by minimizing power dissipation in unused peripherals and oscillators.

3.4.2 Internal and External Oscillators

The EFR32BG29 supports two crystal oscillators and fully integrates four RC oscillators:

- A high-frequency crystal oscillator (HFXO) with integrated load capacitors, tunable in small steps, provides a precise timing reference for the MCU. The HFXO provides excellent RF clocking performance using a 38.4 MHz crystal. The HFXO can also support an external clock source such as a TCXO for applications that require an extremely accurate clock frequency over temperature.
- A 32.768 kHz crystal oscillator (LFXO) provides an accurate timing reference for low-energy modes.
- An integrated high-frequency RC oscillator (HFRCO) is available for the MCU system, when crystal accuracy is not required. The HFRCO employs fast start-up at minimal energy consumption combined with a wide frequency range, from 1 to 76.8 MHz.
- An integrated fast start-up RC oscillator (FSRCO) that runs at a fixed 20 MHz
- An integrated low-frequency 32.768 kHz RC oscillator (LFRCO) for low-power operation without an external crystal. Precision mode enables periodic recalibration against the 38.4 MHz HFXO crystal to improve accuracy to ±500 ppm, suitable for BLE sleep interval timing.
- An integrated ultra-low-frequency 1 kHz RC oscillator (ULFRCO) is available to provide a timing reference at the lowest energy consumption in low-energy modes.

3.5 Counters/Timers and PWM

3.5.1 Timer/Counter (TIMER)

TIMER peripherals keep track of timing, count events, generate PWM outputs and trigger timed actions in other peripherals through the Peripheral Reflex System (PRS). The core of each TIMER is a 16-bit or 32-bit counter with up to 3 compare/capture channels. Each channel is configurable in one of three modes:

- In capture mode, the counter state is stored in a buffer at a selected input event.
- In compare mode, the channel output reflects the comparison of the counter to a programmed threshold value.
- In PWM mode, the TIMER supports generation of pulse-width modulation (PWM) outputs of arbitrary waveforms defined by the sequence of values written to the compare registers.

Complementary outputs with dead-time insertion are available on select TIMER output channels.

See 3.13 Configuration Summary for information on the feature set of each timer.

3.5.2 Low-Energy Timer (LETIMER)

The unique LETIMER is a 24-bit timer that is available in energy mode EM0 Active, EM1 Sleep, EM2 Deep Sleep, and EM3 Stop. This allows it to be used for timing and output generation when most of the device is powered down, allowing simple tasks to be performed while the power consumption of the system is kept at an absolute minimum. The LETIMER can be used to output a variety of waveforms with minimal software intervention. The LETIMER is connected to the Peripheral Reflex System (PRS), and can be configured to start counting on compare matches from other peripherals such as the Real Time Clock.

3.5.3 Real Time Clock with Capture (RTCC)

The RTCC is a 32-bit counter that provides timekeeping down to EM3. The RTCC can be clocked by any of the on-board, low-frequency oscillators, and it is capable of providing system wake-up at user-defined intervals.

A secondary RTC is used by the RF protocol stack for event scheduling, leaving the primary RTCC block available exclusively for application software.

3.5.4 Back-Up Real Time Counter (BURTC)

The Back-Up Real Time Counter (BURTC) is a 32-bit counter providing timekeeping in all energy modes, including EM4. The BURTC can be clocked by any of the on-board low-frequency oscillators, and it is capable of providing system wake-up at user-defined intervals.

3.5.5 Watchdog Timer (WDOG)

The watchdog timer can act both as an independent watchdog or as a watchdog synchronous with the CPU clock. It has windowed monitoring capabilities, and can generate a reset or different interrupts depending on the failure mode of the system. The watchdog can also monitor autonomous systems driven by the Peripheral Reflex System (PRS).

3.6 Communications and Other Digital Peripherals

3.6.1 Universal Synchronous/Asynchronous Receiver/Transmitter (USART)

The USART is a flexible serial I/O module. It supports full duplex asynchronous UART communication with hardware flow control as well as RS-485, SPI, MicroWire, and 3-wire. It can also interface with devices supporting:

- ISO7816 SmartCards
- IrDA
- I²S

3.6.2 Enhanced Universal Synchronous/Asynchronous Receiver/Transmitter (EUSART)

The EUSART supports full duplex asynchronous UART communication with hardware flow control, RS-485, and IrDA support. The EUSART also supports high-speed SPI. In EM0 and EM1, the EUSART provides a high-speed, buffered communication interface.

When routed to GPIO ports A or B, the EUSART0 may also be used in a low-energy mode and operate in EM2. A 32.768 kHz clock source allows full duplex UART communication up to 9600 baud. EUSART0 can also act as a SPI secondary device in EM2 and EM3, and wake the system when data is received from an external bus controller.

3.6.3 Inter-Integrated Circuit Interface (I²C)

The I²C module provides an interface between the MCU and a serial I²C bus. It is capable of acting as a main or secondary interface and supports multi-drop buses. Standard-mode, fast-mode, and fast-mode plus speeds are supported, allowing transmission rates from 10 kbit/s up to 1 Mbit/s. Bus arbitration and timeouts are also available, allowing implementation of an SMBus-compliant system. The interface provided to software by the I²C module allows precise timing control of the transmission process and highly automated transfers. Automatic recognition of addresses is provided in active and low-energy modes. Not all instances of I²C are available in all energy modes.

3.6.4 Peripheral Reflex System (PRS)

The PRS provides a communication network between different peripheral modules without software involvement. Peripheral modules producing reflex signals are called producers. The PRS routes reflex signals from producers to consumer peripherals which in turn perform actions in response. Edge triggers and other functionality, such as simple logic operations (AND, OR, NOT), can be applied by the PRS to the signals. The PRS allows peripherals to act autonomously without waking the MCU core, saving power.

3.6.5 Pulse Density Modulation (PDM) Interface

The PDM module provides a serial interface and decimation filter for Pulse Density Modulation (PDM) microphones, isolated Sigmadelta ADCs, digital sensors, and other PDM or sigma delta bit stream peripherals. A programmable Cascaded Integrator Comb (CIC) filter is used to decimate the incoming bit streams. PDM supports stereo or mono input data and DMA transfer.

3.7 Security Features

A dedicated hardware secure engine containing its own CPU enables the Secure Vault functions. It isolates cryptographic functions and data from the host Cortex-M33 core, and provides several additional security features. The EFR32BG29 family includes devices with Secure Vault High capabilities, which are summarized in the following table.

Table 3.1. Secure Vault Features

| Feature | Secure Vault High |
|---|---|
| True Random Number Generator (TRNG) | Yes |
| Secure Boot with Root of Trust and Secure Loader (RTSL) | Yes |
| Secure Debug with Lock/Unlock | Yes |
| DPA Countermeasures | Yes |
| Anti-Tamper | Yes |
| Secure Attestation | Yes |
| Secure Key Management | Yes |
| Symmetric Encryption | AES 128 / 192 / 256 bit ECB, CTR, CBC, CFB, CCM, GCM, CBC-MAC, and GMAC ChaCha20 |
| Public Key Encryption - ECDSA / ECDH / EdDSA | p192, p256, p384 and p521Curve25519 (ECDH)Ed25519 (EdDSA) |
| Key Derivation | ECJ-PAKE p192, p256, p384, and p521PBKDF2HKDF |
| Hashes | SHA-1 SHA-2 256, 384, and 512 Poly1305 |

Additionally, the EFR32BG29 includes an External Tamper Detection (ETAMPDET) peripheral which provides additional physical security for the end product.

3.7.1 Secure Boot with Root of Trust and Secure Loader (RTSL)

The Secure Boot with RTSL authenticates a chain of trusted firmware that begins from an immutable memory (ROM).

It prevents malware injection, prevents rollback, ensures that only authentic firmware is executed, and protects Over The Air updates.

For more information about this feature, see AN1218: Series 2 Secure Boot with RTSL.

3.7.2 Cryptographic Accelerator

The Cryptographic Accelerator is an autonomous hardware accelerator with Differential Power Analysis (DPA) countermeasures to protect keys.

It supports AES encryption and decryption with 128/192/256-bit keys, ChaCha20 encryption, and Elliptic Curve Cryptography (ECC) to support public key operations and hashes.

Supported block cipher modes of operation for AES include:

- · Electronic Code Book (ECB)
- Counter Mode (CTR)
- · Cipher Block Chaining (CBC)
- · Cipher Feedback (CFB)
- · Galois Counter Mode (GCM)
- · Counter with CBC-MAC (CCM)
- · Cipher Block Chaining Message Authentication Code (CBC-MAC)
- Galois Message Authentication Code (GMAC)

The Cryptographic Accelerator accelerates Elliptical Curve Cryptography and supports the National Institute of Standards and Technology (NIST) recommended curves including P-192, P-256, P-384, and P-521 for Elliptic Curve Diffie-Hellman (ECDH) key derivation, and Elliptic Curve Digital Signature Algorithm (ECDSA) sign and verify operations. Also supported is the non-NIST Curve25519 for ECDH and Ed25519 for Edwards-curve Digital Signature Algorithm (EdDSA) sign and verify operations.

Secure Vault also supports Elliptic Curve variant of Password Authenticated Key Exchange by Juggling (ECJ-PAKE) and Password-Based Key Derivation Function 2 (PBKDF2).

Supported hashes include SHA-1, SHA-2/256/384/512 and Poly1305.

This implementation provides a fast and energy efficient solution to state of the art cryptographic needs.

3.7.3 True Random Number Generator (TRNG)

The TRNG module is a non-deterministic random number generator that harvests entropy from a thermal energy source. It includes start-up health tests for the entropy source as required by NIST SP800-90B and AIS-31, as well as online health tests required for NIST SP800-90C.

The TRNG is suitable for periodically generating entropy to seed an approved pseudo random number generator.

3.7.4 Secure Debug with Lock/Unlock

For obvious security reasons, it is critical for a product to have its debug interface locked before being released in the field.

Secure Vault also provides a secure debug unlock function that allows authenticated access based on public key cryptography. This functionality is particularly useful for supporting failure analysis while maintaining confidentiality of IP and sensitive end-user data.

For more information about this feature, see AN1190: Series 2 Secure Debug.

3.7.5 Differential Power Analysis (DPA) Countermeasures

The AES and ECC accelerators have DPA countermeasures support. This makes it very expensive from a time and effort standpoint to use DPA to recover secret keys.

3.7.6 Secure Key Management with Physically Unclonable Function (PUF)

Key material in Secure Vault High products is protected by "key wrapping" with a standardized symmetric encryption mechanism. This method has the advantage of protecting a virtually unlimited number of keys, limited only by the storage that is accessible by the Cortex-M33, which includes off-chip storage as well. The symmetric key used for this wrapping and unwrapping must be highly secure because it can expose all other key materials in the system. The Secure Vault Key Management system uses a PUF to generate a persistent device-unique seed key on power up to dynamically generate this critical wrapping/unwrapping key which is only visible to the AES encryption engine and is not retained when the device loses power.

3.7.7 Anti-Tamper

Secure Vault High devices provide internal tamper protection which monitors parameters such as voltage, temperature, and electromagnetic pulses as well as detecting tamper of the security sub-system itself. Additionally, 8 external configurable tamper pins support external tamper sources, such as enclosure tamper switches.

For each tamper event, the user is able to select the severity of the tamper response ranging from an interrupt, to a reset, to destroying the PUF reconstruction data which will make all protected key materials un-recoverable and effectively render the device inoperable. The tamper system also has an internal resettable event counter with programmable trigger threshold and refresh periods to mitigate false positive tamper events.

For more information about this feature, see AN1247: Anti-Tamper Protection Configuration and Use.

3.7.8 Secure Attestation

Secure Vault High products support Secure Attestation, which begins with a secure identity that is created during the Silicon Labs manufacturing process. During device production, each device generates its own public/private keypair and securely stores the wrapped private key into immutable OTP memory and this key never leaves the device. The corresponding public key is extracted from the device and inserted into a binary DER-encoded X.509 device certificate, which is signed into a Silicon Labs CA chain and then programmed back into the chip into an immutable OTP memory.

The secure identity can be used to authenticate the chip at any time in the life of the product. The production certification chain can be requested remotely from the product. This certification chain can be used to verify that the device was authentically produced by Silicon Labs. The device unique public key is also bound to the device certificate in the certification chain. A challenge can be sent to the chip at any point in time to be signed by the device private key. The public key in the device certificate can then be used to verify the challenge response, proving that the device has access to the securely-stored private key, which prevents counterfeit products or impersonation attacks.

For more information about this feature, see AN1268: Authenticating Silicon Labs Devices Using Device Certificates.

3.7.9 External Tamper Detection (ETAMPDET)

The ETAMPDET module enables detection of external tampering, such as unauthorized enclosure opening. ETAMPDET operates in all energy modes down to EM4. Up to two signals can be generated and monitored to identify external tamper events. When a tamper event occurs, an interrupt is generated to allow software to take system-appropriate actions.

3.8 Analog

3.8.1 Analog to Digital Converter (IADC)

The IADC is a hybrid architecture combining techniques from both SAR and Delta-Sigma style converters. It has a resolution of 12 bits at 1 Msps and 16 bits at up to 76.9 ksps. Hardware oversampling reduces system-level noise over multiple front-end samples. The IADC includes integrated voltage reference options. Inputs are selectable from a wide range of sources, including pins configurable as either single-ended or differential.

3.8.2 Analog Comparator (ACMP)

The ACMP is used to compare the voltage of two analog inputs, with a digital output indicating which input voltage is higher. Inputs are selected from among internal references and external pins. The tradeoff between response time and current consumption is configurable by software. Two 6-bit reference dividers allow for a wide range of internally-programmable reference sources. The ACMP can also be used to monitor the supply voltage. An interrupt can be generated when the supply falls below or rises above the programmable threshold.

3.9 Power

The EFR32BG29 has an Energy Management Unit (EMU) and efficient integrated regulators to generate internal supply voltages. Only a single external supply voltage is required, from which all internal voltages are created. Devices are available with an integrated DC-DC buck or DC-DC boost regulator. The DC-DC buck regulator is capable of bucking higher voltages down to 1.8 V, while the DC-DC boost option boosts lower battery voltages up to a higher voltage. The DC-DC boost converter has adjustable output, from 1.8 to 2.4 V in 100 mV steps. If used in an application, the DC-DC regulator requires one external inductor and one external capacitor.

The EFR32BG29 device family includes support for internal supply voltage scaling, as well as different power domain groups for peripherals. These enhancements allow for further supply current reductions and lower overall power consumption.

3.9.1 Energy Management Unit (EMU)

The EMU manages transitions of energy modes in the device. Each energy mode defines which peripherals and features are available and the amount of current the device consumes. The EMU can also be used to implement system-wide voltage scaling and turn off the power to unused RAM blocks to optimize the energy consumption in the target application. The DC-DC regulator operation is tightly integrated with the EMU.

3.9.2 Voltage Scaling

The EFR32BG29 supports supply voltage scaling for the LDO powering DECOUPLE, with independent selections for EM0 / EM1 and EM2 / EM3. Voltage scaling helps to optimize the energy efficiency of the system by operating at lower voltages when possible. The EM0 / EM1 voltage scaling level defaults to VSCALE2, which allows the core to operate in active mode at full speed. The intermediate level, VSCALE1, allows operation in EM0 and EM1 at up to 40 MHz. The lowest level, VSCALE0, can be used to conserve power further in EM2 and EM3. The EMU will automatically switch the target voltage scaling level when transitioning between energy modes.

3.9.3 Buck or Boost DC-DC Converter

Each device in the family includes either a buck DC-DC or boost DC-DC converter. The DC-DC converter covers a wide range of load currents, providing high efficiency in energy modes EM0, EM1, EM2 and EM3 for device and radio operation.

RF noise mitigation allows operation of the DC-DC converter without significantly degrading sensitivity of radio components. It employs soft switching at boot and DC-DC regulating-to-bypass transitions to limit the max supply slew rate and mitigate inrush current.

The buck DC-DC configuration provides up to 60 mA output current at 1.8 V from a 2.2 - 3.8 V supply in energy modes EM0,EM1, EM2, and EM3. An on-chip supply-monitor signals when the supply voltage is low to allow bypass of the regulator, and extend the operating range down to 1.8 V. In bypass mode, the DC-DC operation is shut down and the input supply is switched directly to the output. The bypass mode of the buck DC-DC may be enabled to allow the system to go into EM4 and save energy. An integrated Coulomb Counter may be used to monitor the energy flowing through the buck DC-DC.

The boost DC-DC configuration has an input range of 1.2 to 1.7 V, an adjustable output range of 1.8 to 2.4 V, and up to 25 mA output current, enabling operation directly from single-cell low-voltage batteries. The boost DC-DC converter is operational in energy modes EM0, EM1, EM2, and EM3. It can be completely shut down using the dedicated BOOST_EN pin, saving system power during storage and shipping. BOOST_EN may also be used to re-enable the boost converter and power up the system.

3.9.4 Power Domains

Peripherals may exist on one of several independent power domains which are powered down to minimize supply current when not in use. Power domains are managed automatically by the EMU.

The lowest-energy power domain is the "high-voltage" power domain (PDHV), which supports extremely low-energy infrastructure and peripherals. Circuits powered from PDHV are always on and available in all energy modes down to EM4.

The next power domain is the low-power domain (PD0), which is further divided to power subsets of peripherals. All PD0 power domains are shut down in EM4. Circuits powered from PD0 power domains may be available in EM0, EM1, EM2, and EM3.

Low-power domain A (PD0A) is the base power domain for EM2 and EM3 and will always remain on in EM0-EM3. It powers the most commonly used EM2 and EM3-capable peripherals and infrastructure required to operate in EM2 and EM3. Auxiliary PD0 power domains (PD0B, PD0C) power additional EM2 and EM3-capable peripherals on demand. If any peripherals on one of the auxiliary power domains is enabled, that power domain will be active in EM2 and EM3. Otherwise, the auxiliary PD0 power domains will be shut down to reduce current.

The active power domain (PD1) powers the rest of the device circuitry, including the CPU core and EM0 / EM1 peripherals. PD1 is always powered on in EM0 and EM1. PD1 is always shut down in EM2, EM3, and EM4.

Table 3.2 Peripheral Power Subdomains on page 17 shows the peripherals on the PDHV and PD0x domains. Any peripheral not listed is on PD1.

Table 3.2. Peripheral Power Subdomains

| PD0A | | |
|-------|----------|--|
| | PD0B | PD0C |
| RTCC | LETIMER0 | LFRCO (Precision Mode) |
| FSRCO | IADC0 | |
| WDOG0 | ACMP0 | |
| | I2C0 | |
| | EUSART0 | |
| | PRS | |
| | DEBUG | |
| | GPIO | |
| | FSRCO | FSRCO IADCO WDOGO ACMPO I2CO EUSARTO PRS DEBUG |

Note:

3.10 Reset Management Unit (RMU)

The RMU is responsible for handling reset of the EFR32BG29. A wide range of reset sources are available, including several power supply monitors, pin reset, software controlled reset, core lockup reset, and watchdog reset.

^{1.} Peripherals on PDHV are also available in EM4.

3.11 Core and Memory

3.11.1 Processor Core

The ARM Cortex-M processor includes a 32-bit RISC processor integrating the following features and tasks in the system:

- ARM Cortex-M33 RISC processor achieving 1.50 Dhrystone MIPS/MHz
- ARM TrustZone security technology
- · Embedded Trace Macrocell (ETM) for real-time trace and debug
- Up to 1024 KB flash program memory
- · Up to 256 KB RAM data memory
- · Configuration and event handling of all modules
- · 2-pin Serial-Wire debug interface

3.11.2 Memory System Controller (MSC)

The MSC is the program memory unit of the microcontroller. The flash memory is readable and writable from both the Cortex-M33 and LDMA. In addition to the main flash array where program code is normally written, the MSC provides an information block where additional information, such as special user information or flash-lock bits, is stored. There is also a read-only page in the information block containing system and device calibration data. Read and write operations are supported in energy modes EM0 Active and EM1 Sleep.

3.11.3 Linked Direct Memory Access Controller (LDMA)

The LDMA controller allows the system to perform memory operations independently of software. This reduces both energy consumption and software workload. The LDMA allows operations to be linked together and staged, enabling sophisticated operations to be implemented.

3.12 Memory Map

The EFR32BG29 memory map is shown in the following figure. RAM and flash sizes are for the largest memory configuration.

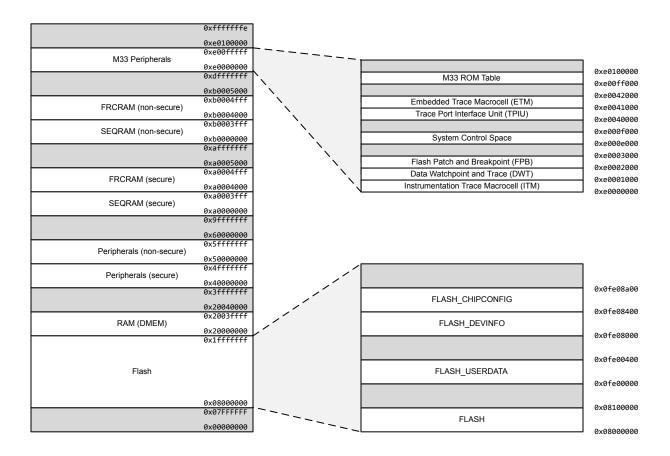


Figure 3.1. EFR32BG29 Memory Map — Core Peripherals and Code Space

3.13 Configuration Summary

The features of the EFR32BG29 are a subset of the feature set described in the device reference manual. The following table describes device specific implementation of the features. Remaining modules support full configuration.

Table 3.3. Configuration Summary

| Lowest Energy Mode | Configuration |
|---|---|
| EM3 ¹ | |
| EM1 | |
| EM3 | |
| EM2 ¹ | |
| EM1 | 2-channel |
| EM1 | 32-bit, 3-channels, +DTI |
| EM1 | 32-bit, 3-channels, +DTI |
| EM1 | 16-bit, 3-channels, +DTI |
| EM1 | 16-bit, 3-channels, +DTI |
| EM1 | 16-bit, 3-channels, +DTI |
| EM1 - Full high-speed operation, all modes | |
| EM2 ¹ - Low-energy UART operation, 9600 Baud | |
| EM2 or EM3 ¹ - Low-energy SPI secondary receiver | |
| EM1 - Full high-speed operation, all modes | |
| EM1 | +IrDA, +I2S, +SmartCard |
| EM1 | +IrDA, +I2S, +SmartCard |
| | EM3 EM1 EM3 EM21 EM1 EM1 EM1 EM1 EM1 EM1 EM |

^{1.} EM2 and EM3 operation is only supported for digital peripheral I/O on Port A and Port B. All GPIO ports support digital peripheral operation in EM0 and EM1.

4. Electrical Specifications

4.1 Electrical Characteristics

All electrical parameters in all tables are specified under the following conditions, unless stated otherwise:

- Typical values are based on T_A=25 °C and all supplies at 3.0 V, by production test and/or technology characterization.
- Radio performance numbers are measured in conducted mode, based on Silicon Laboratories reference designs using output power-specific external RF impedance-matching networks for interfacing to a 50 Ω antenna.
- Minimum and maximum values represent the worst conditions across supply voltage, process variation, and operating temperature, unless stated otherwise.

Power Supply Pin Dependencies

Due to on-chip circuitry, some EFR32 power supply pins have a dependent relationship with one or more other power supply pins. These internal relationships between the external voltages applied to the various EFR32 supply pins are defined in the following list. Exceeding these constraints can result in damage to the device and/or increased current draw.

Buck DC-DC or DC-DC not used

- VREGVDD and DVDD
 - In systems using the DCDC converter, DVDD (the buck converter output) should not be driven externally and VREGVDD (the buck converter input) must be greater than DVDD (VREGVDD ≥ DVDD).
 - In systems not using the DCDC converter, DVDD must be shorted to VREGVDD on the PCB (VREGVDD = DVDD).
- DVDD ≥ DECOUPLE
- PAVDD ≥ RFVDD
- · AVDD, IOVDD: No dependency with each other or any other supply pin.

Boost DC-DC

- VBAT: DCDC converter input. Connect to recommended supply and L_{DCDC}.
- VLDO: Digital LDO power input. Connect to VBAT (VLDO is on WLCSP package only).
- DVDD: DVDD is the boost converter output and should be bypassed with the recommended C_{DCDC}, it should not be driven by an
 off-chip regulator.
- VREGVDD: Tie directly to DVDD (VREGVDD is on WLCSP package only).
- DVDD ≥ DECOUPLE
- PAVDD ≥ RFVDD
- AVDD, IOVDD: No dependency with each other or any other supply pin.

4.2 Absolute Maximum Ratings

Stresses above those listed in the following table may cause permanent damage to the device. This is a stress rating only and functional operation of the devices at those or any other conditions above those indicated in the operation listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

Table 4.1. Absolute Maximum Ratings

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|------------------------|----------------|------|-----|--------------------------|--------|
| Storage temperature range | T _{STG} | | -50 | _ | +150 | °C |
| Voltage on DVDD, AVDD, IOVDD, RFVDD, PAVDD or VREGVDD supply pins | V _{DDMAX} | | -0.3 | _ | 3.8 | V |
| Voltage on VBAT supply pin | V _{VBATMAX} | | -0.3 | _ | 3.8 | V |
| Junction temperature | T _{JMAX} | -C grade | _ | _ | 55 | °C |
| | | -I grade | _ | _ | 125 | °C |
| Voltage ramp rate on any supply pin | V _{DDRAMPMAX} | | _ | _ | 1.0 | V / µs |
| Voltage on HFXO pins | V _{HFXOPIN} | | -0.3 | _ | 1.2 | V |
| DC voltage on any GPIO pin | V _{DIGPIN} | | -0.3 | _ | V _{IOVDD} + 0.3 | V |
| DC voltage on RESETn pin ¹ | V _{RESETn} | | -0.3 | _ | 3.8 | V |
| Input RF level on RF pins RF2G4_IO | P _{RFMAX2G4} | | _ | _ | +10 | dBm |
| Absolute voltage on RF pin RF2G4_IO | V _{MAX2G4} | | -0.3 | _ | V _{PAVDD} + 0.3 | V |
| Total current into VDD power lines | I _{VDDMAX} | Source | _ | _ | 200 | mA |
| Total current into VSS ground lines | I _{VSSMAX} | Sink | _ | _ | 200 | mA |
| Current per I/O pin | I _{IOMAX} | Sink | _ | _ | 50 | mA |
| | | Source | _ | _ | 50 | mA |
| Current for all I/O pins | I _{IOALLMAX} | Sink | _ | _ | 200 | mA |
| | | Source | _ | _ | 200 | mA |

^{1.} The RESETn pin has a pull-up device to the DVDD supply. For minimum leakage, RESETn should not exceed the voltage at DVDD.

4.3 General Operating Conditions

Table 4.2. General Operating Conditions

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------------|---|-------|------|----------------------------|------|
| Operating ambient tempera- | T _A | -C temperature grade ¹ | -20 | _ | +55 | °C |
| ture range | | -I temperature grade ¹ | -40 | _ | +125 | °C |
| VREGVDD operating supply voltage (Buck DCDC or | V _{VREGVDD} | Buck Mode DCDC in regulation, 60 mA load | 2.2 | 3.0 | 3.8 | V |
| DCDC not used) | | Buck Mode DCDC in bypass, 60 mA load | 1.8 | 3.0 | 3.8 | V |
| | | DCDC not in use. DVDD externally shorted to VREGVDD | 1.71 | 3.0 | 3.8 | V |
| VBAT operating supply voltage (Boost DCDC) | V_{VBAT} | Boost Mode DCDC in regulation ² | 1.2 | 1.5 | V _{OUT_BST} - 0.1 | V |
| DVDD supply voltage | V _{DVDD} | EM0/1 | 1.71 | 3.0 | 3.8 | V |
| | | EM2/3/4 ³ | 1.71 | 3.0 | 3.8 | V |
| AVDD supply voltage | V _{AVDD} | | 1.71 | 3.0 | 3.8 | V |
| IOVDD0 operating supply | V _{IOVDD0} | IOVDD0BODEN = 0 4 | 1.175 | 3.0 | 3.8 | V |
| voltage | | IOVDD0BODEN = 1 ⁴ | 1.71 | 3.0 | 3.8 | V |
| RFVDD operating supply voltage | V _{RFVDD} | | 1.71 | 3.0 | V _{PAVDD} | V |
| PAVDD operating supply voltage | V _{PAVDD} | | 1.71 | 3.0 | 3.8 | V |
| DECOUPLE output capacitor ⁵ | C _{DECOUPLE} | 1.0 µF ± 10% X8L capacitor used for performance characterization. | 1.0 | _ | 2.75 | μF |
| HCLK and core frequency | f _{HCLK} | VSCALE2, MODE = WS1 | _ | _ | 80 | MHz |
| | | VSCALE2, MODE = WS0 | _ | _ | 40 | MHz |
| | | VSCALE1, MODE = WS0 | _ | _ | 40 | MHz |
| PCLK frequency | f _{PCLK} | VSCALE2 or VSCALE1 | _ | _ | 40 | MHz |
| EM01 Group A clock fre- | f _{EM01GRPACLK} | VSCALE2 | _ | _ | 80 | MHz |
| quency | | VSCALE1 | _ | _ | 40 | MHz |
| EM01 Group B clock fre- | f _{EM01} GRPBCLK | VSCALE2 | _ | _ | 80 | MHz |
| quency | | VSCALE1 | _ | _ | 40 | MHz |
| EM01 Group C clock fre- | f _{EM01GRPCCLK} | VSCALE2 | _ | | 80 | MHz |
| quency | | VSCALE1 | _ | _ | 40 | MHz |
| HCLK radio frequency ⁶ | f _{HCLKRADIO} | VSCALE2 or VSCALE1 | _ | 38.4 | | MHz |
| External clock input | f _{CLKIN} | VSCALE2 or VSCALE1 | _ | _ | 40 | MHz |
| DPLL reference clock | f _{DPLLREFCLK} | VSCALE2 or VSCALE1 | _ | _ | 40 | MHz |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------|--------|----------------|-----|-----|-----|------|
| | | | | | | 4 |

- 1. The device may operate continuously at the maximum allowable ambient T_A rating as long as the absolute maximum T_{JMAX} is not exceeded. For an application with significant power dissipation, the allowable T_A may be lower than the maximum T_A rating. $T_A = T_{JMAX}$ (THETA $_{JA}$ x PowerDissipation). Refer to the Absolute Maximum Ratings table and the Thermal Characteristics table for T_{JMAX} and THETA $_{JA}$.
- 2. The VBAT supply may be as high as the Boost DCDC output, but DCDC and RF performance specifications will degrade.
- 3. The DVDD supply is monitored by the DVDD BOD in EM0/1 and the LE DVDD BOD in EM2/3/4.
- 4. The IOVDD BOD enable bit is in the EMU_BOD3SENSE register. The BOD is disabled on reset.
- 5. Murata GCM21BL81C105KA58L used for performance characterization. Actual capacitor values can be significantly de-rated from their specified nominal value by the rated tolerance, as well as the application's AC voltage, DC bias, and temperature. The minimum capacitance counting all error sources should be no less than 0.6 μF.
- 6. The recommended radio crystal frequency is 38.4 MHz and all radio performance is specified at this frequency. See HFXO specifications for more detail on crystal tolerance.

4.4 Buck-Mode DC-DC Converter

Test conditions: L_{DCDC} = 2.2 μ H, C_{DCDC} = 4.7 μ F, $V_{VREGVDD}$ = 3.0 V, V_{OUT} = 1.8 V, IPKVAL in EM0/1 modes is set to 150 mA, and in EM2/3 modes is set to 90 mA, unless otherwise indicated.

Table 4.3. Buck-Mode DC-DC Converter

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|----------------------|--|-------------------|------|-----|-------|
| Input voltage range at VREGVDD pin | V _{VREGVDD} | DCDC in regulation, I _{LOAD} = 60 mA, EM0/EM1 mode | 2.2 | 3.0 | 3.8 | V |
| | | DCDC in regulation, I _{LOAD} = 5 mA, EM0/EM1 or EM2/EM3 mode | 1.8 | 3.0 | 3.8 | V |
| | | Bypass mode | 1.8 | 3.0 | 3.8 | V |
| Regulated output voltage | V _{OUT} | | | 1.8 | _ | V |
| Regulation DC accuracy | ACC _{DC} | V _{VREGVDD} ≥ 2.2 V, Steady state in EM0/EM1 mode or EM2/EM3 mode | -2.5 | _ | 3.3 | % |
| Regulation total accuracy | ACC _{TOT} | With mode transitions between EM0/EM1 and EM2/EM3 modes | -5 | _ | 7 | % |
| Steady-state output ripple | V _R | I _{LOAD} = 20 mA in EM0/EM1 mode | _ | 14.3 | _ | mVpp |
| DC line regulation | V _{REG} | I _{LOAD} = 60 mA in EM0/EM1 mode, V _{VREGVDD} ≥ 2.2 V | _ | 5.5 | _ | mV/V |
| DC load regulation | I _{REG} | Load current between 100 µA and 60 mA in EM0/EM1 mode | _ | 0.27 | _ | mV/mA |
| Efficiency | EFF | Load current between 100 µA and 60 mA in EM0/EM1 mode, or between 10 µA and 5 mA in EM2/EM3 mode | | 91 | _ | % |
| Output load current ¹ | I _{LOAD} | EM0/EM1 mode, DCDC in regulation | _ | _ | 60 | mA |
| | | EM2/EM3 mode, DCDC in regulation | _ | _ | 5 | mA |
| | | Bypass mode | _ | _ | 60 | mA |
| Nominal output capacitor | C _{DCDC} | 4.7 μF ± 10% X7R capacitor used for performance characterization ² | 4.7 | _ | 10 | μF |
| Nominal inductor | L _{DCDC} | ± 20% tolerance | _ | 2.2 | _ | μH |
| Nominal input capacitor | C _{IN} | | C _{DCDC} | _ | _ | μF |
| Resistance in bypass mode | R _{BYP} | Bypass switch from VREGVDD to DVDD, V _{VREGVDD} = 1.8 V | _ | 1.75 | 3 | Ω |
| | | Powertrain PFET switch from VREGVDD to VREGSW, VVREGVDD = 1.8 V | _ | 0.86 | 1.5 | Ω |
| Supply monitor threshold programming range | V _{CMP_RNG} | Programmable in 0.1 V steps | 2.0 | _ | 2.3 | V |
| Supply monitor threshold accuracy | V _{CMP_ACC} | Supply falling edge trip point | -5 | _ | 5 | % |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-------------------------------------|------------------------|---|-----|-----|-----|------|
| Supply monitor threshold hysteresis | V _{CMP_HYST} | Positive hysteresis on the supply rising edge referred to the falling edge trip point | _ | 4 | _ | % |
| Supply monitor response time | t _{CMP_DELAY} | Supply falling edge at -100 mV / µs | _ | 0.6 | _ | μs |

- 1. I_{LOAD} is the total current sourced by the DCDC, including on-chip and off-chip circuits powered from the DVDD supply rail.
- 2. Actual capacitor values can be significantly de-rated from their specified nominal value by the rated tolerance, as well as the application's AC voltage, DC bias, and temperature. The minimum capacitance counting all error sources should be no less than 2.4 μ F.

4.4.1 Buck DC-DC Operating Limits

The maximum supported voltage on the VREGVDD supply pin is limited under certain conditions. Maximum input voltage is a function of temperature and the average load current over a 10-year lifetime. Figure 4.1 Lifetime Average Load Current limit vs. Maximum Input Voltage on page 27 shows the safe operating region under specific conditions. Exceeding this safe operating range may impact the reliability and performance of the DC-DC converter.

The average load current for an application can typically be determined by examining the current profile during the time the device is powered. For example, a continuously powered application that sleeps 99% of the time, consumes 2 uA while asleep and 10 mA during the 1% it is active, with an average lifetime load current of about 102 uA.

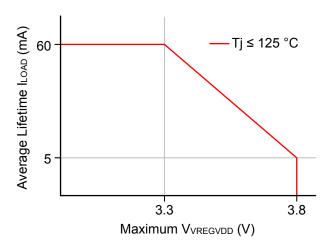


Figure 4.1. Lifetime Average Load Current limit vs. Maximum Input Voltage

The minimum input voltage for the DC-DC in EM0/EM1 mode is a function of the maximum load current, and the peak current setting. Figure 4.2 Transient Maximum Load Current vs. Minimum Input Voltage on page 27 shows the max load current vs. input voltage for different DC-DC peak inductor current settings.

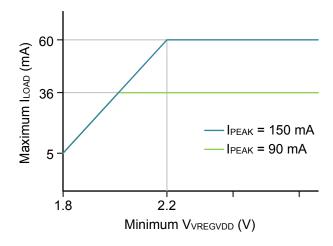


Figure 4.2. Transient Maximum Load Current vs. Minimum Input Voltage

4.5 Boost-Mode DC-DC Converter

Test conditions: L_{DCDC} = 2.2 μ H, C_{DCDC} = 10 μ F, V_{VBAT} = 1.5 V, V_{OUT} = 1.8 V, IPKVAL in EM0/1 modes is set to 180 mA, and in EM2/3 modes is set to 150 mA, unless otherwise indicated.

Table 4.4. Boost-Mode DC-DC Converter

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|---------------------------|---|-------------------------|-------|------------------------|-------|
| Input voltage range at VBAT pin | V_{VBAT} | C _{LOAD} = 10 μF | 1.2 | _ | 1.7 | V |
| Nominal regulated output voltage | V _{OUT_BST} | Adjustable in 100 mV increments | 1.8 | _ | 2.4 | V |
| Regulation DC accuracy | ACC _{DC} | 1.2 V ≤ V _{VBAT} ≤ 1.7 V, Steady state in EM0/EM1 mode or EM2/EM3 mode | -2 | _ | 2.5 | % |
| Regulation total accuracy | ACC _{TOT} | With mode transitions between EM0/EM1 and EM2/EM3 modes | -5 | _ | 7 | % |
| Steady-state output ripple | V _R | I _{LOAD} = 20 mA in EM0/EM1 mode | _ | 15 | _ | mVpp |
| DC line regulation | V_{REG} | I _{LOAD} = 25 mA in EM0/EM1 mode, 1.2 V ≤ V _{VBAT} ≤ 1.6 V | _ | 15 | _ | mV/V |
| DC load regulation | I _{REG} | Load current between 100 µA and MAX(I _{LOAD}) in EM0/EM1 mode | _ | -0.25 | _ | mV/mA |
| Efficiency | EFF | Load current between 100 µA and MAX(I _{LOAD}) mA in EM0/EM1 mode, or between 10 µA and 5 mA in EM2/EM3 mode | _ | 91 | _ | % |
| Output load current ¹ | I _{LOAD} | EM0/EM1 mode, DCDC in regulation, V _{OUT} = 1.8 V, V _{VBAT} = 1.2 V | _ | _ | 25 | mA |
| | | EM2/EM3 mode, DCDC in regulation, V _{OUT} = 1.8 V, V _{VBAT} = 1.2 V | _ | _ | 5 | mA |
| External load during startup ² | I _{LOAD_START} | Off-chip load applied at DVDD supply rail | _ | _ | 0.5 | mA |
| Peak current during startup | I _{PEAK_START} | C _{LOAD} = 10 μF | _ | _ | 10 | mA |
| Nominal output capacitor | C _{DCDC} | 10 µF ± 10% X8L capacitor used for performance characterization ³ | 7.5 | 10 | _ | μF |
| Nominal inductor | L _{DCDC} | ± 20% tolerance | _ | 2.2 | | μH |
| Nominal input capacitor | C _{IN} | | 4.7 | _ | _ | μF |
| Time to switch from EM2/3 mode to EM0/1 mode ⁴ | t _{MODE_} SWITCH | | _ | 16 | 32 | μs |
| Input high voltage on BOOST_EN | V _{IH_BOOST_EN} | | 0.8 * V _{BAT} | _ | _ | V |
| Input low voltage on BOOST_EN | V _{IL_BOOST_EN} | | _ | _ | 0.3 * V _{BAT} | V |
| Hysteresis of input voltage on BOOST_EN | V _{HYST_BOOST_E} | | 0.03 * V _{BAT} | _ | _ | V |
| Time from BOOST_EN high to output regulation at 1.8 V | t _{START} | With 500 μA off-chip I _{LOAD_START} on DVDD | _ | 8 | 20 | ms |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|--------------------|----------------|-----|------|-----|------|
| Peak output voltage during startup (during t _{START}) | V _{START} | | _ | 2.35 | 2.8 | V |

Note:

- 1. I_{LOAD} is the total current sourced by the DCDC, including on-chip and off-chip circuits powered from the DVDD supply rail. Maximum output load current is a function of input and output voltage.
- 2. I_{LOAD START} is the allowable current sourced by the DCDC during startup to off-chip circuits powered from the DVDD supply rail.
- 3. Actual capacitor values can be significantly de-rated from their specified nominal value by the rated tolerance, as well as the application's AC voltage, DC bias, and temperature. The minimum capacitance counting all error sources should be no less than 6.7 μF.
- 4. Mode switch is initiated when a wake event is recognized and occurs in parallel to the normal system wake time. During the mode switch, I_{LOAD} should be limited to 20 mA or less.

4.6 Coulomb Counter Calibration Load (Buck DC-DC Only)

Table 4.5. Coulomb Counter Calibration Load (Buck DC-DC Only)

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|-----------------------|--------------------------------|-----|-----|-----|------|
| Operating temperature range | T _{CCLOAD} | | -20 | _ | 70 | °C |
| Load current accuracy vs. production measurement ¹ | I _{LOAD_ACC} | CCLVL = LOAD2 (1.0 mA nominal) | -9 | _ | 9 | % |
| | | CCLVL = LOAD7 (8.0 mA nominal) | -10 | _ | 10 | % |

Note:

Calibration load currents vary from part-to-part. The magnitude of the calibration load currents at 25 °C are measured in production on each device, and the measurement is written into DEVINFO space in the CCLOADxx locations. Accuracy is specified relative to the measured value across T_{CCLOAD}.

4.7 Thermal Characteristics

Table 4.6. Thermal Characteristics

| Package | Board | Parameter | Symbol | Test Condition | Value | Unit |
|------------------|--|--|-------------|----------------|-------|------|
| 40QFN (5x5mm) | JEDEC - High Thermal Cond. | Thermal Resistance, Junction to Ambient | ΘЈΑ | Still Air | 27.1 | °C/W |
| | (2s2p) ¹ | Thermal Resistance, Junction to Board | Ψ_{JB} | | 7.2 | °C/W |
| | | Thermal Resistance, Junction to Top Center | Ψ_{JT} | | 0.27 | °C/W |
| | Thermal Resistance, Junction to Board | ΘЈВ | | 15.5 | °C/W | |
| 45WLCSP | JEDEC - High Thermal Cond. | Thermal Resistance, Junction to Ambient | ΘЈΑ | Still Air | 110.2 | °C/W |
| | (2s2p) ² | Thermal Resistance, Junction to Board | Ψ_{JB} | | 40.7 | °C/W |
| | Thermal Resistance, Junction to Top Center | Ψ_{JT} | | 0.1 | °C/W | |
| | | Thermal Resistance, Junction to Board | ΘЈВ | | 53.1 | °C/W |

- 1. Based on 4 layer PCB with dimension 3" x 4.5", PCB Thickness of 1.6 mm, per JEDEC. PCB Center Land with 9 Via to top internal plane of PCB.
- 2. Based on 4 layer PCB with dimension 3" x 4.5", PCB Thickness of 1.6 mm, per JEDEC. PCB Center Land with 6 Via to top internal GND plane and 5 Via to bottom internal VDD plane of PCB.

4.8 Current Consumption

4.8.1 MCU Current Consumption Using Buck DC-DC at 3.0 V VREGVDD Input

Unless otherwise indicated, typical conditions are: VREGVDD = 3.0 V. AVDD = DVDD = IOVDD = RFVDD = 1.8 V from DCDC. Voltage scaling level = VSCALE1. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = 25 °C.

Table 4.7. MCU Current Consumption Using Buck DC-DC at 3.0 V VREGVDD Input

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|----------------------|--|-----|-----|-----|--------|
| Current consumption in EM0 mode with all peripherals disabled | I _{ACTIVE} | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, CPU running Prime from flash, VSCALE2 | _ | 32 | _ | μA/MHz |
| | | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, CPU running while loop from flash, VSCALE2 | _ | 30 | _ | μA/MHz |
| | | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, CPU running CoreMark loop from flash, VSCALE2 | _ | 40 | _ | μA/MHz |
| | | 38.4 MHz crystal, CPU running Prime from flash | _ | 33 | _ | μΑ/MHz |
| | | 38.4 MHz crystal, CPU running while loop from flash | _ | 31 | _ | µA/MHz |
| | | 38.4 MHz crystal, CPU running CoreMark loop from flash | _ | 41 | _ | µA/MHz |
| | | 38 MHz HFRCO, CPU running while loop from flash | _ | 27 | _ | μΑ/MHz |
| | | 26 MHz HFRCO, CPU running while loop from flash | _ | 30 | _ | μΑ/MHz |
| | | 16 MHz HFRCO, CPU running while loop from flash | _ | 36 | _ | μA/MHz |
| | | 1 MHz HFRCO, CPU running while loop from flash | _ | 283 | _ | µA/MHz |
| Current consumption in EM1 mode with all peripherals disabled | I _{EM1} | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, VSCALE2 | _ | 20 | _ | μA/MHz |
| | | 38.4 MHz crystal | _ | 21 | _ | μΑ/MHz |
| | | 38 MHz HFRCO | _ | 17 | _ | μΑ/MHz |
| | | 26 MHz HFRCO | _ | 20 | _ | μΑ/MHz |
| | | 16 MHz HFRCO | _ | 26 | _ | µA/MHz |
| | | 1 MHz HFRCO | _ | 273 | _ | µA/MHz |
| Current consumption in EM2 mode, VSCALE1 | I _{EM2_VS1} | 256 KB RAM retention and RTC running from LFRCO | _ | 4.6 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFRCO | _ | 1.9 | _ | μА |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|-----------------------|---|-----|-------|-----|------|
| Current consumption in EM2 mode, VSCALE0 | I _{EM2_VS} | 256 KB RAM retention and RTC running from LFXO | _ | 3.4 | _ | μA |
| | | 256 KB RAM retention and RTC running from LFRCO | _ | 3.4 | _ | μA |
| | | 192 KB RAM retention and RTC running from LFXO | _ | 2.9 | _ | μA |
| | | 192 KB RAM retention and RTC running from LFRCO | _ | 2.9 | _ | μA |
| | | 192 KB RAM retention with RTC, BURTC, and WDOG running from LFRCO in precision mode | _ | 3.3 | _ | μА |
| | | 32 KB RAM retention and RTC running from LFXO | _ | 1.7 | _ | μA |
| | | 32 KB RAM retention and RTC running from LFRCO in precision mode | _ | 2.0 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFXO | _ | 1.5 | _ | μA |
| | | 16 KB RAM retention and RTC running from LFRCO | _ | 1.5 | _ | μA |
| | | 16 KB RAM retention and RTC running from LFXO, Radio RAM and CPU cache not retained | _ | 1.3 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFXO, CPU cache not retained | _ | 1.5 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFXO, Radio RAM, CPU cache, and EM0/1 peripheral states not retained | _ | 1.3 | _ | μА |
| Current consumption in EM3 mode, VSCALE0 | I _{EM3_VS} | 16 KB RAM retention and RTC running from ULFRCO | _ | 1.35 | _ | μA |
| Change in current consumption for retained RAM bank in EM2 or EM3 | I _{EM23_RAM} | Per 16 KB RAM bank | _ | 0.124 | _ | μА |
| Additional current in EM2 or EM3 when any peripheral in PD0B is enabled ¹ | I _{PD0B_VS} | | _ | 1.8 | _ | μА |

^{1.} Extra current consumed by power domain. Does not include current associated with the enabled peripherals. See 3.9.4 Power Domains for a list of the peripherals in each power domain.

4.8.2 MCU Current Consumption Using Boost DC-DC at 1.5 V VBAT Input

Unless otherwise indicated, typical conditions are: VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V from DC-DC. Voltage scaling level = VSCALE1. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = 25 °C.

Table 4.8. MCU Current Consumption Using Boost DC-DC at 1.5 V VBAT Input

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|----------------------|--|-----|-----|-----|--------|
| Current consumption in EM0 mode with all peripherals disabled | I _{ACTIVE} | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, CPU running Prime from flash, VSCALE2 | _ | 50 | _ | μA/MHz |
| | | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, CPU running while loop from flash, VSCALE2 | _ | 47 | _ | μA/MHz |
| | | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, CPU running CoreMark loop from flash, VSCALE2 | _ | 62 | _ | µA/MHz |
| | | 38.4 MHz crystal, CPU running Prime from flash | _ | 52 | _ | μA/MHz |
| | | 38.4 MHz crystal, CPU running while loop from flash | _ | 49 | _ | µA/MHz |
| | | 38.4 MHz crystal, CPU running CoreMark loop from flash | _ | 64 | _ | µA/MHz |
| | | 38 MHz HFRCO, CPU running while loop from flash | _ | 41 | _ | µA/MHz |
| | | 26 MHz HFRCO, CPU running while loop from flash | _ | 45 | _ | μA/MHz |
| | | 16 MHz HFRCO, CPU running while loop from flash | _ | 55 | _ | μA/MHz |
| | | 1 MHz HFRCO, CPU running while loop from flash | _ | 429 | _ | μA/MHz |
| Current consumption in EM1 mode with all peripherals disabled | I _{EM1} | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, VSCALE2 | _ | 33 | _ | μA/MHz |
| | | 38.4 MHz crystal | _ | 35 | _ | μΑ/MHz |
| | | 38 MHz HFRCO | _ | 27 | _ | µA/MHz |
| | | 26 MHz HFRCO | _ | 31 | _ | µA/MHz |
| | | 16 MHz HFRCO | _ | 41 | _ | µA/MHz |
| | | 1 MHz HFRCO | _ | 415 | _ | μΑ/MHz |
| Current consumption in EM2 mode, VSCALE1 | I _{EM2_VS1} | 256 KB RAM retention and RTC running from LFRCO | _ | 5.9 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFRCO | _ | 2.8 | _ | μА |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|-----------------------|---|-----|-------|-----|------|
| Current consumption in EM2 mode, VSCALE0 | I _{EM2_VS} | 256 KB RAM retention and RTC running from LFXO | _ | 4.3 | _ | μA |
| | | 256 KB RAM retention and RTC running from LFRCO | _ | 4.4 | _ | μA |
| | | 192 KB RAM retention and RTC running from LFXO | _ | 3.7 | _ | μA |
| | | 192 KB RAM retention and RTC running from LFRCO | _ | 3.8 | _ | μA |
| | | 192 KB RAM retention with RTC, BURTC, and WDOG running from LFRCO in precision mode | _ | 4.6 | _ | μА |
| | | 32 KB RAM retention and RTC running from LFXO | _ | 2.3 | _ | μA |
| | | 32 KB RAM retention and RTC running from LFRCO in precision mode | _ | 3.0 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFXO | _ | 2.2 | _ | μA |
| | | 16 KB RAM retention and RTC running from LFRCO | _ | 2.2 | _ | μA |
| | | 16 KB RAM retention and RTC running from LFXO, Radio RAM and CPU cache not retained | _ | 1.9 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFXO, CPU cache not retained | _ | 2.1 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFXO, Radio RAM, CPU cache, and EM0/1 peripheral states not retained | _ | 1.9 | _ | μА |
| Current consumption in EM3 mode, VSCALE0 | I _{EM3_VS} | 16 KB RAM retention and RTC running from ULFRCO | _ | 1.9 | _ | μA |
| Current with Boost DCDC shut down (BOOST_EN = 0) | I _{SHDN} | IOVDD, AVDD, RFVDD, and PAVDD connected to DVDD (unpowered) | _ | 18 | 30 | nA |
| | | IOVDD powered. AVDD, RFVDD, and PAVDD connected to DVDD (unpowered) | _ | 36 | 50 | nA |
| Current consumption during reset | I _{RST} | Hard pin reset held | _ | 516 | _ | μA |
| Additional current in EM2 or EM3 when any peripheral in PD0B is enabled ¹ | I _{PD0B_VS} | | _ | 2.1 | _ | μА |
| Change in current consumption for retained RAM bank in EM2 or EM3 | I _{EM23_RAM} | Per 16 KB RAM bank | _ | 0.143 | _ | μА |

Note:

1. Extra current consumed by power domain. Does not include current associated with the enabled peripherals. See 3.9.4 Power Domains for a list of the peripherals in each power domain.

4.8.3 MCU Current Consumption at 3.0 V

Unless otherwise indicated, typical conditions are: AVDD = DVDD = IOVDD = RFVDD = PAVDD = VREGVDD = 3.0 V. DC-DC not used. Voltage scaling level = VSCALE1. T_A = $25 \,^{\circ}$ C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = $25 \,^{\circ}$ C.

Table 4.9. MCU Current Consumption at 3.0 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|----------------------|--|-----|-----|------|--------|
| Current consumption in EM0 mode with all peripherals disabled | I _{ACTIVE} | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, CPU running Prime from flash, VSCALE2 | _ | 47 | _ | μA/MHz |
| | | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, CPU running while loop from flash, VSCALE2 | _ | 44 | _ | μA/MHz |
| | | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, CPU running CoreMark loop from flash, VSCALE2 | _ | 59 | _ | μA/MHz |
| | | 38.4 MHz crystal, CPU running Prime from flash | _ | 48 | _ | μΑ/MHz |
| | v | 38.4 MHz crystal, CPU running while loop from flash | _ | 45 | _ | μA/MHz |
| | | 38.4 MHz crystal, CPU running CoreMark loop from flash | _ | 60 | _ | µA/MHz |
| | | 38 MHz HFRCO, CPU running while loop from flash | _ | 39 | 81 | μΑ/MHz |
| | | 26 MHz HFRCO, CPU running while loop from flash | _ | 43 | _ | μΑ/MHz |
| | | 16 MHz HFRCO, CPU running while loop from flash | _ | 53 | _ | μΑ/MHz |
| | | 1 MHz HFRCO, CPU running while loop from flash | _ | 408 | 1960 | μA/MHz |
| Current consumption in EM1 mode with all peripherals disabled | I _{EM1} | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, VSCALE2 | _ | 29 | _ | μA/MHz |
| | | 38.4 MHz crystal | _ | 31 | _ | µA/MHz |
| | | 38 MHz HFRCO | _ | 25 | 67 | µA/MHz |
| | | 26 MHz HFRCO | _ | 29 | _ | µA/MHz |
| | | 16 MHz HFRCO | _ | 38 | _ | µA/MHz |
| | | 1 MHz HFRCO | _ | 393 | 1950 | µA/MHz |
| Current consumption in EM2 mode, VSCALE1 | I _{EM2_VS1} | 256 KB RAM retention and RTC running from LFRCO | _ | 6.6 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFRCO | _ | 2.7 | _ | μА |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|-----------------------|---|-----|-------|-----|------|
| Current consumption in EM2 mode, VSCALE0 | I _{EM2_VS} | 256 KB RAM retention and RTC running from LFXO | _ | 4.8 | _ | μA |
| | | 256 KB RAM retention and RTC running from LFRCO | _ | 4.8 | 16 | μА |
| | | 192 KB RAM retention and RTC running from LFXO | _ | 4.1 | _ | μА |
| | | 192 KB RAM retention and RTC running from LFRCO | _ | 4.1 | _ | μА |
| | | 192 KB RAM retention with RTC, BURTC, and WDOG running from LFRCO in precision mode | _ | 4.7 | _ | μA |
| | | 32 KB RAM retention and RTC running from LFXO | _ | 2.3 | _ | μA |
| | | 32 KB RAM retention and RTC running from LFRCO in precision mode | _ | 2.8 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFXO | _ | 2.1 | _ | μA |
| | | 16 KB RAM retention and RTC running from LFRCO | _ | 2.1 | _ | μA |
| | | 16 KB RAM retention and RTC running from LFXO, Radio RAM and CPU cache not retained | _ | 1.7 | _ | μA |
| | | 16 KB RAM retention and RTC running from LFXO, CPU cache not retained | _ | 2.0 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFXO, Radio RAM, CPU cache, and EM0/1 peripheral states not retained | _ | 1.7 | _ | μА |
| Current consumption in EM3 mode, VSCALE0 | I _{EM3_VS} | 16 KB RAM retention and RTC running from ULFRCO | _ | 1.8 | 6 | μA |
| Change in current consumption for retained RAM bank in EM2 or EM3 | I _{EM23_RAM} | Per 16 KB RAM bank | _ | 0.179 | _ | μА |
| Current consumption in EM4 | I _{EM4} | No BURTC, no LF oscillator | _ | 0.16 | 0.4 | μA |
| mode | | BURTC with LFXO | _ | 0.52 | _ | μA |
| Current consumption during reset | I _{RST} | Hard pin reset held | | 536 | _ | μA |
| Additional current in EM2 or EM3 when any peripheral in PD0B is enabled ¹ | I _{PD0B_VS} | | _ | 2.7 | _ | μА |

^{1.} Extra current consumed by power domain. Does not include current associated with the enabled peripherals. See 3.9.4 Power Domains for a list of the peripherals in each power domain.

4.8.4 MCU Current Consumption at 1.8 V

Unless otherwise indicated, typical conditions are: AVDD = DVDD = IOVDD = RFVDD = PAVDD = VREGVDD = 1.8 V. DC-DC not used. Voltage scaling level = VSCALE1. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = 25 °C.

Table 4.10. MCU Current Consumption at 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|----------------------|--|-----|-----|-----|--------|
| Current consumption in EM0 mode with all peripherals disabled | I _{ACTIVE} | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, CPU running Prime from flash, VSCALE2 | _ | 46 | _ | μA/MHz |
| | | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, CPU running while loop from flash, VSCALE2 | _ | 44 | _ | μA/MHz |
| | | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, CPU running CoreMark loop from flash, VSCALE2 | _ | 59 | _ | µA/MHz |
| | | 38.4 MHz crystal, CPU running Prime from flash | _ | 47 | _ | μA/MHz |
| | | 38.4 MHz crystal, CPU running while loop from flash | _ | 45 | _ | µA/MHz |
| | | 38.4 MHz crystal, CPU running CoreMark loop from flash | _ | 60 | _ | µA/MHz |
| | | 38 MHz HFRCO, CPU running while loop from flash | _ | 39 | _ | µA/MHz |
| | | 26 MHz HFRCO, CPU running while loop from flash | _ | 43 | _ | μΑ/MHz |
| | | 16 MHz HFRCO, CPU running while loop from flash | _ | 52 | _ | μA/MHz |
| | | 1 MHz HFRCO, CPU running while loop from flash | _ | 405 | _ | μΑ/MHz |
| Current consumption in EM1 mode with all peripherals disabled | I _{EM1} | 76.8 MHz HFRCO w/ DPLL referenced to 38.4 MHz crystal, VSCALE2 | _ | 29 | _ | μA/MHz |
| | | 38.4 MHz crystal | _ | 31 | _ | μΑ/MHz |
| | | 38 MHz HFRCO | _ | 24 | _ | µA/MHz |
| | | 26 MHz HFRCO | _ | 29 | _ | µA/MHz |
| | | 16 MHz HFRCO | _ | 38 | _ | µA/MHz |
| | | 1 MHz HFRCO | _ | 391 | _ | μΑ/MHz |
| Current consumption in EM2 mode, VSCALE1 | I _{EM2_VS1} | 256 KB RAM retention and RTC running from LFRCO | _ | 6.5 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFRCO | _ | 2.7 | _ | μА |

| | | | Min | Тур | Max | Unit |
|--|-----------------------|---|-----|--------|-----|------|
| Current consumption in EM2 mode, VSCALE0 | I _{EM2_VS} | 256 KB RAM retention and RTC running from LFXO | _ | 4.7 | _ | μА |
| | | 256 KB RAM retention and RTC running from LFRCO | _ | 4.7 | _ | μА |
| | | 192 KB RAM retention and RTC running from LFXO | _ | 4.0 | _ | μА |
| | | 192 KB RAM retention and RTC running from LFRCO | _ | 4.0 | _ | μА |
| | | 192 KB RAM retention with RTC, BURTC, and WDOG running from LFRCO in precision mode | _ | 4.7 | _ | μА |
| | | 32 KB RAM retention and RTC running from LFXO | _ | 2.2 | _ | μА |
| | | 32 KB RAM retention and RTC running from LFRCO in precision mode | _ | 2.8 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFXO | _ | 2.1 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFRCO | _ | 2.0 | _ | μА |
| | | 16 KB RAM retention and RTC running from LFXO, Radio RAM and CPU cache not retained | _ | 1.7 | _ | μΑ |
| | | 16 KB RAM retention and RTC running from LFXO, CPU cache not retained | _ | 2.0 | _ | μΑ |
| | | 16 KB RAM retention and RTC running from LFXO, Radio RAM, CPU cache, and EM0/1 peripheral states not retained | _ | 1.7 | _ | μА |
| Current consumption in EM3 mode, VSCALE0 | I _{EM3_VS} | 16 KB RAM retention and RTC running from ULFRCO | _ | 1.8 | _ | μА |
| Change in current consumption for retained RAM bank in EM2 or EM3 | I _{EM23_RAM} | Per 16 KB RAM bank | _ | 0.179 | _ | μΑ |
| Current consumption in EM4 | I _{EM4} | No BURTC, no LF oscillator | _ | 0.12 | _ | μA |
| mode | | BURTC with LFXO | _ | 0.44 | _ | μA |
| Current consumption during reset | I _{RST} | Hard pin reset held | _ | 447.31 | _ | μА |
| Additional current in EM2 or EM3 when any peripheral in PD0B is enabled ¹ | I _{PD0B_VS} | | _ | 2.7 | _ | μА |

^{1.} Extra current consumed by power domain. Does not include current associated with the enabled peripherals. See 3.9.4 Power Domains for a list of the peripherals in each power domain.

4.8.5 Radio Current Consumption at 3.0 V Using Buck-Mode DCDC

RF current consumption measured with RHCLK = 38.4 MHz, and all MCU peripherals disabled. Unless otherwise indicated, typical conditions are: VREGVDD = 3.0 V. AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = 25 °C.

Table 4.11. Radio Current Consumption at 3.0 V Using Buck-Mode DCDC

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|------------------------|---|-----|-----|-----|------|
| Current consumption in receive mode, active packet reception | I _{RX_ACTIVE} | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 3.7 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 4 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 4.2 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 3.8 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 4.1 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 4.3 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 3.6 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 3.8 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 4 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 4 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 4.2 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 4.5 | _ | mA |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|------------------------|---|-----|-----|-----|------|
| Current consumption in receive mode, listening for packet | I _{RX_LISTEN} | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 3.8 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 4.1 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 4.3 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 3.8 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 4.1 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 4.3 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 3.6 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 3.9 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 4 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 4 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 4.3 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 4.5 | _ | mA |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------------|-----------------|---|-----|------|-----|------|
| Current consumption in transmit mode | I _{TX} | f = 2.4 GHz, CW, 0 dBm PA, 0 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 4 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 0 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 5.6 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 4 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 7.4 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 6 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 9 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 8 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 11 | _ | mA |
| | | f = 2.4 GHz, CW, 0 dBm PA, 0 dBm output power, VSCALE1, EM1 | _ | 4.3 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 0 dBm output power, VSCALE1, EM1 | _ | 5.9 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 4 dBm output power, VSCALE1, EM1 | _ | 7.6 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 6 dBm output power, VSCALE1, EM1 | _ | 9.4 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 8 dBm output power, VSCALE1, EM1 | _ | 11.3 | _ | mA |
| | | f = 2.4 GHz, CW, 0 dBm PA, 0 dBm output power, VSCALE2, EM1 | _ | 4.4 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 0 dBm output power, VSCALE2, EM1 | _ | 6 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 4 dBm output power, VSCALE2, EM1 | _ | 7.8 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 6 dBm output power, VSCALE2, EM1 | _ | 9.4 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 8 dBm output power, VSCALE2, EM1 | _ | 11.4 | _ | mA |

4.8.6 Radio Current Consumption at 1.5 V Using Boost-Mode DCDC

RF current consumption measured with RHCLK = 38.4 MHz, and all MCU peripherals disabled. Unless otherwise indicated, typical conditions are: VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = 25 °C.

Table 4.12. Radio Current Consumption at 1.5 V Using Boost-Mode DCDC

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|------------------------|---|-----|-----|-----|------|
| Current consumption in receive mode, active packet reception | I _{RX_ACTIVE} | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 7 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 7.5 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 7.8 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 7.1 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 7.6 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 7.9 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 6.8 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 7.2 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 7.5 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 7.4 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 7.9 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 8.2 | _ | mA |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|------------------------|---|-----|-----|-----|------|
| Current consumption in receive mode, listening for packet | I _{RX_LISTEN} | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 7.1 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 7.6 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 7.9 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 7.1 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 7.6 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 7.9 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 6.8 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 7.3 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 7.5 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 7.5 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 7.9 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 8.3 | _ | mA |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------------|-----------------|---|-----|------|-----|------|
| Current consumption in transmit mode | I _{TX} | f = 2.4 GHz, CW, 0 dBm PA, 0 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 7.9 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 0 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 11.1 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 4 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 14.8 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 6 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 17.3 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 8 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 22.2 | _ | mA |
| | | f = 2.4 GHz, CW, 0 dBm PA, 0 dBm output power, VSCALE1, EM1 | _ | 8.4 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 0 dBm output power, VSCALE1, EM1 | _ | 11.5 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 4 dBm output power, VSCALE1, EM1 | _ | 15.2 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 6 dBm output power, VSCALE1, EM1 | _ | 17.8 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 8 dBm output power, VSCALE1, EM1 | _ | 22.7 | _ | mA |
| | | f = 2.4 GHz, CW, 0 dBm PA, 0 dBm output power, VSCALE2, EM1 | _ | 8.6 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 0 dBm output power, VSCALE2, EM1 | _ | 11.7 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 4 dBm output power, VSCALE2, EM1 | _ | 15.4 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 6 dBm output power, VSCALE2, EM1 | _ | 18 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 8 dBm output power, VSCALE2, EM1 | _ | 22.9 | _ | mA |

4.8.7 Radio Current Consumption at 3.0 V

RF current consumption measured with RHCLK = 38.4 MHz, and all MCU peripherals disabled. Unless otherwise indicated, typical conditions are: AVDD = DVDD = IOVDD = RFVDD = PAVDD = 3.0 V. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = 25 °C.

Table 4.13. Radio Current Consumption at 3.0 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|------------------------|---|-----|-----|-----|------|
| Current consumption in receive mode, active packet reception | I _{RX_ACTIVE} | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | | 5.7 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 6.1 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.5 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 5.8 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 6.2 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.6 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 5.4 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 5.9 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.1 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 6.1 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 6.5 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.8 | _ | mA |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|------------------------|---|-----|-----|-----|------|
| Current consumption in receive mode, listening for packet | I _{RX_LISTEN} | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 5.7 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 6.1 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.4 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 5.7 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 6.1 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.4 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 5.5 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 5.9 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.2 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 6.2 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 6.6 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.9 | _ | mA |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------------|-----------------|---|-----|------|-----|------|
| Current consumption in transmit mode | I _{TX} | f = 2.4 GHz, CW, 0 dBm PA, 0 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 6.1 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 0 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 8.6 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 4 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 11.1 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 6 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 13.7 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 8 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 16.9 | _ | mA |
| | | f = 2.4 GHz, CW, 0 dBm PA, 0 dBm output power, VSCALE1, EM1 | _ | 6.5 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 0 dBm output power, VSCALE1, EM1 | _ | 9 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 4 dBm output power, VSCALE1, EM1 | _ | 11.5 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 6 dBm output power, VSCALE1, EM1 | _ | 14.1 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 8 dBm output power, VSCALE1, EM1 | _ | 17.3 | _ | mA |
| | | f = 2.4 GHz, CW, 0 dBm PA, 0 dBm output power, VSCALE2, EM1 | _ | 6.8 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 0 dBm output power, VSCALE2, EM1 | _ | 9.2 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 4 dBm output power, VSCALE2, EM1 | _ | 11.8 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 6 dBm output power, VSCALE2, EM1 | _ | 14.3 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 8 dBm output power, VSCALE2, EM1 | _ | 17.6 | _ | mA |

4.8.8 Radio Current Consumption at 1.8 V

RF current consumption measured with RHCLK = 38.4 MHz, and all MCU peripherals disabled. Unless otherwise indicated, typical conditions are: AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = 25 °C.

Table 4.14. Radio Current Consumption at 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|------------------------|---|-----|-----|-----|------|
| Current consumption in receive mode, active packet reception | I _{RX_ACTIVE} | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 5.7 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 6.1 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.5 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 5.8 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 6.2 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.5 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 5.4 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 5.8 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.1 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 6 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 6.5 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.8 | _ | mA |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|------------------------|---|-----|-----|-----|------|
| Current consumption in receive mode, listening for packet | I _{RX_LISTEN} | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 5.7 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 6.1 | _ | mA |
| | | 125 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.4 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 5.7 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 6.1 | _ | mA |
| | | 500 kbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.4 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 5.4 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 5.9 | _ | mA |
| | | 1 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.1 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1P (Radio clocks only) | _ | 6.1 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE1, EM1 | _ | 6.5 | _ | mA |
| | | 2 Mbit/s, 2GFSK, f = 2.4 GHz, VSCALE2, EM1 | _ | 6.9 | _ | mA |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------------|-----------------|---|-----|------|-----|----------------------------|
| Current consumption in transmit mode | I _{TX} | f = 2.4 GHz, CW, 0 dBm PA, 0 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 6.1 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 0 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 8.5 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 4 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 11.1 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 6 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 13.1 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 8 dBm output power, VSCALE1, EM1P (Radio clocks only) | _ | 16.8 | _ | |
| | | f = 2.4 GHz, CW, 0 dBm PA, 0 dBm output power, VSCALE1, EM1 | _ | 6.5 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 0 dBm output power, VSCALE1, EM1 | _ | 8.9 | _ | mA mA mA mA mA mA |
| | | f = 2.4 GHz, CW, High-power PA, 4 dBm output power, VSCALE1, EM1 | _ | 11.5 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 6 dBm output power, VSCALE1, EM1 | _ | 14.1 | _ | mA mA mA mA mA mA mA mA mA |
| | | f = 2.4 GHz, CW, High-power PA, 8 dBm output power, VSCALE1, EM1 | _ | 17.2 | _ | |
| | | f = 2.4 GHz, CW, 0 dBm PA, 0 dBm output power, VSCALE2, EM1 | _ | 6.7 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 0 dBm output power, VSCALE2, EM1 | _ | 9.1 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 4 dBm output power, VSCALE2, EM1 | _ | 11.7 | _ | mA |
| | | f = 2.4 GHz, CW, High-power PA, 6 dBm output power, VSCALE2, EM1 | _ | 14.3 | _ | mA mA mA |
| | | f = 2.4 GHz, CW, High-power PA, 8 dBm output power, VSCALE2, EM1 | _ | 17.5 | _ | mA |

4.9 Flash Characteristics

Table 4.15. Flash Characteristics

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|----------------------|---------------------------------|--------|-----|-----|--------|
| Flash supply voltage during write or erase | V _{FLASH} | | 1.71 | _ | 3.8 | V |
| Flash erase cycles before failure ¹ | EC _{FLASH} | | 10,000 | _ | _ | cycles |
| Flash data retention ¹ | RET _{FLASH} | | 10 | _ | _ | years |
| Program time | t _{PROG} | one word (32-bits) | 40 | 44 | 48 | uSec |
| | | average per word over 128 words | 10 | 11 | 12 | uSec |
| Page erase time | t _{PERASE} | | 11 | 13 | 15 | ms |
| Mass erase time | t _{MERASE} | Erases all of User Code area | 94 | 101 | 117 | ms |
| Program current | I _{WRITE} | T _A = 25 °C | _ | _ | 2.6 | mA |
| Page erase current | I _{ERASE} | T _A = 25 °C | _ | _ | 1.2 | mA |
| Mass erase current | I _{MERASE} | T _A = 25 °C | _ | _ | 1.2 | mA |

^{1.} Flash data retention information is published in the Quarterly Quality and Reliability Report.

4.10 Energy Mode Wake-up and Entry Times

Unless otherwise specified, these times are measured using the HFRCO at 19 MHz.

Table 4.16. Energy Mode Wake-up and Entry Times

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|----------------------|--|-----|------|-----|-------|
| Wake-up time from EM1 | t _{EM1_WU} | Code execution from flash | _ | 3 | _ | HCLKs |
| | | Code execution from RAM | _ | 1.39 | _ | μs |
| Wake-up time from EM2 | t _{EM2_WU} | Code execution from flash, No Voltage Scaling | _ | 13.3 | _ | μs |
| | | Code execution from RAM, No Voltage Scaling | _ | 5.3 | _ | μs |
| | | Voltage scaling up one level ¹ | _ | 37.9 | _ | μs |
| | | Voltage scaling up two levels ² | _ | 50.3 | _ | μs |
| Wake-up time from EM3 | t _{EM3_WU} | Code execution from flash, No Voltage Scaling | _ | 13.3 | _ | μs |
| | | Code execution from RAM, No Voltage Scaling | _ | 5.3 | _ | μs |
| | | Voltage scaling up one level ¹ | _ | 37.9 | _ | μs |
| | | Voltage scaling up two levels ² | _ | 50.3 | _ | μs |
| Wake-up time from EM4 | t _{EM4_WU} | Code execution from flash | _ | 34 | _ | ms |
| Entry time to EM1 | t _{EM1_ENT} | Code execution from flash | _ | 1.27 | _ | μs |
| Entry time to EM2 | t _{EM2_ENT} | Code execution from flash | _ | 5.8 | _ | μs |
| Entry time to EM3 | t _{EM3_ENT} | Code execution from flash | _ | 5.9 | _ | μs |
| Entry time to EM4 | t _{EM4_ENT} | Code execution from flash | _ | 10.5 | _ | μs |
| Voltage scaling time in EM0 ³ | t _{SCALE} | Up from VSCALE1 to VSCALE2 | _ | 32 | _ | μs |
| | | Down from VSCALE2 to VSCALE1 | _ | 172 | _ | μs |

- 1. Voltage scaling one level is between VSCALE0 and VSCALE1 or between VSCALE1 and VSCALE2.
- 2. Voltage scaling two levels is between VSCALE0 and VSCALE2.
- 3. During voltage scaling in EM0, RAM is inaccessible and processor will be halted until complete.

4.11 Boot Timing

Secure boot impacts the recovery time from all sources of device reset. In addition to the root code authentication process, which cannot be disabled or bypassed, the root code can authenticate a bootloader, and the bootloader can authenticate the application. In projects that include only an application and no bootloader, the root code can authenticate the application directly. The duration of each authentication operation depends on two factors: the computation of the associated image hash (which is proportional to the size of the image) and the verification of the image signature (which is independent of image size).

The duration for the root code to authenticate the bootloader depends on the SE firmware version as well as on the size of the bootloader.

The duration for the bootloader to authenticate the application depends on the size of the application.

The configurations below assume that the associated bootloader and application code images do not contain a bootloader certificate or an application certificate. Authenticating a bootloader certificate or an application certificate will extend the boot time by an additional 6 to 7 ms.

The following table provides the durations from the termination of reset until the completion of the secure boot process (start of main() function in the application image) under various conditions.

Conditions:

- · SE firmware version 2.2.6
- Gecko Bootloader size 13 KB

Timing is expected to be similar for subsequent SE firmware versions. Refer to SE firmware release notes for any significant changes.

| Table | 4.17. | Boot | Timing |
|-------|-------|------|---------------|
|-------|-------|------|---------------|

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|------------------------|-------------------|---|-----|------|-----|------|
| Boot time ¹ | t _{BOOT} | Secure boot application check disabled, no bootloader | _ | 25.2 | _ | ms |
| | | Secure boot application check disabled, second stage bootloader check enabled ² , 50 KB application size | _ | 32.9 | _ | ms |
| | | Secure boot application check enabled, second stage bootloader check enabled ² , 50 KB application size | _ | 45.0 | _ | ms |
| | | Secure boot application check enabled, second stage bootloader check enabled ² , 150 KB application size | _ | 48.1 | _ | ms |
| | | Secure boot application check enabled, second stage bootloader check enabled ² , 350 KB application size | _ | 54.6 | _ | ms |

- 1. Excludes boost DCDC startup time.
- 2. Timing is measured with the specified bootloader size. Actual bootloader size will impact the boot timing slightly, with a similar µs / KB ratio as application size.

4.12 Crypto Operation Timing for SE Manager API

Values in the following table represent the timing from the SE Manager API call to return. The Cortex-M33 HCLK frequency is 38.4 MHz. The timing specifications are measured at the SE Manager function call API. Each duration in the table contains some portion that is influenced by SE Manager build compilation and Cortex-M33 operating frequency and some portion that is influenced by the Hardware Secure Engine's firmware version and its operating speed (typically 80 MHz). The contributions of the Cortex-M33 properties to the overall specification timing are most pronounced for the shorter operations such as AES and hash when operating on small payloads. The overhead of command processing at the mailbox interface can also dominate the timing for shorter operations.

Conditions:

· SE firmware version 2.2.6

Timing is expected to be similar for subsequent SE firmware versions. Refer to SE firmware release notes for any significant changes.

Table 4.18. Crypto Operation Timing for SE Manager API

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-------------------------------|-------------------------|---|-----|------|--------------|-------------------|
| AES-128 timing | t _{AES128} | AES-128 CCM encryption, PT 1 KB | _ | 643 | _ | μs |
| | | AES-128 CCM encryption, PT 32 KB | _ | 1832 | _ | μs |
| | | AES-128 CTR encryption, PT 1 KB | _ | 524 | _ | μs |
| | | AES-128 CTR encryption, PT 32 KB | _ | 1095 | _ | μs |
| | | AES-128 GCM encryption, PT 1 KB | _ | 583 | _ | μs |
| | | AES-128 GCM encryption, PT 32 KB | _ | 1158 | _ | μs |
| AES-256 timing | t _{AES256} | AES-256 CCM encryption, PT 1 KB | _ | 656 | _ | μs |
| | | AES-256 CCM encryption, PT 32 KB | _ | 2240 | _ | μs |
| | | AES-256 CTR encryption, PT 1 KB | _ | 531 | _ | μs |
| | | AES-256 CTR encryption, PT 32 KB | _ | 1314 | _ | μs |
| | | AES-256 GCM encryption, PT 1 KB | _ | 591 | _ | μs |
| | | AES-256 GCM encryption, PT 32 KB | _ | 1360 | _ | μs |
| ECC P-256 timing | t _{ECC_P256} | ECC key generation, P-256 | _ | 5.6 | _ | ms |
| | | ECC signing, P-256 | _ | 5.9 | _ | ms |
| | | ECC verification, P-256 | _ | 6.2 | _ | ms |
| ECC P-521 timing ¹ | t _{ECC_P521} | ECC key generation, P-521 | _ | 30.5 | _ | hs hs hs hs ms ms |
| | | ECC signing, P-521 | _ | 30.8 | _ | ms |
| | | ECC verification, P-521 | _ | 36.6 | _ | ms |
| ECC P-25519 timing | t _{ECC_P25519} | ECC key generation, P-25519 | _ | 4.6 | _ | ms |
| | | ECC signing, P-25519 | _ | 8.9 | _ | ms |
| | | ECC verification, P-25519 | _ | 6.3 | _ | ms |
| ECDH compute secret timing | t _{ECDH} | ECDH compute secret, P-521 ¹ | _ | 30.7 | _ | ms |
| | | ECDH compute secret, P-25519 ² | _ | 4.6 | _ | ms |
| | | ECDH compute secret, P-256 | _ | 5.7 | _ | ms |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-------------------------------|------------------------|--------------------------------|-----|------|-----|----------|
| ECJPAKE client timing | t _{ECJPAKE_C} | ECJPAKE client write round one | _ | 21.8 | _ | ms |
| | | ECJPAKE client read round one | _ | 11.8 | _ | ms |
| | | ECJPAKE client write round two | _ | 15.6 | _ | ms |
| | | ECJPAKE client read round two | _ | 6.5 | _ | ms |
| | | ECJPAKE client derive secret | _ | 9.0 | _ | ms |
| ECJPAKE server timing | tecjpake_s | ECJPAKE server write round one | _ | 21.8 | _ | ms |
| | | ECJPAKE server read round one | _ | 11.8 | _ | ms |
| | | ECJPAKE server write round two | _ | 15.5 | _ | ms |
| | | ECJPAKE server read round two | _ | 6.5 | _ | ms |
| | | ECJPAKE server derive secret | _ | 9.0 | _ | ms |
| POLY-1305 timing ¹ | t _{POLY1305} | POLY-1305, PT 1 KB | _ | 564 | _ | ms ms |
| | | POLY-1305, PT 32 KB | _ | 1233 | _ | μs |
| SHA-256 timing | t _{SHA256} | SHA-256, PT 1 KB | _ | 340 | _ | μs |
| | | SHA-256, PT 32 KB | _ | 769 | _ | μs |
| SHA-512 timing ¹ | t _{SHA512} | SHA-512, PT 1 KB | _ | 338 | _ | μs |
| | | SHA-512, PT 32 KB | _ | 654 | _ | μs |

- 1. Option is only available on OPNs with Secure Vault High feature set.
- 2. Option is not available on Secure Vault Mid devices with SE firmware earlier than v2.1.7.

4.13 Crypto Operation Average Current for SE Manager API

Values in the following table represent current consumed by security core during the operation, and represent additions to the current consumed by the Cortex-M33 application CPU due to the Hardware Secure Engine CPU and its associated crypto accelerators. The current measurements represent the average value of the current for the duration of the crypto operation. Instantaneous peak currents might be higher.

Conditions:

• SE firmware version 2.2.6

Current consumption is expected to be similar for subsequent SE firmware versions. Refer to SE firmware release notes for any significant changes.

Table 4.19. Crypto Operation Average Current for SE Manager API (Direct supply)

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------|------------------------|---|-----|------|-----|------|
| AES-128 current | I _{AES128} | AES-128 CCM encryption, PT 1 KB | _ | 1.95 | _ | mA |
| | | AES-128 CCM encryption, PT 32 KB | _ | 4.18 | _ | mA |
| | | AES-128 CTR encryption, PT 1 KB | _ | 1.85 | _ | mA |
| | | AES-128 CTR encryption, PT 32 KB | _ | 4.22 | _ | mA |
| | | AES-128 GCM encryption, PT 1 KB | _ | 1.86 | _ | mA |
| | | AES-128 GCM encryption, PT 32 KB | _ | 4.19 | _ | mA |
| AES-256 current | I _{AES256} | AES-256 CCM encryption, PT 1 KB | _ | 2.02 | _ | mA |
| | | AES-256 CCM encryption, PT 32 KB | _ | 4.28 | _ | mA |
| | | AES-256 CTR encryption, PT 1 KB | _ | 1.9 | _ | mA |
| | | AES-256 CTR encryption, PT 32 KB | _ | 4.3 | _ | mA |
| | | AES-256 GCM encryption, PT 1 KB | _ | 1.9 | _ | mA |
| | | AES-256 GCM encryption, PT 32 KB | _ | 4.28 | _ | mA |
| ECC P-256 current | I _{ECCP256} | ECC key generation, P-256 | _ | 2.46 | _ | mA |
| | | ECC signing, P-256 | _ | 2.45 | _ | mA |
| | | ECC verification, P-256 | _ | 2.48 | _ | mA |
| ECC P-521 current ¹ | I _{ECCP521} | ECC key generation, P-521 | _ | 2.61 | _ | mA |
| | | ECC signing, P-521 | _ | 2.6 | _ | mA |
| | | ECC verification, P-521 | _ | 2.6 | _ | mA |
| ECC P-25519 current | I _{ECCP25519} | ECC key generation, P-25519 | _ | 2.42 | _ | mA |
| | | ECC signing, P-25519 | _ | 2.45 | _ | mA |
| | | ECC verification, P-25519 | _ | 2.41 | _ | mA |
| ECDH compute secret cur- | I _{ECDH} | ECDH compute secret, P-521 ¹ | _ | 2.59 | _ | mA |
| rent | | ECDH compute secret, P-25519 ² | _ | 2.33 | _ | mA |
| | | ECDH compute secret, P-256 | _ | 2.43 | _ | mA |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------|------------------------|--------------------------------|-----|------|-----|------|
| ECJPAKE client current | I _{ECJPAKE_C} | ECJPAKE client write round one | _ | 2.49 | _ | mA |
| | | ECJPAKE client read round one | _ | 2.5 | _ | mA |
| | | ECJPAKE client write round two | _ | 2.5 | _ | mA |
| | | ECJPAKE client read round two | _ | 2.44 | _ | mA |
| | | ECJPAKE client derive secret | _ | 2.5 | _ | mA |
| ECJPAKE server current | I _{ECJPAKE_S} | ECJPAKE server write round one | _ | 2.51 | _ | mA |
| | | ECJPAKE server read round one | _ | 2.5 | _ | mA |
| | | ECJPAKE server write round two | _ | 2.5 | _ | mA |
| | | ECJPAKE server read round two | _ | 2.44 | _ | mA |
| | | ECJPAKE server derive secret | _ | 2.5 | _ | mA |
| POLY-1305 current ¹ | I _{POLY1305} | POLY-1305, PT 1 KB | _ | 1.75 | _ | mA |
| | | POLY-1305, PT 32 KB | _ | 2.5 | _ | mA |
| SHA-256 current | I _{SHA256} | SHA-256, PT 1 KB | _ | 1.79 | _ | mA |
| | | SHA-256, PT 32 KB | _ | 3.07 | _ | mA |
| SHA-512 current ¹ | I _{SHA512} | SHA-512, PT 1 KB | _ | 1.77 | _ | mA |
| | | SHA-512, PT 32 KB | _ | 2.76 | _ | mA |

- 1. Option is only available on OPNs with Secure Vault High feature set.
- 2. Option is not available on Secure Vault Mid devices with SE firmware earlier than v2.1.7.

4.14 RFSENSE Low-energy Wake-on-RF

Table 4.20. RFSENSE Low-energy Wake-on-RF

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|-------------------------|--|-----|-----|-----|------|
| Average current | I _{RFSENSE} | RF energy below wake threshold | _ | 138 | _ | nA |
| | | Selective mode, RF energy above threshold but no OOK sync detected | _ | 131 | _ | nA |
| RF level above which RFSENSE will detect signal ¹ | THRES _{TRIG} | Threshold set to -34 dBm | -28 | _ | _ | dBm |
| | | Threshold set to -22 dBm | -19 | _ | _ | dBm |
| RF level below which | THRES _{NOTRIG} | Threshold set to -34 dBm | _ | _ | -40 | dBm |
| RFSENSE will not detect signal ¹ | | Threshold set to -22 dBm | _ | _ | -26 | dBm |
| Sensitivity in selective OOK mode ¹ | SENS _{OOK} | Sensitivity for > 90% probability of OOK detection ² , threshold set to -34 dBm | -28 | _ | _ | dBm |
| | | Sensitivity for > 90% probability of OOK detection ² , threshold set to -22 dBm | -19 | _ | _ | dBm |

- 1. Values collected with conducted measurements performed at the end of the matching network.
- 2. Selective wake signal is 1 kHz OOK Manchester-coded, 8 bits of preamble, 32-bit sync word.

4.15 2.4 GHz RF Transceiver Characteristics for QFN40 Package

4.15.1 RF Transmitter Characteristics for QFN40 Package

4.15.1.1 RF Transmitter General Characteristics for the 2.4 GHz Band

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.0 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.21. RF Transmitter General Characteristics for the 2.4 GHz Band

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|-------------------------|---|------|-------|--------|------|
| RF test frequency range | F _{RANGE} | | 2400 | _ | 2483.5 | MHz |
| Maximum TX power ¹ | POUT _{MAX} | High-power PA | _ | 8.2 | _ | dBm |
| | | 0 dBm PA | _ | -0.4 | _ | dBm |
| Minimum active TX power | POUT _{MIN} | High-power PA | _ | -31.2 | _ | dBm |
| | | 0 dBm PA | _ | -29.3 | _ | dBm |
| Output power variation vs supply voltage variation, fre- quency = 2450 MHz | POUT _{VAR_V} | 8 dBm PA output power, using DCDC with VREGVDD swept from 1.8 to 3.0 V | _ | 0.01 | _ | dB |
| | | 0 dBm PA output power, using DCDC with VREGVDD swept from 1.8 to 3.0 V | _ | 0.01 | _ | dB |
| Output power variation vs temperature, frequency = | POUT _{VAR_T} | High-power PA at 8 dBm, (-40 to +125 °C) | _ | 1.0 | _ | dB |
| 2450 MHz | | 0 dBm PA at 0 dBm, (-40 to +125 °C) | _ | 1.4 | _ | dB |
| Output power variation vs RF | POUT _{VAR_F} | High-power PA, 8 dBm | _ | 0.2 | _ | dB |
| frequency | | 0 dBm PA, 0 dBm | _ | 0.3 | _ | dB |
| Spurious emissions per ETSI EN300.440 | SPUR _{ETSI440} | 47-74 MHz,87.5-108 MHz, 174-230 MHz, 470-862 MHz, P _{out} = POUT _{MAX} , Test Frequency = 2440 MHz | _ | -60 | -54 | dBm |
| | | 25-1000 MHz, excluding above frequencies. P _{out} = POUT _{MAX} , Test Frequency = 2440 MHz | _ | -42 | -36 | dBm |
| | | 1G-14G, P _{out} = POUT _{MAX} , Test Frequency = 2440 MHz | _ | -36 | -30 | dBm |

^{1.} Supported transmit power levels are determined by the ordering part number (OPN). Transmit power ratings for all devices covered in this datasheet can be found in the Max TX Power column of the Ordering Information Table.

4.15.1.2 RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 1 Mbps Data Rate

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.0 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.22. RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 1 Mbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|--------------------------------|---|-----|-------|-----|--------------|
| Transmit 6 dB bandwidth | TXBW | P _{out} = 8 dBm | _ | 665.7 | _ | kHz |
| | | P _{out} = 0 dBm | _ | 665.1 | _ | kHz |
| Power spectral density limit, peak per FCC 15.247 / ANSI C63.10-2020 11.10.2 Meth- od PKPSD-1 | PSD _{LIMIT_PEAK} | P _{out} = 8 dBm, Per FCC part 15.247 at 8 dBm | _ | -8.3 | _ | dBm/ 3kHz |
| | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -16.8 | _ | dBm/ 3kHz |
| Power spectral density limit, average per FCC 15.247 / | PSD _{LIMIT_AVG} | P _{out} = 8 dBm, Per FCC part 15.247 at 8 dBm | _ | -11.9 | _ | dBm/ 3kHz |
| ANSI C63.10-2020 11.10.2 Method AVGPSD-1 | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -20.5 | _ | dBm/ 3kHz |
| Power spectral density limit, per ETSI 300.328 option 2 | PSD _{LIMIT_OPT2} | P _{out} = 8 dBm, Per ETSI 300.328 at 10 dBm/1 MHz | _ | 7.8 | _ | dBm/ 1MHz |
| Occupied channel bandwidth per ETSI EN300.328 | OCP _{ETSI328} | P _{out} = 8 dBm 99% BW at highest and lowest channels in band | _ | 1.0 | _ | MHz |
| | | P _{out} = 0 dBm 99% BW at highest and lowest channels in band | _ | 1.0 | _ | MHz |
| In-band spurious emissions, with allowed exceptions ¹ | SPUR _{INB} | P _{out} = 8 dBm, Inband spurs at ± 2 MHz | | -43.3 | _ | dBm |
| | | P _{out} = 0 dBm, Inband spurs at ± 2 MHz | _ | -52.3 | _ | dBm |
| | | P _{out} = 8 dBm Inband spurs at ± 3 MHz | _ | -48.0 | _ | dBm |
| | | P _{out} = 0 dBm Inband spurs at ± 3 MHz | _ | -57.0 | _ | dBm |
| Spurious emissions of har- monics in restricted bands per FCC Part 15.205/15.209 | SPUR _{HRM_FCC_} | Continuous transmission of modulated carrier. P _{out} = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -47 | _ | dBm |
| Spurious emissions of har- monics in non-restricted bands per FCC Part 15.247/15.35 | SPUR _{HRM_FCC_} NR | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -26 | _ | dBc |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|--------------------------------|---|-----|-----|-----|------|
| Spurious emissions out-of- band (above 2.483 GHz or below 2.4 GHz) in restricted bands, per FCC part 15.205/15.209 | SPUR _{OOB_FCC_} | Restricted bands 30-88 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| 15.205/15.209 | | Restricted bands 88 - 216 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands 216 - 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands > 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| Spurious emissions out-of- band in non-restricted bands per FCC Part 15.247 | SPUR _{OOB_FCC_} NR | Frequencies above 2.483 GHz or below 2.4 GHz, continuous transmission modulated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | - | -26 | _ | dBc |
| Spurious emissions out-of- band, per ETSI EN300.328 | | [2400-BW to 2400], [2483.5 to 2483.5+BW] P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -16 | _ | dBm |
| | | [2400-2BW to 2400-BW], [2483.5+BW to 2483.5+2BW], P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -26 | _ | dBm |
| | | 47-74 MHz, 87.5-118 MHz, 174-230 MHz, 470-694 MHz, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -60 | _ | dBm |
| | | 30-47 MHz, 74-87.5 MHz, 118-174 MHz, 230-470 MHz, 694-1000 MHz , P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -42 | _ | dBm |
| | | 1G-12.75 GHz, excluding bands listed above, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -36 | _ | dBm |

1. As per Bluetooth Core_5.1, Vol.6 Part A, Section 3.2.2, exceptions are allowed in up to three bands of 1 MHz width, centered on a frequency which is an integer multiple of 1 MHz. These exceptions shall have an absolute value of -20 dBm or less.

4.15.1.3 RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 2 Mbps Data Rate

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.0 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.23. RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 2 Mbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|--------------------------------|---|-----|--------|-----|--------------|
| Transmit 6 dB bandwidth | TXBW | P _{out} = 8 dBm | _ | 1372.1 | _ | kHz |
| | | P _{out} = 0 dBm | _ | 1372.6 | _ | kHz |
| Power spectral density limit, peak per FCC 15.247 / ANSI C63.10-2020 11.10.2 Meth- od PKPSD-1 | PSD _{LIMIT_PEAK} | P _{out} = 8 dBm, Per FCC part 15.247 at 8 dBm | _ | -14.4 | _ | dBm/ 3kHz |
| | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -22.9 | _ | dBm/ 3kHz |
| Power spectral density limit, average per FCC 15.247 / ANSI C63.10-2020 11.10.2 Method AVGPSD-1 | PSD _{LIMIT_AVG} | P _{out} = 8 dBm, Per FCC part 15.247 at 8 dBm | _ | -16.5 | _ | dBm/ 3kHz |
| | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -25.0 | _ | dBm/ 3kHz |
| Power spectral density limit, per ETSI 300.328 option 2 | PSD _{LIMIT_OPT2} | P _{out} = 8 dBm, Per ETSI 300.328 at 10 dBm/1 MHz | _ | 6.8 | _ | dBm/ 1MHz |
| Occupied channel bandwidth per ETSI EN300.328 | OCP _{ETSI328} | P _{out} = 8 dBm 99% BW at highest and lowest channels in band | _ | 2.0 | _ | MHz |
| | | P _{out} = 0 dBm 99% BW at highest and lowest channels in band | _ | 2.0 | _ | MHz |
| In-band spurious emissions, with allowed exceptions ¹ | SPUR _{INB} | P _{out} = 8 dBm, Inband spurs at ± 4 MHz | _ | -42.6 | _ | dBm |
| | | P _{out} = 0 dBm, Inband spurs at ± 4 MHz | _ | -51.7 | _ | dBm |
| | | P _{out} = 8 dBm Inband spurs at ± 6 MHz | _ | -48.9 | _ | dBm |
| | | P _{out} = 0 dBm Inband spurs at ± 6 MHz | _ | -57.6 | _ | dBm |
| Spurious emissions of har- monics in restricted bands per FCC Part 15.205/15.209 | SPUR _{HRM_FCC_} | Continuous transmission of modulated carrier. P _{out} = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -47 | _ | dBm |
| Spurious emissions of har- monics in non-restricted bands per FCC Part 15.247/15.35 | SPUR _{HRM_FCC_} NR | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -26 | _ | dBc |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|--------------------------------|---|-----|-----|-----|------|
| Spurious emissions out-of- band (above 2.483 GHz or below 2.4 GHz) in restricted bands, per FCC part 15.205/15.209 | SPUR _{OOB_FCC_} | Restricted bands 30-88 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| 15.205/15.209 | | Restricted bands 88 - 216 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands 216 - 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands > 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| Spurious emissions out-of- band in non-restricted bands per FCC Part 15.247 | SPUR _{OOB_FCC_} NR | Frequencies above 2.483 GHz or below 2.4 GHz, continuous transmission modulated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | - | -26 | _ | dBc |
| Spurious emissions out-of- band, per ETSI EN300.328 | | [2400-BW to 2400], [2483.5 to 2483.5+BW] P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -16 | _ | dBm |
| | | [2400-2BW to 2400-BW], [2483.5+BW to 2483.5+2BW], P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -26 | _ | dBm |
| | | 47-74 MHz, 87.5-118 MHz, 174-230 MHz, 470-694 MHz, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -60 | _ | dBm |
| | | 30-47 MHz, 74-87.5 MHz, 118-174 MHz, 230-470 MHz, 694-1000 MHz , P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -42 | _ | dBm |
| | | 1G-12.75 GHz, excluding bands listed above, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -36 | _ | dBm |

1. As per Bluetooth Core_5.1, Vol.6 Part A, Section 3.2.2, exceptions are allowed in up to three bands of 1 MHz width, centered on a frequency which is an integer multiple of 1 MHz. These exceptions shall have an absolute value of -20 dBm or less.

4.15.1.4 RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 500 kbps Data Rate

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.0 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.24. RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 500 kbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|--------------------------------|---|-----|-------|-----|--------------|
| Transmit 6 dB bandwidth | TXBW | P _{out} = 8 dBm | _ | 693.3 | _ | kHz |
| | | P _{out} = 0 dBm | _ | 688.1 | _ | kHz |
| Power spectral density limit, peak per FCC 15.247 / ANSI C63.10-2020 11.10.2 Meth- od PKPSD-1 | PSD _{LIMIT_PEAK} | P _{out} = 8 dBm, Per FCC part 15.247 at 8 dBm | _ | -9.1 | _ | dBm/ 3kHz |
| | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -17.6 | _ | dBm/ 3kHz |
| Power spectral density limit, average per FCC 15.247 / ANSI C63.10-2020 11.10.2 Method AVGPSD-1 | PSD _{LIMIT_AVG} | P _{out} = 8 dBm, Per FCC part 15.247 at 8 dBm | _ | -13.6 | _ | dBm/ 3kHz |
| | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -22.1 | _ | dBm/ 3kHz |
| Power spectral density limit, per ETSI 300.328 option 2 | PSD _{LIMIT_OPT2} | P _{out} = 8 dBm, Per ETSI 300.328 at 10 dBm/1 MHz | _ | 7.8 | _ | dBm/ 1MHz |
| Occupied channel bandwidth per ETSI EN300.328 | OCP _{ETSI328} | P _{out} = 8 dBm 99% BW at highest and lowest channels in band | _ | 1.0 | _ | MHz |
| | | P _{out} = 0 dBm 99% BW at highest and lowest channels in band | _ | 1.0 | _ | MHz |
| In-band spurious emissions, with allowed exceptions ¹ | SPUR _{INB} | P _{out} = 8 dBm, Inband spurs at ± 2 MHz | _ | -43.3 | _ | dBm |
| | | P _{out} = 0 dBm, Inband spurs at ± 2 MHz | _ | -52.3 | _ | dBm |
| | | P _{out} = 8 dBm Inband spurs at ± 3 MHz | _ | -48.0 | _ | dBm |
| | | P _{out} = 0 dBm Inband spurs at ± 3 MHz | _ | -57.0 | _ | dBm |
| Spurious emissions of har- monics in restricted bands per FCC Part 15.205/15.209 | SPUR _{HRM_FCC_} | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -47 | _ | dBm |
| Spurious emissions of harmonics in non-restricted bands per FCC Part 15.247/15.35 | SPUR _{HRM_FCC_} NR | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -26 | _ | dBc |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|--------------------------------|---|-----|-----|-----|------|
| Spurious emissions out-of- band (above 2.483 GHz or below 2.4 GHz) in restricted bands, per FCC part 15.205/15.209 | SPUR _{OOB_FCC_} | Restricted bands 30-88 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| 15.205/15.209 | | Restricted bands 88 - 216 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands 216 - 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands > 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| Spurious emissions out-of- band in non-restricted bands per FCC Part 15.247 | SPUR _{OOB_FCC_} NR | Frequencies above 2.483 GHz or below 2.4 GHz, continuous transmission modulated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | - | -26 | _ | dBc |
| Spurious emissions out-of- band, per ETSI EN300.328 | | [2400-BW to 2400], [2483.5 to 2483.5+BW] P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -16 | _ | dBm |
| | | [2400-2BW to 2400-BW], [2483.5+BW to 2483.5+2BW], P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -26 | _ | dBm |
| | | 47-74 MHz, 87.5-118 MHz, 174-230 MHz, 470-694 MHz, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -60 | _ | dBm |
| | | 30-47 MHz, 74-87.5 MHz, 118-174 MHz, 230-470 MHz, 694-1000 MHz , P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -42 | _ | dBm |
| | | 1G-12.75 GHz, excluding bands listed above, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -36 | _ | dBm |

1. As per Bluetooth Core_5.1, Vol.6 Part A, Section 3.2.2, exceptions are allowed in up to three bands of 1 MHz width, centered on a frequency which is an integer multiple of 1 MHz. These exceptions shall have an absolute value of -20 dBm or less.

4.15.1.5 RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 125 kbps Data Rate

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.0 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.25. RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 125 kbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|--------------------------------|---|-----|-------|-----|--------------|
| Transmit 6 dB bandwidth | TXBW | P _{out} = 8 dBm | _ | 680.5 | _ | kHz |
| | | P _{out} = 0 dBm | _ | 680.1 | _ | kHz |
| Power spectral density limit, peak per FCC 15.247 / ANSI C63.10-2020 11.10.2 Meth- od PKPSD-1 | PSD _{LIMIT_PEAK} | P _{out} = 8 dBm, Per FCC part 15.247 at 8 dBm | _ | 1.8 | _ | dBm/ 3kHz |
| | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -6.7 | _ | dBm/ 3kHz |
| Power spectral density limit, average per FCC 15.247 / ANSI C63.10-2020 11.10.2 Method AVGPSD-1 | PSD _{LIMIT_AVG} | P _{out} = 8 dBm, Per FCC part 15.247 at 8 dBm | _ | 1.0 | _ | dBm/ 3kHz |
| | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -7.5 | _ | dBm/ 3kHz |
| Power spectral density limit, per ETSI 300.328 option 2 | PSD _{LIMIT_OPT2} | P _{out} = 8 dBm, Per ETSI 300.328 at 10 dBm/1 MHz | _ | 7.7 | _ | dBm/ 1MHz |
| Occupied channel bandwidth per ETSI EN300.328 | OCP _{ETSI328} | P _{out} = 8 dBm 99% BW at highest and lowest channels in band | _ | 1.0 | _ | MHz |
| | | P _{out} = 0 dBm 99% BW at highest and lowest channels in band | _ | 1.0 | _ | MHz |
| In-band spurious emissions, with allowed exceptions ¹ | SPUR _{INB} | P _{out} = 8 dBm, Inband spurs at ± 2 MHz | | -43.3 | _ | dBm |
| | | P _{out} = 0 dBm, Inband spurs at ± 2 MHz | _ | -52.3 | _ | dBm |
| | | P _{out} = 8 dBm Inband spurs at ± 3 MHz | _ | -48.0 | _ | dBm |
| | | P _{out} = 0 dBm Inband spurs at ± 3 MHz | _ | -57.0 | _ | dBm |
| Spurious emissions of har- monics in restricted bands per FCC Part 15.205/15.209 | SPUR _{HRM_FCC_} | Continuous transmission of modulated carrier. P _{out} = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -47 | _ | dBm |
| Spurious emissions of har- monics in non-restricted bands per FCC Part 15.247/15.35 | SPUR _{HRM_FCC_} NR | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -26 | _ | dBc |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|--------------------------------|---|-----|-----|-----|------|
| Spurious emissions out-of- band (above 2.483 GHz or below 2.4 GHz) in restricted bands, per FCC part 15.205/15.209 | SPUR _{OOB_FCC_} | Restricted bands 30-88 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| 15.205/15.209 | | Restricted bands 88 - 216 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands 216 - 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands > 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| Spurious emissions out-of- band in non-restricted bands per FCC Part 15.247 | SPUR _{OOB_FCC_} NR | Frequencies above 2.483 GHz or below 2.4 GHz, continuous transmission modulated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | - | -26 | _ | dBc |
| Spurious emissions out-of- band, per ETSI EN300.328 | | [2400-BW to 2400], [2483.5 to 2483.5+BW] P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -16 | _ | dBm |
| | | [2400-2BW to 2400-BW], [2483.5+BW to 2483.5+2BW], P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -26 | _ | dBm |
| | | 47-74 MHz, 87.5-118 MHz, 174-230 MHz, 470-694 MHz, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -60 | _ | dBm |
| | | 30-47 MHz, 74-87.5 MHz, 118-174 MHz, 230-470 MHz, 694-1000 MHz , P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -42 | _ | dBm |
| | | 1G-12.75 GHz, excluding bands listed above, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -36 | _ | dBm |

1. As per Bluetooth Core_5.1, Vol.6 Part A, Section 3.2.2, exceptions are allowed in up to three bands of 1 MHz width, centered on a frequency which is an integer multiple of 1 MHz. These exceptions shall have an absolute value of -20 dBm or less.

4.15.1.6 RF Transmitter Characteristics for 802.15.4 DSSS-OQPSK in the 2.4 GHz Band

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.0 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.26. RF Transmitter Characteristics for 802.15.4 DSSS-OQPSK in the 2.4 GHz Band

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|--------------------------------|---|-----|-------|-----|--------------|
| Error vector magnitude per 802.15.4-2011 | EVM | Average across frequency, signal is DSSS-OQPSK reference packet, Pout = 8 dBm | _ | 2.9 | _ | % rms |
| | | Average across frequency, signal is DSSS-OQPSK reference packet, P _{out} = 0 dBm | _ | 2.9 | _ | % rms |
| Power spectral density limit, peak per FCC 15.247 / ANSI | PSD _{LIMIT_PEAK} | P _{out} = 8 dBm, Per FCC part 15.247 at 8 dBm | _ | -7.5 | _ | dBm/ 3kHz |
| C63.10-2020 11.10.2 Meth- od PKPSD-1 | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -16.1 | _ | dBm/ 3kHz |
| Power spectral density limit, average per FCC 15.247 / ANSI C63.10-2020 11.10.2 Method AVGPSD-1 | PSD _{LIMIT_AVG} | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -24.1 | _ | dBm/ 3kHz |
| Power spectral density limit, per ETSI 300.328 option 2 | PSD _{LIMIT_OPT2} | P _{out} = 8 dBm, Per ETSI 300.328 at 10 dBm/1 MHz | _ | 6.0 | _ | dBm/ 1MHz |
| Occupied channel bandwidth per ETSI EN300.328 | OCP _{ETSI328} | 99% BW at highest and lowest channels in band, P _{out} = 8 dBm | _ | 2.2 | _ | MHz |
| | | 99% BW at highest and lowest channels in band, P _{out} = 0 dBm | _ | 2.2 | _ | MHz |
| Spurious emissions of harmonics in restricted bands per FCC Part 15.205/15.209 | SPUR _{HRM_FCC_} | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -47 | _ | dBm |
| Spurious emissions of harmonics in non-restricted bands per FCC Part 15.247/15.35 | SPUR _{HRM_FCC_} NR | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -26 | _ | dBc |
| Spurious emissions out-of- band (above 2.483 GHz or below 2.4 GHz) in restricted bands, per FCC part | SPUR _{OOB_FCC_} | Restricted bands 30-88 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| 15.205/15.209 | | Restricted bands 88 - 216 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands 216 - 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands > 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|--------------------------------|---|-----|-----|-----|------|
| Spurious emissions out-of- band in non-restricted bands per FCC Part 15.247 | SPUR _{OOB_FCC_} NR | Frequencies above 2.483 GHz or below 2.4 GHz, continuous transmission modulated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | 1 | -26 | _ | dBc |
| Spurious emissions out-of- band, per ETSI EN300.328 | SPUR _{ETSI328} | [2400-BW to 2400], [2483.5 to 2483.5+BW] P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | | -16 | _ | dBm |
| | | [2400-2BW to 2400-BW], [2483.5+BW to 2483.5+2BW], P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -26 | _ | dBm |
| | | 47-74 MHz, 87.5-118 MHz, 174-230 MHz, 470-694 MHz, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -60 | _ | dBm |
| | | 30-47 MHz, 74-87.5 MHz, 118-174 MHz, 230-470 MHz, 694-1000 MHz , P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -42 | _ | dBm |
| | | 1G-12.75 GHz, excluding bands listed above, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -36 | _ | dBm |

4.15.2 RF Receiver Characteristics for QFN40 Package

4.15.2.1 RF Receiver General Characteristics for the 2.4 GHz Band

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.0 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.27. RF Receiver General Characteristics for the 2.4 GHz Band

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|------------------------|--|------|--------|--------|------|
| RF test frequency range | F _{RANGE} | | 2400 | _ | 2483.5 | MHz |
| Receive mode maximum spurious emission | SPUR _{RX} | 30 MHz to 1 GHz | _ | -92.7 | _ | dBm |
| | | 1 GHz to 12 GHz | _ | -68.5 | _ | dBm |
| Max spurious emissions during active receive mode, per FCC Part 15.109(a) | SPUR _{RX_FCC} | 216 MHz to 960 MHz, conducted measurement | _ | -47 | _ | dBm |
| | | Above 960 MHz, conducted measurement. | _ | -47 | _ | dBm |
| 2GFSK Sensitivity | SENS _{2GFSK} | 2 Mbps 2GFSK signal ¹ , 1% PER | _ | -93.3 | _ | dBm |
| | | 250 kbps 2GFSK signal ² , 0.1% BER | _ | -104.8 | _ | dBm |

- 1. Reference signal is 2 Mbps 2GFSK, BT = 0.5, mi = 1.0, $\Delta f = \pm 1$ MHz, Channel bandwidth = 2.4 MHz.
- 2. Reference signal is 250 kbps 2GFSK, BT = 0.5, mi = 1.0, $\Delta f = \pm 125$ kHz, Channel bandwidth = 350 kHz.

4.15.2.2 RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 1 Mbps Data Rate

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.0 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz, Packet length is 37 bytes.

Table 4.28. RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 1 Mbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------|--|-----|-------|-----|------|
| Rx Max Strong Signal Input Level for 0.1% BER | RX _{SAT} | Signal is reference signal ¹ | _ | 10 | _ | dBm |
| Sensitivity | SENS | Signal is reference signal, 37 byte payload ¹ | _ | -99 | _ | dBm |
| | | Signal is reference signal, 255 byte payload ² | _ | -97.4 | _ | dBm |
| | | With non-ideal signals ³ | _ | -98.4 | _ | dBm |
| Signal to co-channel interferer | C/I _{CC} | (see notes) ^{1 4} | _ | 6.9 | _ | dB |
| N ± 1 Adjacent channel selectivity | C/I ₁ | Interferer is reference signal at +1 MHz offset ^{1 5 4 6} | _ | -7.9 | _ | dB |
| | | Interferer is reference signal at -1 MHz offset ^{1 5 4 6} | _ | -8.1 | _ | dB |
| N ± 2 Alternate channel selectivity | C/I ₂ | Interferer is reference signal at +2 MHz offset ^{1 5 4 6} | _ | -43.8 | _ | dB |
| | | Interferer is reference signal at -2 MHz offset ^{1 5 4 6} | _ | -46.3 | _ | dB |
| N ± 3 Alternate channel selectivity | C/I ₃ | Interferer is reference signal at +3 MHz offset ^{1 5 4 6} | _ | -49.4 | _ | dB |
| | | Interferer is reference signal at -3 MHz offset ^{1 5 4 6} | _ | -51 | _ | dB |
| Selectivity to image frequency | C/I _{IM} | Interferer is reference signal at image frequency with 1 MHz precision ^{1 6} | _ | -24.9 | _ | dB |
| Selectivity to image frequency ± 1 MHz | C/I _{IM_1} | Interferer is reference signal at image frequency +1 MHz with 1 MHz precision ^{1 6} | _ | -43.8 | _ | dB |
| | | Interferer is reference signal at image frequency -1 MHz with 1 MHz precision ^{1 6} | _ | -7.9 | _ | dB |
| Intermodulation performance | IM | n = 3 ⁷ | _ | -15.5 | _ | dBm |

- 1.0.1% Bit Error Rate.
- 2.0.017% Bit Error Rate.
- 3. With non-ideal signals as specified in Bluetooth Test Specification RF-PHY.TS.5.0.1 section 4.7.1.
- 4. Desired signal -67 dBm.
- 5. Desired frequency 2402 MHz ≤ Fc ≤ 2480 MHz.
- 6. With allowed exceptions.
- 7. As specified in Bluetooth Core specification version 5.1, Vol 6, Part A, Section 4.4.

4.15.2.3 RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 2 Mbps Data Rate

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.0 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz, Packet length is 37 bytes.

Table 4.29. RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 2 Mbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------|--|-----|-------|-----|------|
| Rx Max Strong Signal Input Level for 0.1% BER | RX _{SAT} | Signal is reference signal ¹ | _ | 10 | _ | dBm |
| Sensitivity | SENS | Signal is reference signal, 37 byte payload ¹ | _ | -96.1 | _ | dBm |
| | | Signal is reference signal, 255 byte payload ² | _ | -94.6 | _ | dBm |
| | | With non-ideal signals ³ ¹ | _ | -95.8 | _ | dBm |
| Signal to co-channel interferer | C/I _{CC} | (see notes) ^{1 4} | _ | 6.9 | _ | dB |
| N ± 1 Adjacent channel selectivity | C/I ₁ | Interferer is reference signal at +2 MHz offset ^{1 5 4 6} | _ | -7.7 | _ | dB |
| | | Interferer is reference signal at -2 MHz offset ^{1 5 4 6} | _ | -8.5 | _ | dB |
| N ± 2 Alternate channel selectivity | C/I ₂ | Interferer is reference signal at +4 MHz offset ^{1 5 4 6} | _ | -44.1 | _ | dB |
| | | Interferer is reference signal at -4 MHz offset ^{1 5 4 6} | _ | -49.1 | _ | dB |
| N ± 3 Alternate channel selectivity | C/I ₃ | Interferer is reference signal at +6 MHz offset ^{1 5 4 6} | _ | -51 | _ | dB |
| | | Interferer is reference signal at -6 MHz offset ^{1 5 4 6} | _ | -53.4 | _ | dB |
| Selectivity to image frequency | C/I _{IM} | Interferer is reference signal at image frequency with 1 MHz precision ^{1 6} | _ | -24.1 | _ | dB |
| Selectivity to image frequency ± 1 MHz | C/I _{IM_1} | Interferer is reference signal at image frequency +2 MHz with 1 MHz precision ^{1 6} | _ | -44.1 | _ | dB |
| | | Interferer is reference signal at image frequency -2 MHz with 1 MHz precision 1 6 | _ | -7.7 | _ | dB |
| Intermodulation performance | IM | n = 3 ⁷ | _ | -14.5 | _ | dBm |

- 1.0.1% Bit Error Rate.
- 2.0.017% Bit Error Rate.
- 3. With non-ideal signals as specified in Bluetooth Test Specification RF-PHY.TS.5.0.1 section 4.7.1.
- 4. Desired signal -67 dBm.
- 5. Desired frequency 2404 MHz ≤ Fc ≤ 2478 MHz.
- 6. With allowed exceptions.
- 7. As specified in Bluetooth Core specification version 5.1, Vol 6, Part A, Section 4.4.

4.15.2.4 RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 500 kbps Data Rate

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.0 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz, Packet length is 37 bytes.

Table 4.30. RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 500 kbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------|--|-----|--------|-----|------|
| Rx Max Strong Signal Input Level for 0.1% BER | RX _{SAT} | Signal is reference signal ¹ | _ | 10 | _ | dBm |
| Sensitivity | SENS | Signal is reference signal, 37 byte payload ¹ | _ | -102.6 | _ | dBm |
| | | Signal is reference signal, 255 byte payload ² | _ | -101.2 | _ | dBm |
| | | With non-ideal signals ³ 1 | _ | -101.9 | _ | dBm |
| Signal to co-channel interferer | C/I _{CC} | (see notes) ^{1 4} | _ | 2.1 | _ | dB |
| N ± 1 Adjacent channel selectivity | C/I ₁ | Interferer is reference signal at +1 MHz offset ^{1 5 4 6} | _ | -9.1 | _ | dB |
| | | Interferer is reference signal at -1 MHz offset ^{1 5 4 6} | _ | -9.3 | _ | dB |
| N ± 2 Alternate channel selectivity | C/I ₂ | Interferer is reference signal at +2 MHz offset ^{1 5 4 6} | _ | -47.8 | _ | dB |
| | | Interferer is reference signal at -2 MHz offset ^{1 5 4 6} | _ | -51.4 | _ | dB |
| N ± 3 Alternate channel selectivity | C/I ₃ | Interferer is reference signal at +3 MHz offset ^{1 5 4 6} | _ | -48.9 | _ | dB |
| | | Interferer is reference signal at -3 MHz offset ^{1 5 4 6} | _ | -54.8 | _ | dB |
| Selectivity to image frequency | C/I _{IM} | Interferer is reference signal at image frequency with 1 MHz precision 1 6 | _ | -48.8 | _ | dB |
| Selectivity to image frequency ± 1 MHz | C/I _{IM_1} | Interferer is reference signal at image frequency +1 MHz with 1 MHz precision ^{1 6} | _ | -48.9 | _ | dB |
| | | Interferer is reference signal at image frequency -1 MHz with 1 MHz precision 1 6 | _ | -47.8 | _ | dB |

- 1.0.1% Bit Error Rate.
- 2.0.017% Bit Error Rate.
- 3. With non-ideal signals as specified in Bluetooth Test Specification RF-PHY.TS.5.0.1 section 4.7.1.
- 4. Desired signal -67 dBm.
- 5. Desired frequency 2402 MHz \leq Fc \leq 2480 MHz.
- 6. With allowed exceptions.

4.15.2.5 RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 125 kbps Data Rate

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.0 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz, Packet length is 37 bytes.

Table 4.31. RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 125 kbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------|---|-----|--------|-----|------|
| Rx Max Strong Signal Input Level for 0.1% BER | RX _{SAT} | Signal is reference signal ¹ | _ | 10 | _ | dBm |
| Sensitivity | SENS | Signal is reference signal, 37 byte payload ¹ | _ | -106.8 | _ | dBm |
| | | Signal is reference signal, 255 byte payload ² | _ | -106.4 | _ | dBm |
| | | With non-ideal signals ³ 1 | _ | -106.4 | _ | dBm |
| Signal to co-channel interferer | C/I _{CC} | (see notes) ^{1 4} | _ | 0.9 | _ | dB |
| N ± 1 Adjacent channel selectivity | C/I ₁ | Interferer is reference signal at +1 MHz offset ^{1 5 4 6} | _ | -13.2 | _ | dB |
| | | Interferer is reference signal at -1 MHz offset ^{1 5 4 6} | _ | -13.4 | _ | dB |
| N ± 2 Alternate channel selectivity | C/I ₂ | Interferer is reference signal at +2 MHz offset ^{1 5 4 6} | _ | -52.7 | _ | dB |
| | | Interferer is reference signal at -2 MHz offset ^{1 5 4 6} | _ | -55.9 | _ | dB |
| N ± 3 Alternate channel selectivity | C/I ₃ | Interferer is reference signal at +3 MHz offset ^{1 5 4 6} | _ | -52.8 | _ | dB |
| | | Interferer is reference signal at -3 MHz offset ^{1 5 4 6} | _ | -60.2 | _ | dB |
| Selectivity to image frequency | C/I _{IM} | Interferer is reference signal at image frequency with 1 MHz precision ¹⁶ | _ | -52.1 | _ | dB |
| Selectivity to image frequency ± 1 MHz | C/I _{IM_1} | Interferer is reference signal at image frequency +1 MHz with 1 MHz precision ¹⁶ | _ | -52.8 | _ | dB |
| | | Interferer is reference signal at image frequency -1 MHz with 1 MHz precision 1 6 | _ | -52.7 | _ | dB |

- 1.0.1% Bit Error Rate.
- 2.0.017% Bit Error Rate.
- 3. With non-ideal signals as specified in Bluetooth Test Specification RF-PHY.TS.5.0.1 section 4.7.1.
- 4. Desired signal -67 dBm.
- 5. Desired frequency 2402 MHz \leq Fc \leq 2480 MHz.
- 6. With allowed exceptions.

4.15.2.6 RF Receiver Characteristics for 802.15.4 DSSS-OQPSK in the 2.4 GHz Band

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.0 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.32. RF Receiver Characteristics for 802.15.4 DSSS-OQPSK in the 2.4 GHz Band

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------|--|-----|--------|-----|------|
| Rx Max Strong Signal Input Level for 1% PER | RX _{SAT} | Signal is reference signal ¹ . Packet length is 20 octets | _ | 10 | _ | dBm |
| Sensitivity, 1% PER | SENS | Signal is reference signal. Packet length is 20 octets | _ | -102.2 | _ | dBm |
| Co-channel interferer rejection, 1% PER | CCR | Desired signal 3 dB above sensitivity limit | _ | 1.9 | _ | dB |
| High-side adjacent channel rejection, 1% PER. Desired is reference signal at 3 dB above reference sensitivity level ² | ACR _{P1} | Interferer is reference signal at +1 channel-spacing | _ | 34.9 | _ | dB |
| Low-side adjacent channel rejection, 1% PER. Desired is reference signal at 3 dB above reference sensitivity level ² | ACR _{M1} | Interferer is reference signal at -1 channel-spacing | _ | 35.5 | _ | dB |
| Alternate channel rejection, 1% PER. Desired is reference signal at 3 dB above reference sensitivity level ² | ACR ₂ | Interferer is reference signal at ± 2 channel-spacing | _ | 47.9 | _ | dB |
| Image rejection , 1% PER. Desired is reference signal at 3 dB above reference sensitivity level ² | IR | Interferer is CW in image band ³ | _ | 38.9 | _ | dB |
| Blocking rejection of all other channels, 1% PER. Desired | BLOCK | Interferer frequency < Desired frequency - 3 channel-spacing | _ | 53.8 | _ | dB |
| is reference signal at 3 dB above reference sensitivity level ² . Interferer is reference signal | | Interferer frequency > Desired frequency + 3 channel-spacing | _ | 53.9 | _ | dB |
| RSSI resolution | RSSI _{RES} | -100 dBm to +5 dBm | _ | 0.25 | _ | dB |
| RSSI accuracy in the linear region as defined by 802.15.4-2020 | RSSI _{LIN} | | _ | +/-6 | _ | dB |

- 1. Reference signal is defined as O-QPSK DSSS per 802.15.4, frequency range = 2400-2483.5 MHz, symbol rate = 62.5 ksymbols/s.
- 2. Reference sensitivity level is -85 dBm.
- 3. Due to low-IF frequency, there is some overlap of adjacent channel and image channel bands. Adjacent channel CW blocker tests place the Interferer center frequency at the desired frequency ± 5 MHz on the channel raster, whereas the image rejection test places the CW interferer near the image frequency of the desired signal carrier, regardless of the channel raster.

4.16 2.4 GHz RF Transceiver Characteristics for WLCSP45 Package

4.16.1 RF Transmitter Characteristics for WLCSP45 Package

4.16.1.1 WLCSP45 Package RF Transmitter General Characteristics for the 2.4 GHz Band

Unless otherwise indicated, typical conditions are: $T_A = 25$ °C, VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.33. WLCSP45 Package RF Transmitter General Characteristics for the 2.4 GHz Band

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|-------------------------|---|------|-------|--------|------|
| RF test frequency range | F _{RANGE} | | 2400 | _ | 2483.5 | MHz |
| Maximum TX power ¹ | POUT _{MAX} | High-power PA | _ | 4 | _ | dBm |
| | | 0 dBm PA | _ | 0.6 | _ | dBm |
| Minimum active TX power | POUT _{MIN} | High-power PA | _ | -30.5 | _ | dBm |
| | | 0 dBm PA | _ | -27.2 | _ | dBm |
| Output power variation vs supply voltage variation, fre- quency = 2450 MHz | POUT _{VAR_V} | 4 dBm PA output power, using boost DCDC with VBAT swept from 1.2 to 1.7 V | _ | 0.01 | _ | dB |
| | | 0 dBm PA output power, using boost DCDC with VBAT swept from 1.2 to 1.7 V | _ | 0.01 | _ | dB |
| Output power variation vs temperature, frequency = | POUT _{VAR_T} | High-power PA at 4 dBm, (-20 to +55 °C) | _ | 0.2 | _ | dB |
| 2450 MHz | | 0 dBm PA at 0 dBm, (-20 to +55 °C) | _ | 0.4 | _ | dB |
| Output power variation vs RF | POUT _{VAR_F} | High-power PA, 4 dBm | _ | 0.2 | _ | dB |
| frequency | | 0 dBm PA, 0 dBm | _ | 0.2 | _ | dB |
| Spurious emissions per ETSI EN300.440 | SPUR _{ETSI440} | 47-74 MHz,87.5-108 MHz, 174-230 MHz, 470-862 MHz, P _{out} = POUT _{MAX} , Test Frequency = 2440 MHz | _ | -60 | -54 | dBm |
| | | 25-1000 MHz, excluding above frequencies. P _{out} = POUT _{MAX} , Test Frequency = 2440 MHz | _ | -42 | -36 | dBm |
| | | 1G-14G, P _{out} = POUT _{MAX} , Test Frequency = 2440 MHz | _ | -36 | -30 | dBm |

^{1.} Supported transmit power levels are determined by the ordering part number (OPN). Transmit power ratings for all devices covered in this datasheet can be found in the Max TX Power column of the Ordering Information Table.

4.16.1.2 WLCSP45 Package RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 1 Mbps Data Rate

Unless otherwise indicated, typical conditions are: $T_A = 25$ °C, VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.34. WLCSP45 Package RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 1 Mbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|--------------------------------|---|-----|-------|-----|--------------|
| Transmit 6 dB bandwidth | TXBW | P _{out} = 4 dBm | _ | 665.8 | _ | kHz |
| | | P _{out} = 0 dBm | _ | 666.2 | _ | kHz |
| Power spectral density limit, peak per FCC 15.247 / ANSI C63.10-2020 11.10.2 Meth- od PKPSD-1 | PSD _{LIMIT_PEAK} | P _{out} = 4 dBm, Per FCC part 15.247 at 4 dBm | _ | -8.8 | _ | dBm/ 3kHz |
| | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -15.6 | _ | dBm/ 3kHz |
| Power spectral density limit, average per FCC 15.247 / ANSI C63.10-2020 11.10.2 | PSD _{LIMIT_AVG} | P _{out} = 4 dBm, Per FCC part 15.247 at 4 dBm | _ | -12.3 | _ | dBm/ 3kHz |
| Method AVGPSD-1 | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -19.3 | _ | dBm/ 3kHz |
| Power spectral density limit, per ETSI 300.328 option 2 | PSD _{LIMIT_OPT2} | P _{out} = 4 dBm, Per ETSI 300.328 at 10 dBm/1 MHz | _ | 7.2 | _ | dBm/ 1MHz |
| Occupied channel bandwidth per ETSI EN300.328 | OCP _{ETSI328} | P _{out} = 4 dBm 99% BW at highest and lowest channels in band | _ | 1.0 | _ | MHz |
| | | P _{out} = 0 dBm 99% BW at highest and lowest channels in band | _ | 1.0 | _ | MHz |
| In-band spurious emissions, with allowed exceptions ¹ | SPUR _{INB} | P _{out} = 4 dBm, Inband spurs at ± 2 MHz | _ | -48.4 | _ | dBm |
| | | P _{out} = 0 dBm, Inband spurs at ± 2 MHz | _ | -51.3 | _ | dBm |
| | | P _{out} = 4 dBm Inband spurs at ± 3 MHz | _ | -53.2 | _ | dBm |
| | | P _{out} = 0 dBm Inband spurs at ± 3 MHz | _ | -56.2 | _ | dBm |
| Spurious emissions of harmonics in restricted bands per FCC Part 15.205/15.209 | SPUR _{HRM_FCC_} | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -47 | _ | dBm |
| Spurious emissions of harmonics in non-restricted bands per FCC Part 15.247/15.35 | SPUR _{HRM_FCC_} NR | Continuous transmission of modulated carrier. P _{out} = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -26 | _ | dBc |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|--------------------------------|---|-----|-----|-----|------|
| Spurious emissions out-of- band (above 2.483 GHz or below 2.4 GHz) in restricted bands, per FCC part | SPUR _{OOB_FCC_} R | Restricted bands 30-88 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| 15.205/15.209 | | Restricted bands 88 - 216 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands 216 - 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands > 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| Spurious emissions out-of- band in non-restricted bands per FCC Part 15.247 | SPUR _{OOB_FCC_} NR | Frequencies above 2.483 GHz or below 2.4 GHz, continuous transmission modulated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | - | -26 | _ | dBc |
| Spurious emissions out-of-band, per ETSI EN300.328 | SPUR _{ETSI328} | [2400-BW to 2400], [2483.5 to 2483.5+BW] P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -16 | _ | dBm |
| | | [2400-2BW to 2400-BW], [2483.5+BW to 2483.5+2BW], P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -26 | _ | dBm |
| | | 47-74 MHz, 87.5-118 MHz, 174-230 MHz, 470-694 MHz, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -60 | _ | dBm |
| | | 30-47 MHz, 74-87.5 MHz, 118-174 MHz, 230-470 MHz, 694-1000 MHz , P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -42 | _ | dBm |
| | | 1G-12.75 GHz, excluding bands listed above, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -36 | _ | dBm |

1. As per Bluetooth Core_5.1, Vol.6 Part A, Section 3.2.2, exceptions are allowed in up to three bands of 1 MHz width, centered on a frequency which is an integer multiple of 1 MHz. These exceptions shall have an absolute value of -20 dBm or less.

4.16.1.3 WLCSP45 Package RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 2 Mbps Data Rate

Unless otherwise indicated, typical conditions are: $T_A = 25$ °C, VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.35. WLCSP45 Package RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 2 Mbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|--------------------------------|---|-----|--------|-----|--------------|
| Transmit 6 dB bandwidth | TXBW | P _{out} = 4 dBm | _ | 1372.2 | _ | kHz |
| | | P _{out} = 0 dBm | _ | 1371.8 | _ | kHz |
| Power spectral density limit, peak per FCC 15.247 / ANSI C63.10-2020 11.10.2 Meth- | PSD _{LIMIT_PEAK} | P _{out} = 4 dBm, Per FCC part 15.247 at 4 dBm | _ | -14.8 | _ | dBm/ 3kHz |
| od PKPSD-1 | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -21.7 | _ | dBm/ 3kHz |
| Power spectral density limit, average per FCC 15.247 / ANSI C63.10-2020 11.10.2 | PSD _{LIMIT_AVG} | P _{out} = 4 dBm, Per FCC part 15.247 at 4 dBm | _ | -16.9 | _ | dBm/ 3kHz |
| Method AVGPSD-1 | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -23.8 | _ | dBm/ 3kHz |
| Power spectral density limit, per ETSI 300.328 option 2 | PSD _{LIMIT_OPT2} | P _{out} = 4 dBm, Per ETSI 300.328 at 10 dBm/1 MHz | _ | 6.2 | _ | dBm/ 1MHz |
| Occupied channel bandwidth per ETSI EN300.328 | OCP _{ETSI328} | P _{out} = 4 dBm 99% BW at highest and lowest channels in band | _ | 2.0 | _ | MHz |
| | | P _{out} = 0 dBm 99% BW at highest and lowest channels in band | _ | 2.0 | _ | MHz |
| In-band spurious emissions, with allowed exceptions ¹ | SPUR _{INB} | P _{out} = 4 dBm, Inband spurs at ± 4 MHz | _ | -47.8 | _ | dBm |
| | | P _{out} = 0 dBm, Inband spurs at ± 4 MHz | _ | -51.2 | _ | dBm |
| | | P _{out} = 4 dBm Inband spurs at ± 6 MHz | _ | -53.8 | _ | dBm |
| | | P _{out} = 0 dBm Inband spurs at ± 6 MHz | _ | -57.1 | _ | dBm |
| Spurious emissions of harmonics in restricted bands per FCC Part 15.205/15.209 | SPUR _{HRM_FCC_} | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -47 | _ | dBm |
| Spurious emissions of har- monics in non-restricted bands per FCC Part 15.247/15.35 | SPUR _{HRM_FCC_} NR | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -26 | _ | dBc |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|--|---|-----|-----|-----|------|
| Spurious emissions out-of- band (above 2.483 GHz or below 2.4 GHz) in restricted bands, per FCC part | SPUR _{OOB_FCC_} | Restricted bands 30-88 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | | -47 | _ | dBm |
| 15.205/15.209 | | Restricted bands 88 - 216 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | | -47 | _ | dBm |
| | | Restricted bands 216 - 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands > 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| Spurious emissions out-of- band in non-restricted bands per FCC Part 15.247 | SPUR _{OOB_FCC_} NR | Frequencies above 2.483 GHz or below 2.4 GHz, continuous transmission modulated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | - | -26 | _ | dBc |
| Spurious emissions out-of- band, per ETSI EN300.328 | SPUR _{ETSI328} | [2400-BW to 2400], [2483.5 to 2483.5+BW] P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -16 | _ | dBm |
| | | [2400-2BW to 2400-BW], [2483.5+BW to 2483.5+2BW], P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -26 | _ | dBm |
| | | 47-74 MHz, 87.5-118 MHz, 174-230 MHz, 470-694 MHz, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -60 | _ | dBm |
| | | 30-47 MHz, 74-87.5 MHz, 118-174 MHz, 230-470 MHz, 694-1000 MHz , P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -42 | _ | dBm |
| | 1G-12.75 GHz, excluding bands listed above, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -36 | _ | dBm | |

1. As per Bluetooth Core_5.1, Vol.6 Part A, Section 3.2.2, exceptions are allowed in up to three bands of 1 MHz width, centered on a frequency which is an integer multiple of 1 MHz. These exceptions shall have an absolute value of -20 dBm or less.

4.16.1.4 WLCSP45 Package RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 500 kbps Data Rate

Unless otherwise indicated, typical conditions are: $T_A = 25$ °C, VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.36. WLCSP45 Package RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 500 kbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|--------------------------------|---|-----|-------|-----|--------------|
| Transmit 6 dB bandwidth | TXBW | P _{out} = 4 dBm | _ | 694.8 | _ | kHz |
| | | P _{out} = 0 dBm | _ | 694.2 | _ | kHz |
| Power spectral density limit, peak per FCC 15.247 / ANSI | PSD _{LIMIT_PEAK} | P _{out} = 4 dBm, Per FCC part 15.247 at 4 dBm | _ | -9.6 | _ | dBm/ 3kHz |
| C63.10-2020 11.10.2 Meth- od PKPSD-1 | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -16.5 | _ | dBm/ 3kHz |
| Power spectral density limit, average per FCC 15.247 / ANSI C63.10-2020 11.10.2 | PSD _{LIMIT_AVG} | P _{out} = 4 dBm, Per FCC part 15.247 at 4 dBm | _ | -14.1 | _ | dBm/ 3kHz |
| Method AVGPSD-1 | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -20.9 | _ | dBm/ 3kHz |
| Power spectral density limit, per ETSI 300.328 option 2 | PSD _{LIMIT_OPT2} | P _{out} = 4 dBm, Per ETSI 300.328 at 10 dBm/1 MHz | _ | 7.2 | _ | dBm/ 1MHz |
| Occupied channel bandwidth per ETSI EN300.328 | OCP _{ETSI328} | P _{out} = 4 dBm 99% BW at highest and lowest channels in band | _ | 1.0 | _ | MHz |
| | | P _{out} = 0 dBm 99% BW at highest and lowest channels in band | _ | 1.0 | _ | MHz |
| In-band spurious emissions, with allowed exceptions ¹ | SPUR _{INB} | P _{out} = 4 dBm, Inband spurs at ± 2 MHz | _ | -48.4 | _ | dBm |
| | | P _{out} = 0 dBm, Inband spurs at ± 2 MHz | _ | -51.3 | _ | dBm |
| | | P _{out} = 4 dBm Inband spurs at ± 3 MHz | _ | -53.2 | _ | dBm |
| | | P _{out} = 0 dBm Inband spurs at ± 3 MHz | _ | -56.2 | _ | dBm |
| Spurious emissions of har- monics in restricted bands per FCC Part 15.205/15.209 | SPUR _{HRM_FCC_} | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -47 | _ | dBm |
| Spurious emissions of har- monics in non-restricted bands per FCC Part 15.247/15.35 | SPUR _{HRM_FCC_} NR | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -26 | _ | dBc |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|--------------------------------|---|-----|-----|-----|------|
| Spurious emissions out-of- band (above 2.483 GHz or below 2.4 GHz) in restricted bands, per FCC part | SPUR _{OOB_FCC_} R | Restricted bands 30-88 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| 15.205/15.209 | | Restricted bands 88 - 216 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands 216 - 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands > 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| Spurious emissions out-of- band in non-restricted bands per FCC Part 15.247 | SPUR _{OOB_FCC_} NR | Frequencies above 2.483 GHz or below 2.4 GHz, continuous transmission modulated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | - | -26 | _ | dBc |
| Spurious emissions out-of-band, per ETSI EN300.328 | SPUR _{ETSI328} | [2400-BW to 2400], [2483.5 to 2483.5+BW] P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -16 | _ | dBm |
| | | [2400-2BW to 2400-BW], [2483.5+BW to 2483.5+2BW], P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -26 | _ | dBm |
| | | 47-74 MHz, 87.5-118 MHz, 174-230 MHz, 470-694 MHz, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -60 | _ | dBm |
| | | 30-47 MHz, 74-87.5 MHz, 118-174 MHz, 230-470 MHz, 694-1000 MHz , P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -42 | _ | dBm |
| | | 1G-12.75 GHz, excluding bands listed above, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -36 | _ | dBm |

1. As per Bluetooth Core_5.1, Vol.6 Part A, Section 3.2.2, exceptions are allowed in up to three bands of 1 MHz width, centered on a frequency which is an integer multiple of 1 MHz. These exceptions shall have an absolute value of -20 dBm or less.

4.16.1.5 WLCSP45 Package RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 125 kbps Data Rate

Unless otherwise indicated, typical conditions are: $T_A = 25$ °C, VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.37. WLCSP45 Package RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 125 kbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|--------------------------------|---|-----|-------|-----|--------------|
| Transmit 6 dB bandwidth | TXBW | P _{out} = 4 dBm | _ | 683.0 | _ | kHz |
| | | P _{out} = 0 dBm | _ | 681.9 | _ | kHz |
| Power spectral density limit, peak per FCC 15.247 / ANSI C63.10-2020 11.10.2 Meth- od PKPSD-1 | PSD _{LIMIT_PEAK} | P _{out} = 4 dBm, Per FCC part 15.247 at 4 dBm | _ | 1.4 | _ | dBm/ 3kHz |
| | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -5.5 | _ | dBm/ 3kHz |
| Power spectral density limit, average per FCC 15.247 / | PSD _{LIMIT_AVG} | P _{out} = 4 dBm, Per FCC part 15.247 at 4 dBm | _ | 0.5 | _ | dBm/ 3kHz |
| ANSI C63.10-2020 11.10.2 Method AVGPSD-1 | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -6.4 | _ | dBm/ 3kHz |
| Power spectral density limit, per ETSI 300.328 option 2 | PSD _{LIMIT_OPT2} | P _{out} = 4 dBm, Per ETSI 300.328 at 10 dBm/1 MHz | _ | 7.1 | _ | dBm/ 1MHz |
| Occupied channel bandwidth per ETSI EN300.328 | OCP _{ETSI328} | P _{out} = 4 dBm 99% BW at highest and lowest channels in band | _ | 1.0 | _ | MHz |
| | | P _{out} = 0 dBm 99% BW at highest and lowest channels in band | _ | 1.0 | _ | MHz |
| In-band spurious emissions, with allowed exceptions ¹ | SPUR _{INB} | P _{out} = 4 dBm, Inband spurs at ± 2 MHz | _ | -48.4 | _ | dBm |
| | | P _{out} = 0 dBm, Inband spurs at ± 2 MHz | _ | -51.3 | _ | dBm |
| | | P _{out} = 4 dBm Inband spurs at ± 3 MHz | _ | -53.2 | _ | dBm |
| | | P _{out} = 0 dBm Inband spurs at ± 3 MHz | _ | -56.2 | _ | dBm |
| Spurious emissions of har- monics in restricted bands per FCC Part 15.205/15.209 | SPUR _{HRM_FCC_} | Continuous transmission of modulated carrier. P _{out} = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -47 | _ | dBm |
| Spurious emissions of har- monics in non-restricted bands per FCC Part 15.247/15.35 | SPUR _{HRM_FCC_} NR | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -26 | _ | dBc |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|--------------------------------|---|-----|-----|-----|------|
| Spurious emissions out-of- band (above 2.483 GHz or below 2.4 GHz) in restricted bands, per FCC part | SPUR _{OOB_FCC_} R | Restricted bands 30-88 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| 15.205/15.209 | | Restricted bands 88 - 216 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands 216 - 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands > 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| Spurious emissions out-of- band in non-restricted bands per FCC Part 15.247 | SPUR _{OOB_FCC_} NR | Frequencies above 2.483 GHz or below 2.4 GHz, continuous transmission modulated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | - | -26 | _ | dBc |
| Spurious emissions out-of-band, per ETSI EN300.328 | SPUR _{ETSI328} | [2400-BW to 2400], [2483.5 to 2483.5+BW] P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -16 | _ | dBm |
| | | [2400-2BW to 2400-BW], [2483.5+BW to 2483.5+2BW], P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -26 | _ | dBm |
| | | 47-74 MHz, 87.5-118 MHz, 174-230 MHz, 470-694 MHz, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -60 | _ | dBm |
| | | 30-47 MHz, 74-87.5 MHz, 118-174 MHz, 230-470 MHz, 694-1000 MHz , P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -42 | _ | dBm |
| | | 1G-12.75 GHz, excluding bands listed above, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -36 | _ | dBm |

1. As per Bluetooth Core_5.1, Vol.6 Part A, Section 3.2.2, exceptions are allowed in up to three bands of 1 MHz width, centered on a frequency which is an integer multiple of 1 MHz. These exceptions shall have an absolute value of -20 dBm or less.

4.16.1.6 WLCSP45 Package RF Transmitter Characteristics for 802.15.4 DSSS-OQPSK in the 2.4 GHz Band

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.38. WLCSP45 Package RF Transmitter Characteristics for 802.15.4 DSSS-OQPSK in the 2.4 GHz Band

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|--------------------------------|---|-----|-------|-----|--------------|
| Error vector magnitude per 802.15.4-2011 | EVM | Average across frequency, signal is DSSS-OQPSK reference packet, P _{out} = 4 dBm | _ | 3.1 | _ | % rms |
| | | Average across frequency, signal is DSSS-OQPSK reference packet, P _{out} = 0 dBm | _ | 3.1 | _ | % rms |
| Power spectral density limit, peak per FCC 15.247 / ANSI | PSD _{LIMIT_PEAK} | P _{out} = 4 dBm, Per FCC part 15.247 at 4 dBm | _ | -7.8 | _ | dBm/ 3kHz |
| C63.10-2020 11.10.2 Meth- od PKPSD-1 | | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -14.9 | _ | dBm/ 3kHz |
| Power spectral density limit, average per FCC 15.247 / ANSI C63.10-2020 11.10.2 Method AVGPSD-1 | PSD _{LIMIT_AVG} | P _{out} = 0 dBm, Per FCC part 15.247 at 0 dBm | _ | -22.7 | _ | dBm/ 3kHz |
| Power spectral density limit, per ETSI 300.328 option 2 | PSD _{LIMIT_OPT2} | P _{out} = 4 dBm, Per ETSI 300.328 at 10 dBm/1 MHz | _ | 5.4 | _ | dBm/ 1MHz |
| Occupied channel bandwidth per ETSI EN300.328 | OCP _{ETSI328} | 99% BW at highest and lowest channels in band, P _{out} = 4 dBm | _ | 2.2 | _ | MHz |
| | | 99% BW at highest and lowest channels in band, P _{out} = 0 dBm | _ | 2.2 | _ | MHz |
| Spurious emissions of harmonics in restricted bands per FCC Part 15.205/15.209 | SPUR _{HRM_FCC_} | Continuous transmission of modulated carrier. P _{out} = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -47 | _ | dBm |
| Spurious emissions of har- monics in non-restricted bands per FCC Part 15.247/15.35 | SPUR _{HRM_FCC_} NR | Continuous transmission of modulated carrier. Pout = POUT _{MAX} . Test frequency = 2440 MHz. | _ | -26 | _ | dBc |
| Spurious emissions out-of- band (above 2.483 GHz or below 2.4 GHz) in restricted bands, per FCC part | SPUR _{OOB_FCC_} R | Restricted bands 30-88 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| 15.205/15.209 | | Restricted bands 88 - 216 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands 216 - 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |
| | | Restricted bands > 960 MHz, Continuous transmission of modu- lated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -47 | _ | dBm |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|--------------------------------|---|-----|-----|-----|------|
| Spurious emissions out-of- band in non-restricted bands per FCC Part 15.247 | SPUR _{OOB_FCC_} NR | Frequencies above 2.483 GHz or below 2.4 GHz, continuous transmission modulated carrier, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -26 | _ | dBc |
| Spurious emissions out-of- band, per ETSI EN300.328 | SPUR _{ETSI328} | [2400-BW to 2400], [2483.5 to 2483.5+BW] P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -16 | _ | dBm |
| | | [2400-2BW to 2400-BW], [2483.5+BW to 2483.5+2BW], P _{out} = POUT _{MAX} , Test frequency = 2402 and 2480 MHz | _ | -26 | _ | dBm |
| | | 47-74 MHz, 87.5-118 MHz, 174-230 MHz, 470-694 MHz, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -60 | _ | dBm |
| | | 30-47 MHz, 74-87.5 MHz, 118-174 MHz, 230-470 MHz, 694-1000 MHz , P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -42 | _ | dBm |
| | | 1G-12.75 GHz, excluding bands listed above, P _{out} = POUT _{MAX} , Test frequency = 2440 MHz | _ | -36 | _ | dBm |

4.16.2 RF Receiver Characteristics for WLCSP45 Package

4.16.2.1 WLCSP45 Package RF Receiver General Characteristics for the 2.4 GHz Band

Unless otherwise indicated, typical conditions are: $T_A = 25$ °C, VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.39. WLCSP45 Package RF Receiver General Characteristics for the 2.4 GHz Band

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|------------------------|--|------|--------|--------|------|
| RF test frequency range | F _{RANGE} | | 2400 | _ | 2483.5 | MHz |
| Receive mode maximum spurious emission | SPUR _{RX} | 30 MHz to 1 GHz | _ | -93.6 | _ | dBm |
| | | 1 GHz to 12 GHz | _ | -71.7 | _ | dBm |
| Max spurious emissions during active receive mode, per FCC Part 15.109(a) | SPUR _{RX_FCC} | 216 MHz to 960 MHz, conducted measurement | _ | -47 | _ | dBm |
| | | Above 960 MHz, conducted measurement. | _ | -47 | _ | dBm |
| 2GFSK Sensitivity | SENS _{2GFSK} | 2 Mbps 2GFSK signal ¹ , 1% PER | _ | -93.5 | _ | dBm |
| | | 250 kbps 2GFSK signal ² , 0.1% BER | _ | -104.8 | _ | dBm |

- 1. Reference signal is 2 Mbps 2GFSK, BT = 0.5, mi = 1.0, Δ f = \pm 1 MHz, Channel bandwidth = 2.4 MHz.
- 2. Reference signal is 250 kbps 2GFSK, BT = 0.5, mi = 1.0, Δf = \pm 125 kHz, Channel bandwidth = 350 kHz.

4.16.2.2 WLCSP45 Package RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 1 Mbps Data Rate

Unless otherwise indicated, typical conditions are: $T_A = 25$ °C, VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz, Packet length is 37 bytes.

Table 4.40. WLCSP45 Package RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 1 Mbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------|--|--------------|-------|-----|------|
| Rx Max Strong Signal Input Level for 0.1% BER | RX _{SAT} | Signal is reference signal ¹ | _ | 10 | _ | dBm |
| Sensitivity | SENS | Signal is reference signal, 37 byte payload ¹ | _ | -99.1 | _ | dBm |
| | | Signal is reference signal, 255 byte payload ² | _ | -97.6 | _ | dBm |
| | | With non-ideal signals ³ ¹ | _ | -98.6 | _ | dBm |
| Signal to co-channel interferer | C/I _{CC} | (see notes) ^{1 4} | _ | 6.8 | _ | dB |
| N ± 1 Adjacent channel selectivity | C/I ₁ | Interferer is reference signal at +1 MHz offset ^{1 5 4 6} | _ | -7.9 | _ | dB |
| | | Interferer is reference signal at -1 MHz offset ^{1 5 4 6} | _ | -8 | _ | dB |
| N ± 2 Alternate channel selectivity | C/I ₂ | Interferer is reference signal at +2 MHz offset ^{1 5 4 6} | _ | -43.4 | _ | dB |
| | | Interferer is reference signal at -2 MHz offset ^{1 5 4 6} | _ | -46.4 | _ | dB |
| N ± 3 Alternate channel selectivity | C/I ₃ | Interferer is reference signal at +3 MHz offset ^{1 5 4 6} | _ | -50.8 | _ | dB |
| | | Interferer is reference signal at -3 MHz offset ^{1 5 4 6} | _ | -51.7 | _ | dB |
| Selectivity to image frequency | C/I _{IM} | Interferer is reference signal at image frequency with 1 MHz precision ¹⁶ | _ | -24.9 | _ | dB |
| Selectivity to image frequency ± 1 MHz | C/I _{IM_1} | Interferer is reference signal at image frequency +1 MHz with 1 MHz precision ^{1 6} | _ | -43.4 | _ | dB |
| | | Interferer is reference signal at image frequency -1 MHz with 1 MHz precision 1 6 | _ | -7.9 | _ | dB |
| Intermodulation performance | IM | n = 3 ⁷ | _ | -15.4 | _ | dBm |

- 1.0.1% Bit Error Rate.
- 2.0.017% Bit Error Rate.
- 3. With non-ideal signals as specified in Bluetooth Test Specification RF-PHY.TS.5.0.1 section 4.7.1.
- 4. Desired signal -67 dBm.
- 5. Desired frequency 2402 MHz ≤ Fc ≤ 2480 MHz.
- 6. With allowed exceptions.
- 7. As specified in Bluetooth Core specification version 5.1, Vol 6, Part A, Section 4.4.

4.16.2.3 WLCSP45 Package RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 2 Mbps Data Rate

Unless otherwise indicated, typical conditions are: $T_A = 25$ °C, VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz, Packet length is 37 bytes.

Table 4.41. WLCSP45 Package RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 2 Mbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------|--|--------------|-------|-----|------|
| Rx Max Strong Signal Input Level for 0.1% BER | RX _{SAT} | Signal is reference signal ¹ | _ | 10 | _ | dBm |
| Sensitivity | SENS | Signal is reference signal, 37 byte payload ¹ | _ | -96.1 | _ | dBm |
| | | Signal is reference signal, 255 byte payload ² | _ | -94.7 | _ | dBm |
| | | With non-ideal signals ³ ¹ | _ | -95.9 | _ | dBm |
| Signal to co-channel interferer | C/I _{CC} | (see notes) ^{1 4} | _ | 7 | _ | dB |
| N ± 1 Adjacent channel selectivity | C/I ₁ | Interferer is reference signal at +2 MHz offset ^{1 5 4 6} | _ | -7.5 | _ | dB |
| | | Interferer is reference signal at -2 MHz offset ^{1 5 4 6} | _ | -8.4 | _ | dB |
| N ± 2 Alternate channel selectivity | C/I ₂ | Interferer is reference signal at +4 MHz offset ^{1 5 4 6} | _ | -43.4 | _ | dB |
| | | Interferer is reference signal at -4 MHz offset ^{1 5 4 6} | _ | -48.2 | _ | dB |
| N ± 3 Alternate channel selectivity | C/I ₃ | Interferer is reference signal at +6 MHz offset ^{1 5 4 6} | _ | -50.5 | _ | dB |
| | | Interferer is reference signal at -6 MHz offset ^{1 5 4 6} | _ | -52.6 | _ | dB |
| Selectivity to image frequency | C/I _{IM} | Interferer is reference signal at image frequency with 1 MHz precision ¹⁶ | _ | -24.1 | _ | dB |
| Selectivity to image frequency ± 1 MHz | C/I _{IM_1} | Interferer is reference signal at image frequency +2 MHz with 1 MHz precision ^{1 6} | _ | -43.4 | _ | dB |
| | | Interferer is reference signal at image frequency -2 MHz with 1 MHz precision 1 6 | _ | -7.5 | _ | dB |
| Intermodulation performance | IM | n = 3 ⁷ | _ | -14.3 | _ | dBm |

- 1.0.1% Bit Error Rate.
- 2.0.017% Bit Error Rate.
- 3. With non-ideal signals as specified in Bluetooth Test Specification RF-PHY.TS.5.0.1 section 4.7.1.
- 4. Desired signal -67 dBm.
- 5. Desired frequency 2404 MHz ≤ Fc ≤ 2478 MHz.
- 6. With allowed exceptions.
- 7. As specified in Bluetooth Core specification version 5.1, Vol 6, Part A, Section 4.4.

4.16.2.4 WLCSP45 Package RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 500 kbps Data Rate

Unless otherwise indicated, typical conditions are: $T_A = 25$ °C, VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz, Packet length is 37 bytes.

Table 4.42. WLCSP45 Package RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 500 kbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------|---|-----|--------|-----|------|
| Rx Max Strong Signal Input Level for 0.1% BER | RX _{SAT} | Signal is reference signal ¹ | _ | 10 | _ | dBm |
| Sensitivity | SENS | Signal is reference signal, 37 byte payload ¹ | _ | -102.6 | _ | dBm |
| | | Signal is reference signal, 255 byte payload ² | _ | -101.3 | _ | dBm |
| | | With non-ideal signals ³ 1 | _ | -101.9 | _ | dBm |
| Signal to co-channel interferer | C/I _{CC} | (see notes) ^{1 4} | _ | 2.1 | _ | dB |
| N ± 1 Adjacent channel selectivity | C/I ₁ | Interferer is reference signal at +1 MHz offset ^{1 5 4 6} | _ | -9.2 | _ | dB |
| | | Interferer is reference signal at -1 MHz offset ^{1 5 4 6} | _ | -9.2 | _ | dB |
| N ± 2 Alternate channel selectivity | C/I ₂ | Interferer is reference signal at +2 MHz offset ^{1 5 4 6} | _ | -47.7 | _ | dB |
| | | Interferer is reference signal at -2 MHz offset ^{1 5 4 6} | _ | -50.8 | _ | dB |
| N ± 3 Alternate channel selectivity | C/I ₃ | Interferer is reference signal at +3 MHz offset ^{1 5 4 6} | _ | -49.2 | _ | dB |
| | | Interferer is reference signal at -3 MHz offset ^{1 5 4 6} | _ | -55.9 | _ | dB |
| Selectivity to image frequency | C/I _{IM} | Interferer is reference signal at image frequency with 1 MHz precision ¹⁶ | _ | -49.2 | _ | dB |
| Selectivity to image frequency ± 1 MHz | C/I _{IM_1} | Interferer is reference signal at image frequency +1 MHz with 1 MHz precision ¹⁶ | _ | -49.2 | _ | dB |
| | | Interferer is reference signal at image frequency -1 MHz with 1 MHz precision 1 6 | _ | -47.7 | _ | dB |

- 1.0.1% Bit Error Rate.
- 2.0.017% Bit Error Rate.
- 3. With non-ideal signals as specified in Bluetooth Test Specification RF-PHY.TS.5.0.1 section 4.7.1.
- 4. Desired signal -67 dBm.
- 5. Desired frequency 2402 MHz \leq Fc \leq 2480 MHz.
- 6. With allowed exceptions.

4.16.2.5 WLCSP45 Package RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 125 kbps Data Rate

Unless otherwise indicated, typical conditions are: $T_A = 25$ °C, VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz, Packet length is 37 bytes.

Table 4.43. WLCSP45 Package RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 125 kbps Data Rate

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------|--|-----|--------|-----|------|
| Rx Max Strong Signal Input Level for 0.1% BER | RX _{SAT} | Signal is reference signal ¹ | _ | 10 | _ | dBm |
| Sensitivity | SENS | Signal is reference signal, 37 byte payload ¹ | _ | -106.9 | _ | dBm |
| | | Signal is reference signal, 255 byte payload ² | _ | -106.5 | _ | dBm |
| | | With non-ideal signals ³ 1 | _ | -106.5 | _ | dBm |
| Signal to co-channel interferer | C/I _{CC} | (see notes) ^{1 4} | _ | 0.9 | _ | dB |
| N ± 1 Adjacent channel selectivity | C/I ₁ | Interferer is reference signal at +1 MHz offset ^{1 5 4 6} | _ | -13.3 | _ | dB |
| | | Interferer is reference signal at -1 MHz offset ^{1 5 4 6} | _ | -13.4 | _ | dB |
| N ± 2 Alternate channel selectivity | C/I ₂ | Interferer is reference signal at +2 MHz offset ^{1 5 4 6} | _ | -52.6 | _ | dB |
| | | Interferer is reference signal at -2 MHz offset ^{1 5 4 6} | _ | -56.2 | _ | dB |
| N ± 3 Alternate channel selectivity | C/I ₃ | Interferer is reference signal at +3 MHz offset ^{1 5 4 6} | _ | -52.5 | _ | dB |
| | | Interferer is reference signal at -3 MHz offset ^{1 5 4 6} | _ | -59.1 | _ | dB |
| Selectivity to image frequency | C/I _{IM} | Interferer is reference signal at image frequency with 1 MHz precision ¹⁶ | _ | -51.9 | _ | dB |
| Selectivity to image frequency ± 1 MHz | C/I _{IM_1} | Interferer is reference signal at image frequency +1 MHz with 1 MHz precision ^{1 6} | _ | -52.5 | _ | dB |
| | | Interferer is reference signal at image frequency -1 MHz with 1 MHz precision 1 6 | _ | -52.6 | _ | dB |

- 1.0.1% Bit Error Rate.
- 2.0.017% Bit Error Rate.
- 3. With non-ideal signals as specified in Bluetooth Test Specification RF-PHY.TS.5.0.1 section 4.7.1.
- 4. Desired signal -67 dBm.
- 5. Desired frequency 2402 MHz \leq Fc \leq 2480 MHz.
- 6. With allowed exceptions.

4.16.2.6 WLCSP45 Package RF Receiver Characteristics for 802.15.4 DSSS-OQPSK in the 2.4 GHz Band

Unless otherwise indicated, typical conditions are: $T_A = 25$ °C, VBAT = 1.5 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 38.4 MHz. RF center frequency 2.44 GHz.

Table 4.44. WLCSP45 Package RF Receiver Characteristics for 802.15.4 DSSS-OQPSK in the 2.4 GHz Band

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------|--|-----|--------|-----|------|
| Rx Max Strong Signal Input Level for 1% PER | RX _{SAT} | Signal is reference signal ¹ . Packet length is 20 octets | _ | 10 | _ | dBm |
| Sensitivity, 1% PER | SENS | Signal is reference signal. Packet length is 20 octets | _ | -102.3 | _ | dBm |
| Co-channel interferer rejection, 1% PER | CCR | Desired signal 3 dB above sensitivity limit | _ | 2.6 | _ | dB |
| High-side adjacent channel rejection, 1% PER. Desired is reference signal at 3 dB above reference sensitivity level ² | ACR _{P1} | Interferer is reference signal at +1 channel-spacing | _ | 35 | _ | dB |
| Low-side adjacent channel rejection, 1% PER. Desired is reference signal at 3 dB above reference sensitivity level ² | ACR _{M1} | Interferer is reference signal at -1 channel-spacing | _ | 35.2 | _ | dB |
| Alternate channel rejection, 1% PER. Desired is reference signal at 3 dB above reference sensitivity level ² | ACR ₂ | Interferer is reference signal at ± 2 channel-spacing | _ | 47.8 | _ | dB |
| Image rejection , 1% PER. Desired is reference signal at 3 dB above reference sensitivity level ² | IR | Interferer is CW in image band ³ | _ | 38.2 | _ | dB |
| Blocking rejection of all other channels, 1% PER. Desired | BLOCK | Interferer frequency < Desired frequency - 3 channel-spacing | _ | 53.8 | _ | dB |
| is reference signal at 3 dB above reference sensitivity level ² . Interferer is reference signal | | Interferer frequency > Desired frequency + 3 channel-spacing | _ | 53.7 | _ | dB |
| RSSI resolution | RSSI _{RES} | -100 dBm to +5 dBm | _ | 0.25 | _ | dB |
| RSSI accuracy in the linear region as defined by 802.15.4-2020 | RSSI _{LIN} | | _ | +/-6 | _ | dB |

- 1. Reference signal is defined as O-QPSK DSSS per 802.15.4, frequency range = 2400-2483.5 MHz, symbol rate = 62.5 ksymbols/s.
- 2. Reference sensitivity level is -85 dBm.
- 3. Due to low-IF frequency, there is some overlap of adjacent channel and image channel bands. Adjacent channel CW blocker tests place the Interferer center frequency at the desired frequency ± 5 MHz on the channel raster, whereas the image rejection test places the CW interferer near the image frequency of the desired signal carrier, regardless of the channel raster.

4.17 Oscillators

4.17.1 High-Frequency Crystal Oscillator

Unless otherwise indicated, typical conditions are: AVDD = DVDD = 3.0 V. $T_A = 25 ^{\circ}\text{C}$. Minimum and maximum values in this table represent the worst conditions across process variation, operating supply voltage range, and operating temperature range.

Table 4.45. High-Frequency Crystal Oscillator

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|--------------------------|--|-----|------|-----|------|
| Crystal frequency | F _{HFXO} | see note ¹ | _ | 38.4 | _ | MHz |
| Supported crystal equivalent series resistance (ESR) | ESR _{HFXO_38M4} | 38.4 MHz, C _L = 10 pF ² ³ | _ | 40 | 60 | Ω |
| Supported range of crystal load capacitance ⁴ | C _{L_HFXO} | 38.4 MHz, ESR = 40 Ohm ³ | _ | 10 | _ | pF |
| Supply current | I _{HFXO} | | _ | 415 | _ | μΑ |
| Startup time ⁵ | T _{STARTUP} | 38.4 MHz, ESR = 40 Ω , C _L = 10 pF | _ | 160 | _ | μs |
| On-chip tuning cap step size ⁶ | SS _{HFXO} | | _ | 0.04 | _ | pF |

- 1. The BLE radio requires a 38.4 MHz crystal with a tolerance of ± 50 ppm over temperature and aging. Use a crystal with the recommended frequency and tolerance.
- 2. The crystal should have a maximum ESR less than or equal to this maximum rating.
- 3. RF performance characteristics have been determined using crystals with an ESR of 40 Ω and C_L of 10 pF.
- 4. Total load capacitance as seen by the crystal.
- 5. Startup time does not include time implemented by programmable TIMEOUTSTEADY delay.
- 6. The tuning step size is the effective step size when incrementing both of the tuning capacitors by one count. The step size for the each of the individual tuning capacitors is twice this value.

4.17.2 Low-Frequency Crystal Oscillator

Table 4.46. Low-Frequency Crystal Oscillator

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|-----------------------|--|------|--------|------|------|
| Crystal frequency | F _{LFXO} | | _ | 32.768 | _ | kHz |
| Supported crystal equivalent series resistance (ESR) | ESR _{LFXO} | GAIN = 0 | _ | _ | 80 | kΩ |
| | | GAIN = 1 to 3 | _ | _ | 100 | kΩ |
| Supported range of crystal | C _{L_LFXO} | GAIN = 0 | 4 | _ | 6 | pF |
| load capacitance ¹ | | GAIN = 1 | 6 | _ | 10 | pF |
| | | GAIN = 2 (see note ²) | 10 | _ | 12.5 | pF |
| | | GAIN = 3 (see note ²) | 12.5 | _ | 18 | pF |
| Current consumption | I _{CL12p5} | ESR = 70 k Ω , C _L = 12.5 pF, GAIN ³ = 2, AGC ⁴ = 1 | _ | 254 | _ | nA |
| Startup time | T _{STARTUP} | ESR = 70 k Ω , C _L = 7 pF, GAIN ³ = 1, AGC ⁴ = 1 | _ | 43 | _ | ms |
| On-chip tuning cap step size | SS _{LFXO} | | _ | 0.26 | _ | pF |
| On-chip tuning capacitor value at minimum setting ⁵ | C _{LFXO_MIN} | CAPTUNE = 0 | _ | 4 | _ | pF |
| On-chip tuning capacitor value at maximum setting ⁵ | C _{LFXO_MAX} | CAPTUNE = 0x4F | _ | 24.5 | _ | pF |

- 1. Total load capacitance seen by the crystal.
- 2. Crystals with a load capacitance of greater than 12 pF require external load capacitors.
- 3. In LFXO_CAL Register.
- 4. In LFXO_CFG Register.
- 5. The effective load capacitance seen by the crystal will be $C_{LFXO}/2$. This is because each XTAL pin has a tuning cap and the two caps will be seen in series by the crystal.

4.17.3 High-Frequency RC Oscillator (HFRCO)

Unless otherwise indicated, typical conditions are: AVDD = DVDD = 3.0 V. $T_A = 25 ^{\circ}\text{C}$. Minimum and maximum values in this table represent the worst conditions across process variation, operating supply voltage range, and operating temperature range.

Table 4.47. High-Frequency RC Oscillator (HFRCO)

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|------------------------|---|-----|-----|-----|--------|
| Frequency Accuracy | F _{HFRCO_ACC} | For all production calibrated frequencies | -3 | _ | 3 | % |
| Current consumption on all | I _{HFRCO} | F _{HFRCO} = 4 MHz | _ | 28 | _ | μA |
| supplies ¹ | | F _{HFRCO} = 5 MHz | _ | 30 | _ | μA |
| | | F _{HFRCO} = 7 MHz | _ | 60 | _ | μA |
| | | F _{HFRCO} = 10 MHz | _ | 66 | _ | μA |
| | | F _{HFRCO} = 13 MHz | _ | 79 | _ | μA |
| | | F _{HFRCO} = 16 MHz | _ | 88 | _ | μA |
| | | F _{HFRCO} = 19 MHz | _ | 92 | _ | μA |
| | | F _{HFRCO} = 20 MHz | _ | 105 | _ | μA |
| | | F _{HFRCO} = 26 MHz | _ | 118 | _ | μA |
| | | F _{HFRCO} = 32 MHz | _ | 141 | _ | μA |
| | | F _{HFRCO} = 38 MHz | _ | 172 | _ | μA |
| | | F _{HFRCO} = 80 MHz | _ | 289 | _ | μA |
| Clock out current for HFRCODPLL ² | ICLKOUT_HFRCOD PLL | FORCEEN bit of HFRCO0_CTRL = 1 | _ | 3.0 | _ | μΑ/MHz |
| Startup time ³ | T _{STARTUP} | FREQRANGE = 0 to 7 | _ | 1.2 | _ | μs |
| | | FREQRANGE = 8 to 15 | _ | 0.6 | _ | μs |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|------------------------------------|-------------------------|----------------|------|-----|------|------|
| Band frequency limits ⁴ | f _{HFRCO_BAND} | FREQRANGE = 0 | 3.71 | _ | 5.24 | MHz |
| | | FREQRANGE = 1 | 4.39 | _ | 6.26 | MHz |
| | | FREQRANGE = 2 | 5.25 | _ | 7.55 | MHz |
| | | FREQRANGE = 3 | 6.22 | _ | 9.01 | MHz |
| | | FREQRANGE = 4 | 7.88 | _ | 11.6 | MHz |
| | | FREQRANGE = 5 | 9.9 | _ | 14.6 | MHz |
| | | FREQRANGE = 6 | 11.5 | _ | 17.0 | MHz |
| | | FREQRANGE = 7 | 14.1 | _ | 20.9 | MHz |
| | | FREQRANGE = 8 | 16.4 | _ | 24.7 | MHz |
| | | FREQRANGE = 9 | 19.8 | _ | 30.4 | MHz |
| | | FREQRANGE = 10 | 22.7 | _ | 34.9 | MHz |
| | | FREQRANGE = 11 | 28.6 | _ | 44.4 | MHz |
| | | FREQRANGE = 12 | 33.0 | _ | 51.0 | MHz |
| | | FREQRANGE = 13 | 42.2 | _ | 64.6 | MHz |
| | | FREQRANGE = 14 | 48.8 | _ | 74.8 | MHz |
| | | FREQRANGE = 15 | 57.6 | | 87.4 | MHz |

- 1. Does not include additional clock tree current. See specifications for additional current when selected as a clock source for a particular clock multiplexer.
- 2. When the HFRCO is enabled for characterization using the FORCEEN bit, the total current will be the HFRCO core current plus the specified CLKOUT current. When the HFRCO is enabled on demand, the clock current may be different.
- 3. Hardware delay ensures settling to within ± 0.5%. Hardware also enforces this delay on a band change.
- 4. The frequency band limits represent the lowest and highest frequency which each band can achieve over the operating range.

4.17.4 Fast Start_Up RC Oscillator (FSRCO)

Table 4.48. Fast Start_Up RC Oscillator (FSRCO)

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------------|--------------------|----------------|------|-----|------|------|
| FSRCO frequency | F _{FSRCO} | | 17.2 | 20 | 21.2 | MHz |

4.17.5 Precision Low-Frequency RC Oscillator (LFRCO)

Table 4.49. Precision Low-Frequency RC Oscillator (LFRCO)

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-------------------------------|------------------------|---|------|--------|-----|------|
| Nominal oscillation frequency | F _{LFRCO} | | _ | 32.768 | _ | kHz |
| Frequency accuracy | F _{LFRCO_ACC} | Normal mode | -3 | _ | 3 | % |
| | | Precision mode ¹ , across operating temperature range ² | -500 | _ | 500 | ppm |
| Startup time | t _{STARTUP} | Normal mode | _ | 211 | _ | μs |
| | | Precision mode ¹ | _ | 11.7 | _ | ms |
| Current consumption | I _{LFRCO} | Normal mode | _ | 183 | _ | nA |
| | | Precision mode ¹ , T = stable at 25 °C ³ | _ | 664 | _ | nA |

Note:

- 1. The LFRCO operates in high-precision mode when CFG_HIGHPRECEN is set to 1. High-precision mode is not available in EM4.
- 2. Includes \pm 40 ppm frequency tolerance of the HFXO crystal.
- 3. Includes periodic re-calibration against HFXO crystal oscillator.

4.17.6 Ultra Low-Frequency RC Oscillator

Table 4.50. Ultra Low-Frequency RC Oscillator

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------------------|---------------------|----------------|-------|-----|-------|------|
| Oscillation frequency | F _{ULFRCO} | | 0.944 | 1.0 | 1.095 | kHz |

4.18 GPIO with 3 V Nominal IOVDD

Table 4.51. GPIO with 3 V Nominal IOVDD

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------------|------------------------|---|-----------------|------|----------------|------|
| IOVDD supply range | V _{IO} | | 1.71 | 3.0 | 3.8 | V |
| Leakage current | I _{LEAK_IO} | MODEx = DISABLED, IOVDD = 1.71 V | _ | 1.9 | _ | nA |
| | | MODEx = DISABLED, IOVDD = 3.0 V | _ | 2.5 | _ | nA |
| | | MODEx = DISABLED, IOVDD = 3.8 V T _A = 125 °C | _ | _ | 250 | nA |
| Input low voltage ¹ | V _{IL} | Any GPIO pin | _ | _ | 0.3 * IOVDD | V |
| | | RESETn | _ | _ | 0.3 * DVDD | V |
| Input high voltage ¹ | V _{IH} | Any GPIO pin | 0.7 * IOVDD | _ | _ | V |
| | | RESETn | 0.7 * DVDD | _ | _ | V |
| Hysteresis of input voltage | V _{HYS} | Any GPIO pin | 0.05 * IOVDD | _ | _ | V |
| | | RESETn | 0.05 * DVDD | _ | _ | V |
| Output high voltage | V _{OH} | Sourcing 20 mA, IOVDD = 3.0 V | 0.8 * IOVDD | _ | _ | V |
| | | Sourcing 8 mA, IOVDD = 1.71 V | 0.6 * IOVDD | _ | _ | V |
| Output low voltage | V _{OL} | Sinking 20 mA, IOVDD = 3.0 V | _ | _ | 0.2 * IOVDD | V |
| | | Sinking 8 mA, IOVDD = 1.71 V | _ | _ | 0.4 * IOVDD | V |
| GPIO rise time | T _{GPIO_RISE} | IOVDD = 3.0 V, C _{load} = 50 pF, SLEWRATE = 4, 10% to 90% | _ | 8.4 | _ | ns |
| | | IOVDD = 1.71 V, C _{load} = 50 pF, SLEWRATE = 4, 10% to 90% | _ | 13 | _ | ns |
| GPIO fall time | T _{GPIO_FALL} | IOVDD = 3.0 V, C _{load} = 50 pF, SLEWRATE = 4, 90% to 10% | _ | 7.1 | _ | ns |
| | | IOVDD = 1.71 V, C _{load} = 50 pF, SLEWRATE = 4, 90% to 10% | _ | 11.9 | _ | ns |
| Pull up/down resistance ² | R _{PULL} | Any GPIO pin. Pull-up to IOVDD: MODEn = DISABLE DOUT = 1. Pull-down to VSS: MODEn = WIREDORPULLDOWN DOUT = 0. | 35 | 44 | 55 | kΩ |
| | | RESETn pin. Pull-up to DVDD | 34 | 44 | 60 | kΩ |
| Maximum filtered glitch width | T _{GF} | MODE = INPUT, DOUT = 1 | _ | 27 | _ | ns |
| RESETn low time to ensure pin reset | T _{RESET} | | 100 | _ | _ | ns |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------|--------|----------------|-----|---------------------------------------|-----|------|
| | | | | · · · · · · · · · · · · · · · · · · · | | 4 |

- 1. GPIO input thresholds are proportional to the IOVDD pin. RESETn input thresholds are proportional to DVDD.
- 2. GPIO pull-ups connect to IOVDD supply, pull-downs connect to VSS. RESETn pull-up connects to DVDD.

4.19 GPIO with 1.5 V Nominal IOVDD

Table 4.52. GPIO with 1.5 V Nominal IOVDD

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-------------------------------|------------------------|---|-----------------|------|-----------------|------|
| IOVDD supply range | V _{IO} | IOVDD BOD Disabled | 1.175 | 1.5 | 1.85 | V |
| Leakage current | I _{LEAK_IO} | MODEx = DISABLED, IOVDD = 1.175 V | _ | 1.4 | _ | nA |
| | | MODEx = DISABLED, IOVDD = 1.5 V | _ | 1.5 | _ | nA |
| | | MODEx = DISABLED, IOVDD = 1.71 V T _A = 55 °C | _ | _ | 90 | nA |
| | | MODEx = DISABLED, IOVDD = 1.71 V T _A = 125 °C | _ | _ | 200 | nA |
| Input low voltage | V _{IL} | | _ | _ | 0.35 * IOVDD | V |
| Input high voltage | V _{IH} | | 0.65 * IOVDD | _ | _ | V |
| Hysteresis of input voltage | V _{HYS} | | 0.05 * IOVDD | _ | _ | V |
| Output high voltage | V _{OH} | Sourcing 8 mA, IOVDD = 1.71 V | 0.6 * IOVDD | _ | _ | V |
| | | Sourcing 4 mA, IOVDD ≥ 1.175 V | 0.6 * IOVDD | _ | _ | V |
| | | Sourcing 0.5 mA, IOVDD ≥ 1.175 V | 0.95 * IOVDD | _ | _ | V |
| Output low voltage | V _{OL} | Sinking 8 mA, IOVDD = 1.71 V | _ | | 0.4 * IOVDD | V |
| | | Sinking 4 mA, IOVDD ≥ 1.175 V | _ | _ | 0.4 * IOVDD | V |
| | | Sinking 0.5 mA, IOVDD ≥ 1.175 V | _ | _ | 0.05 * IOVDD | V |
| GPIO rise time | T _{GPIO_RISE} | IOVDD = 1.5 V, C_{load} = 50 pF, SLEWRATE = 4, 10% to 90% | _ | 11.9 | _ | ns |
| | | IOVDD = 1.175 V, C _{load} = 50 pF, SLEWRATE = 4, 10% to 90% | _ | 17.0 | _ | ns |
| GPIO fall time | T _{GPIO_FALL} | IOVDD = 1.5 V, C _{load} = 50 pF, SLEWRATE = 4, 90% to 10% | _ | 12.5 | _ | ns |
| | | IOVDD = 1.175 V, C _{load} = 50 pF, SLEWRATE = 4, 90% to 10% | _ | 17.8 | _ | ns |
| Pull up/down resistance | R _{PULL} | Any GPIO pin. Pull-up to IOVDD: MODEn = DISABLE DOUT = 1. Pull-down to VSS: MODEn = WIREDORPULLDOWN DOUT = 0. | 35 | 44 | 55 | kΩ |
| Maximum filtered glitch width | T _{GF} | MODE = INPUT, DOUT = 1 | _ | 27 | _ | ns |

4.20 Analog to Digital Converter (IADC)

Unless otherwise indicated, specified at 1 Msps, ADCCLK = 10 MHz, OSR = 2.

Table 4.53. Analog to Digital Converter (IADC)

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|-----------------------|---|------------------|-------------------------|------------------|-------|
| Main analog supply | V _{AVDD} | Normal Mode | 1.71 | _ | 3.8 | V |
| Maximum input range ¹ | V _{IN_MAX} | Maximum allowable input voltage | 0 | _ | AVDD | V |
| Full-scale voltage | V _{FS} | Voltage required for full-scale measurement | _ | V _{REF} / Gain | _ | V |
| Input measurement range | V _{IN} | Differential mode - plus and minus inputs | -V _{FS} | _ | +V _{FS} | V |
| | | Single ended mode - one input tied to ground | 0 | _ | V _{FS} | V |
| Input sampling capacitance | Cs | Analog Gain = 1x | _ | 1.8 | _ | pF |
| | | Analog Gain = 2x | _ | 3.6 | _ | pF |
| | | Analog Gain = 3x | _ | 5.4 | _ | pF |
| | | Analog Gain = 4x | _ | 7.2 | _ | pF |
| | | Analog Gain = 0.5x | _ | 0.9 | _ | pF |
| ADC clock frequency | f _{ADC_CLK} | Gain = 1x or 0.5x | _ | _ | 10 | MHz |
| | | Gain = 2x | _ | _ | 5 | MHz |
| | | Gain = 3x or 4x | _ | _ | 2.5 | MHz |
| Input sampling frequency | f _S | | _ | f _{ADC_CLK} /4 | _ | MHz |
| Throughput rate | f _{SAMPLE} | f _{ADC_CLK} = 10 MHz, OSR = 2 | _ | _ | 1 | Msps |
| | | f _{ADC_CLK} = 10 MHz, OSR = 32 | _ | _ | 76.9 | ksps |
| Current from all supplies, Continuous operation | I _{ADC_CONT} | 1 Msps, OSR = 2, f _{ADC_CLK} = 10 MHz | _ | 290 | 385 | μA |
| Current in Standby mode. ADC is not functional but can wake up in 1us. | I _{STBY} | | _ | 16 | _ | μА |
| ADC startup time | t _{startup} | From power down state | _ | 5 | _ | μs |
| | | From standby state | _ | 1 | _ | μs |
| ADC resolution ² | Resolution | | _ | 12 | _ | bits |
| Differential Nonlinearity | DNL | Differential Input, OSR = 2, (No missing codes) . | -0.998 | +/- 0.25 | 1.5 | LSB12 |
| Integral Nonlinearity | INL | Differential Input, OSR = 2. | -2.5 | +/- 0.65 | 2.5 | LSB12 |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|--------|---|------|--------|-----|-------|
| Effective number of bits ³ | ENOB | Differential Input. Gain = 1x, OSR = 2, f _{IN} = 10 kHz, Internal VREF = 1.21 V. OSR = 2 | 10.5 | 11.7 | _ | bits |
| | | Differential Input. Gain = 1x, OSR = 32, f _{IN} = 2.5 kHz, Internal VREF = 1.21 V. | _ | 13.5 | _ | bits |
| | | Differential Input. Gain = 1x, OSR = 32, f _{IN} = 2.5 kHz, External VREF = 1.25 V. | _ | 14.3 | _ | bits |
| Signal to noise + distortion ratio ³ | SNDR | Differential Input. Gain = 1x, OSR = 2, f _{IN} = 10 kHz, Internal VREF = 1.21 V | 65 | 72.3 | _ | dB |
| | | Differential Input. Gain = 2x, OSR = 2, f _{IN} = 10 kHz, Internal VREF = 1.21 V | _ | 72.3 | _ | dB |
| | | Differential Input. Gain = 4x, OSR = 2, f _{IN} = 10 kHz, Internal VREF = 1.21 V | _ | 68.8 | _ | dB |
| | | Differential Input. Gain = 0.5x, OSR = 2, f _{IN} = 10 kHz, Internal VREF = 1.21 V | _ | 72.5 | _ | dB |
| Total harmonic distortion | THD | Differential Input. Gain = 1x, OSR = 2, f _{IN} = 10 kHz, Internal VREF = 1.21 V | _ | -80.8 | -70 | dB |
| Spurious-free dynamic range | SFDR | Differential Input. Gain = 1x, OSR = 2, f _{IN} = 10 kHz, Internal VREF = 1.21 V | 72 | 86.5 | _ | dB |
| Common mode rejection ra- | CMRR | DC to 100 Hz | _ | 87.0 | _ | dB |
| tio | | AC high frequency | _ | 68.6 | _ | dB |
| Power supply rejection ratio | PSRR | DC to 100 Hz | _ | 80.4 | _ | dB |
| | | AC high frequency, using VREF pad. | _ | 33.4 | _ | dB |
| | | AC high frequency, using internal VBGR. | _ | 65.2 | _ | dB |
| Gain error | GE | GAIN = 1 and 0.5, using external VREF | -0.3 | 0.0165 | 0.3 | % |
| | | GAIN = 2, using external VREF | -0.4 | 0.0426 | 0.4 | % |
| | | GAIN = 3, using external VREF | -0.7 | 0.0864 | 0.7 | % |
| | | GAIN = 4, using external VREF | -1.1 | 0.107 | 1.1 | % |
| | | Internal VREF ⁴ , all GAIN settings | -1.5 | 0.064 | 1.5 | % |
| Offset error | OFFSET | GAIN = 1 and 0.5, Differential Input | -3 | -0.45 | 3 | LSB12 |
| | | GAIN = 2, Differential Input | -4 | -0.44 | 4 | LSB12 |
| | | GAIN = 3, Differential Input | -4 | -0.47 | 4 | LSB12 |
| | | GAIN = 4, Differential Input | -4 | -0.47 | 4 | LSB12 |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|--------------------|----------------|-----|------|------|------|
| External reference voltage range ¹ | V _{EVREF} | | 1.0 | _ | AVDD | V |
| Internal reference voltage | V _{IVREF} | | _ | 1.21 | _ | V |

- 1. When inputs are routed to external GPIO pins, the maximum pin voltage is limited to the lower of the IOVDD and AVDD supplies.
- 2. ADC output resolution depends on the OSR and digital averaging settings. With no digital averaging, ADC output resolution is 12 bits at OSR = 2, 13 bits at OSR = 4, 14 bits at OSR = 8, 15 bits at OSR = 16, 16 bits at OSR = 32, and 17 bits at OSR = 64. Digital averaging has a similar impact on ADC output resolution. See the product reference manual for additional details.
- 3. The relationship between ENOB and SNDR is specified according to the equation: ENOB = (SNDR 1.76) / 6.02.
- 4. Includes error from internal VREF drift.

4.21 Analog Comparator (ACMP)

Table 4.54. Analog Comparator (ACMP)

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------------|--|------|------|------|------|
| ACMP supply current | I _{ACMP} | BIAS = 0 ¹ , HYST = DISABLED (100 °C max) | _ | 63 | _ | nA |
| | | BIAS = 1 ¹ , HYST = DISABLED | _ | 252 | _ | nA |
| | | BIAS = 2 ¹ , HYST = DISABLED | _ | 628 | _ | nA |
| | | BIAS = 3 ¹ , HYST = DISABLED | _ | 2.3 | _ | μA |
| | | BIAS = 4, HYST = DISABLED | _ | 5.2 | _ | μA |
| | | BIAS = 5, HYST = DISABLED | _ | 10 | _ | μA |
| | | BIAS = 6, HYST = DISABLED | _ | 25 | _ | μA |
| | | BIAS = 7, HYST = DISABLED | _ | 47 | 80 | μA |
| ACMP supply current with hysteresis | I _{ACMP_WHYS} | BIAS = 0 ¹ , HYST = SYM30MV (100 °C max) | _ | 81 | _ | nA |
| | | BIAS = 1 ¹ , HYST = SYM30MV | _ | 346 | _ | nA |
| | | BIAS = 2 ¹ , HYST = SYM30MV | _ | 871 | _ | nA |
| | | BIAS = 3 ¹ , HYST = SYM30MV | _ | 3.23 | _ | μA |
| | | BIAS = 4, HYST = SYM30MV | _ | 7.1 | _ | μA |
| | | BIAS = 5, HYST = SYM30MV | _ | 15 | _ | μA |
| | | BIAS = 6, HYST = SYM30MV | _ | 36 | _ | μA |
| | | BIAS = 7, HYST = SYM30MV | _ | 67 | _ | μA |
| Current consumption from | I _{VREFDIV} | NEGSEL = VREFDIVAVDD | _ | 3.2 | _ | μA |
| VREFDIV in continuous mode | | NEGSEL = VREFDIV1V25 | _ | 4.2 | _ | μA |
| | | NEGSEL = VREFDIV2V5 | _ | 7.0 | _ | μA |
| Current consumption from | I _{VREFDIV_SH} | NEGSEL = VREFDIV2V5LP | _ | 72 | _ | nA |
| VREFDIV in sample/hold mode | | NEGSEL = VREFDIV1V25LP | _ | 66 | _ | nA |
| | | NEGSEL = VREFDIVAVDDLP | _ | 68 | _ | nA |
| Current consumption from VSENSEDIV in continuous mode | I _{VSENSEDIV} | NEGSEL = VSENSE01DIV4 | _ | 1.7 | _ | μA |
| Current consumption from VSENSEDIV in sample/hold mode | I _{VSENSEDIV_SH} | NEGSEL = VSENSE01DIV4LP | _ | 55 | _ | nA |
| Hysteresis (BIAS = 0) | V _{HYST_0} | HYST = SYM10MV ² | _ | 20 | _ | mV |
| | | HYST = SYM20MV ² | _ | 38 | _ | mV |
| | | HYST = SYM30MV ² | _ | 54 | _ | mV |
| Reference voltage | V _{ACMPREF} | Internal 1.25 V Reference | 1.18 | 1.25 | 1.3 | V |
| | | Internal 2.5 V Reference | 2.36 | 2.5 | 2.61 | V |

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---------------------------|---------------------|---------------------------------------|-----|------|------|------|
| Input offset voltage | V _{OFFSET} | BIAS = 0, VCM = 0.15 to AVDD - 0.15 V | -25 | _ | 25 | mV |
| | | BIAS = 2, VCM = 0.15 to AVDD - 0.15 V | -25 | _ | 25 | mV |
| | | BIAS = 4, VCM = 0.15 to AVDD - 0.15 V | -25 | _ | 25 | mV |
| | | BIAS = 7, VCM = 0.15 to AVDD - 0.15 V | -25 | _ | 25 | mV |
| Input range | V _{IN} | Input Voltage Range | 0 | _ | AVDD | V |
| Comparator delay with 100 | T _{DELAY} | BIAS = 0, (100 °C max) | _ | 11 | _ | μs |
| mV overdrive | | BIAS = 1 | _ | 2.9 | _ | μs |
| | | BIAS = 2 | _ | 1.4 | _ | μs |
| | | BIAS = 3 | _ | 0.56 | _ | μs |
| | | BIAS = 4 | _ | 211 | _ | ns |
| | | BIAS = 5 | _ | 120 | _ | ns |
| | | BIAS = 6 | _ | 70 | _ | ns |
| | | BIAS = 7 | _ | 51 | _ | ns |

4.22 External Trace Tamper Detection Supply Current

Unless otherwise indicated, typical conditions are: AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V. T_A = 25 °C.

Table 4.55. External Trace Tamper Detection Supply Current

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|----------------------------|-----------------|---|-----|-----|-----|------|
| Supply current consumption | IETAMPDET | One channel, operating from 1 kHz ULFRCO divided down to 100 Hz, with 1 nF load capacitance from GPIO to ground | - | 81 | _ | nA |
| | | One channel, operating from 32.768 kHz LFXO divided down to 100 Hz, with 1 nF load capacitance from GPIO to ground | _ | 154 | _ | nA |
| | | One channel, operating from 32.768 kHz LFRCO divided down to 100 Hz, with 1 nF load capacitance from GPIO to ground | _ | 154 | _ | nA |

^{1.} When using the 1.25 V or 2.5 V VREF in continuous mode (VREFDIV1V25 or VREFDIV2V5) and BIAS < 4, an additional 1 μ A of supply current is required.

 $^{2.}V_{CM} = 1.25 V$

4.23 Temperature Sensor

Table 4.56. Temperature Sensor

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|---|-------------------------|--|--------------|--------|-----|------|
| Temperature sensor range ¹ | T _{RANGE} | | -40 | _ | 125 | °C |
| Temperature sensor resolution | T _{RESOLUTION} | | _ | 0.25 | _ | °C |
| Measurement noise (RMS) | T _{NOISE} | Single measurement | _ | 0.6 | _ | °C |
| | | 16-sample average (TEMPAVG- NUM = 0) | _ | 0.17 | _ | °C |
| | | 64-sample average (TEMPAVG- NUM = 1) | _ | 0.12 | _ | °C |
| Temperature offset | T _{OFF} | Mean error of uncorrected output across full temperature range | _ | 2.4 | _ | °C |
| Temperature sensor accuracy ² ³ | T _{ACC} | Direct output accuracy after mean error (T _{OFF}) removed | _ | +/-3 | _ | °C |
| | | After linearization in software, no calibration | _ | +/-2 | _ | °C |
| | | After linearization in software, with single-temperature calibration at 25 °C ⁴ | _ | +/-1.5 | _ | °C |
| Measurement interval | t _{MEAS} | | _ | 250 | _ | ms |

- 1. The sensor reports absolute die temperature in Kelvin (K). All specifications are in °C to match the units of the specified product temperature range.
- 2. Error is measured as the deviation of the mean temperature reading from the expected die temperature. Accuracy numbers represent statistical minimum and maximum using ± 4 standard deviations of measured error.
- 3. The raw output of the temperature sensor is a predictable curve. It can be linearized with a polynomial function for additional accuracy.
- 4. Assuming calibration accuracy of \pm 0.25 °C.

4.24 Brown Out Detectors

4.24.1 DVDD BOD

BOD thresholds on DVDD in EM0 and EM1 only, unless otherwise noted. Typical conditions are at T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation, operating supply voltage range, and operating temperature range.

Table 4.57. DVDD BOD

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-------------------|----------------------------|---|------|------|------|------|
| BOD threshold | V _{DVDD_BOD} | Supply rising | _ | 1.67 | 1.71 | V |
| | | Supply falling | 1.62 | 1.65 | _ | V |
| BOD response time | t _{DVDD_BOD_DE} - | Supply dropping at 100 mV / μs slew rate ¹ | _ | 0.95 | _ | μs |
| BOD hysteresis | V _{DVDD_BOD_HYS} | | _ | 20 | _ | mV |

Note:

4.24.2 LE DVDD BOD

BOD thresholds on DVDD pin for low energy modes EM2 and lower, unless otherwise noted.

Table 4.58. LE DVDD BOD

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-------------------|------------------------------------|---|-----|-----|------|------|
| BOD threshold | V _{DVDD_LE_BOD} | Supply falling | 1.5 | _ | 1.71 | V |
| BOD response time | t _{DVDD_LE_BOD_D} ELAY | Supply dropping at 2 mV / µs slew rate ¹ | _ | 50 | _ | μs |
| BOD hysteresis | V _{DVDD_LE_BOD_} HYST | | _ | 20 | _ | mV |

Note:

1. If the supply slew rate exceeds the specified slew rate, the BOD may trip later than expected (at a threshold below the minimum specified threshold), or the BOD may not trip at all (for example if the supply ramps down and then back up at a very fast rate).

^{1.} If the supply slew rate exceeds the specified slew rate, the BOD may trip later than expected (at a threshold below the minimum specified threshold), or the BOD may not trip at all (for example if the supply ramps down and then back up at a very fast rate).

4.24.3 AVDD and IOVDD BODs

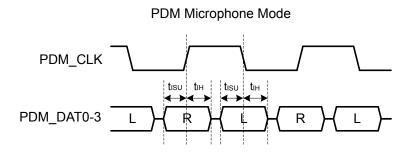
BOD thresholds for AVDD BOD and IOVDD BOD. Available in all energy modes.

Table 4.59. AVDD and IOVDD BODs

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-------------------|------------------------|---|------|-----|------|------|
| BOD threshold | V _{BOD} | Supply falling | 1.45 | _ | 1.71 | V |
| BOD response time | t _{BOD_DELAY} | Supply dropping at 2 mV / μs slew rate ¹ | _ | 50 | _ | μs |
| BOD hysteresis | V _{BOD_HYST} | | _ | 20 | _ | mV |

^{1.} If the supply slew rate exceeds the specified slew rate, the BOD may trip later than expected (at a threshold below the minimum specified threshold), or the BOD may not trip at all (for example if the supply ramps down and then back up at a very fast rate).

4.25 PDM Timing Specifications



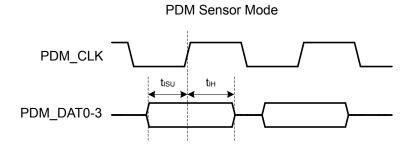


Figure 4.3. PDM Timing Diagrams

4.25.1 Pulse Density Modulator (PDM), Common DBUS

Timing specifications are for all PDM signals routed to the same DBUS (DBUSAB or DBUSCD), though routing to the same GPIO port is the optimal configuration. C_{LOAD} < 20 pF. System voltage scaling = VSCALE1 or VSCALE2. All GPIO set to slew rate = 6. Data delay (PDM_CFG1_DLYMUXSEL) = 0.

Table 4.60. Pulse Density Modulator (PDM), Common DBUS

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|-----------------------|-----------------|------|-----|------|------|
| PDM_CLK frequency during data transfer | F _{PDM_CLK} | Microphone mode | _ | _ | 5 | MHz |
| | | Sensor mode | _ | _ | 20 | MHz |
| PDM_CLK duty cycle | DC _{PDM_CLK} | | 47.5 | _ | 52.5 | % |
| PDM_CLK rise time | t _R | | _ | _ | 5.5 | ns |
| PDM_CLK fall time | t _F | | _ | _ | 5.5 | ns |
| Input setup time | t _{ISU} | Microphone mode | 30 | _ | _ | ns |
| | | Sensor mode | 20 | _ | _ | ns |
| Input hold time | t _{IH} | | 3 | _ | _ | ns |

4.26 USART SPI Main Timing

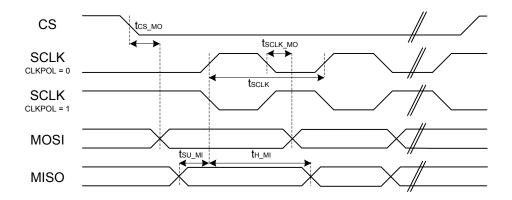


Figure 4.4. SPI Main Timing (SMSDELAY = 0)

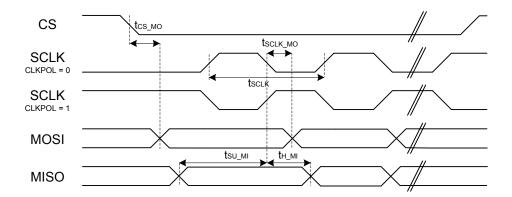


Figure 4.5. SPI Main Timing (SMSDELAY = 1)

4.26.1 USART SPI Main Timing, Voltage Scaling = VSCALE2, IOVDD ≥ 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD). All GPIO set to slew rate = 6.

Table 4.61. USART SPI Main Timing, Voltage Scaling = VSCALE2, IOVDD ≥ 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------|----------------------|----------------|---------------------|-----|-----|------|
| SCLK period ^{1 2 3} | t _{SCLK} | | 2*t _{PCLK} | _ | _ | ns |
| CS to MOSI ^{1 2} | t _{CS_MO} | | -14 | _ | 14 | ns |
| SCLK to MOSI ^{1 2} | t _{SCLK_MO} | | -4 | _ | 13 | ns |
| MISO setup time ^{1 2} | t _{SU_MI} | IOVDD = 1.8 V | 37 | _ | _ | ns |
| | | IOVDD = 3.0 V | 27 | _ | _ | ns |
| MISO hold time ^{1 2} | t _{H_MI} | | -8 | _ | _ | ns |

Note:

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1.
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply.
- 3. t_{PCLK} is one period of the selected PCLK.

4.26.2 USART SPI Main Timing, Voltage Scaling = VSCALE1, IOVDD ≥ 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD). All GPIO set to slew rate = 6.

Table 4.62. USART SPI Main Timing, Voltage Scaling = VSCALE1, IOVDD ≥ 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|----------------------|----------------|---------------------|-----|-----|------|
| SCLK period ^{1 2 3} | t _{SCLK} | | 2*t _{PCLK} | _ | _ | ns |
| CS to MOSI ^{1 2} | t _{CS_MO} | | -25 | _ | 25 | ns |
| SCLK to MOSI ¹ ² | t _{SCLK_MO} | | -7 | _ | 22 | ns |
| MISO setup time ^{1 2} | t _{SU_MI} | IOVDD = 1.8 V | 44 | _ | _ | ns |
| | | IOVDD = 3.0 V | 36 | _ | _ | ns |
| MISO hold time ^{1 2} | t _{H_MI} | | -9 | _ | _ | ns |

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1.
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply.
- $3.\,t_{PCLK}$ is one period of the selected PCLK.

4.26.3 USART SPI Main Timing, Voltage Scaling = VSCALE2, 1.2 V ≤ IOVDD < 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD). All GPIO set to slew rate = 6.

Table 4.63. USART SPI Main Timing, Voltage Scaling = VSCALE2, 1.2 V ≤ IOVDD < 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------|----------------------|----------------|---------------------|-----|-----|------|
| SCLK period ^{1 2 3} | t _{SCLK} | | 2*t _{PCLK} | _ | _ | ns |
| CS to MOSI ^{1 2} | t _{CS_MO} | | -17 | _ | 17 | ns |
| SCLK to MOSI ^{1 2} | t _{SCLK_MO} | | -4 | _ | 15 | ns |
| MISO setup time ^{1 2} | t _{SU_MI} | | 57 | _ | _ | ns |
| MISO hold time ^{1 2} | t _{H_MI} | | -31 | _ | _ | ns |

Note:

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1.
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply.
- 3. t_{PCLK} is one period of the selected PCLK.

4.26.4 USART SPI Main Timing, Voltage Scaling = VSCALE1, 1.2 V ≤ IOVDD < 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD). All GPIO set to slew rate = 6.

Table 4.64. USART SPI Main Timing, Voltage Scaling = VSCALE1, 1.2 V ≤ IOVDD < 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------|----------------------|----------------|---------------------|-----|-----|------|
| SCLK period ^{1 2 3} | t _{SCLK} | | 2*t _{PCLK} | _ | _ | ns |
| CS to MOSI ^{1 2} | t _{CS_MO} | | -28 | _ | 28 | ns |
| SCLK to MOSI ^{1 2} | t _{SCLK_MO} | | -8 | _ | 25 | ns |
| MISO setup time ^{1 2} | t _{SU_MI} | | 66 | _ | _ | ns |
| MISO hold time ^{1 2} | t _{H_MI} | | -34 | _ | _ | ns |

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1.
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply.
- 3. t_{PCLK} is one period of the selected PCLK.

4.27 USART SPI Secondary Timing

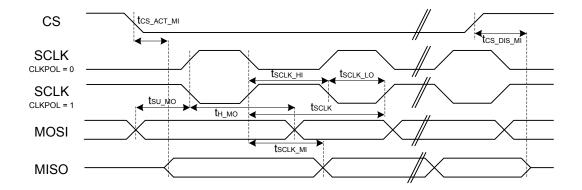


Figure 4.6. SPI Secondary Timing

4.27.1 USART SPI Secondary Timing, Voltage Scaling = VSCALE2, IOVDD ≥ 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD). All GPIO set to slew rate = 6.

Table 4.65. USART SPI Secondary Timing, Voltage Scaling = VSCALE2, IOVDD ≥ 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------------------------------|------------------------|----------------|-------------------------------|-----|-------------------------------|------|
| SCLK period ^{1 2 3} | t _{SCLK} | | 6*t _{PCLK} | _ | _ | ns |
| SCLK high time ^{1 2 3} | t _{SCLK_HI} | | 2.5*t _{PCLK} | _ | _ | ns |
| SCLK low time ^{1 2 3} | t _{SCLK_LO} | | 2.5*t _{PCLK} | _ | _ | ns |
| CS active to MISO ^{1 2} | t _{CS_ACT_MI} | | 19 | _ | 54 | ns |
| CS disable to MISO ^{1 2} | tcs_dis_mi | | 18 | _ | 46 | ns |
| MOSI setup time ^{1 2} | t _{SU_MO} | | 6 | _ | _ | ns |
| MOSI hold time ^{1 2 3} | t _{H_MO} | | 8 | _ | _ | ns |
| SCLK to MISO ^{1 2 3} | t _{SCLK_MI} | | 15 + 1.5*t _{PCLK} | _ | 33 + 2.5*t _{PCLK} | ns |

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply (figure shows 50%).
- 3. $t_{\mbox{\footnotesize{PCLK}}}$ is one period of the selected PCLK.

4.27.2 USART SPI Secondary Timing, Voltage Scaling = VSCALE1, IOVDD ≥ 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD). All GPIO set to slew rate = 6.

Table 4.66. USART SPI Secondary Timing, Voltage Scaling = VSCALE1, IOVDD ≥ 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------------------------------|------------------------|----------------|-------------------------------|-----|-------------------------------|------|
| SCLK period ^{1 2 3} | t _{SCLK} | | 6*t _{PCLK} | _ | _ | ns |
| SCLK high time ^{1 2 3} | t _{SCLK_HI} | | 2.5*t _{PCLK} | _ | _ | ns |
| SCLK low time ^{1 2 3} | t _{SCLK_LO} | | 2.5*t _{PCLK} | _ | _ | ns |
| CS active to MISO ^{1 2} | t _{CS_ACT_MI} | | 24 | _ | 65 | ns |
| CS disable to MISO ^{1 2} | t _{CS_DIS_MI} | | 26 | _ | 64 | ns |
| MOSI setup time ^{1 2} | t _{SU_MO} | | 9 | _ | _ | ns |
| MOSI hold time ^{1 2 3} | t _{H_MO} | | 14 | _ | _ | ns |
| SCLK to MISO ^{1 2 3} | tsclk_mi | | 18 + 1.5*t _{PCLK} | _ | 46 + 2.5*t _{PCLK} | ns |

Note:

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply (figure shows 50%).
- 3. t_{PCLK} is one period of the selected PCLK.

4.27.3 USART SPI Secondary Timing, Voltage Scaling = VSCALE2, 1.2 V ≤ IOVDD < 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD). All GPIO set to slew rate = 6.

Table 4.67. USART SPI Secondary Timing, Voltage Scaling = VSCALE2, 1.2 V ≤ IOVDD < 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------------------------------|------------------------|----------------|-------------------------------|-----|-------------------------------|------|
| SCLK period ^{1 2 3} | tsclk | | 6*t _{PCLK} | _ | _ | ns |
| SCLK high time ^{1 2 3} | t _{SCLK_HI} | | 2.5*t _{PCLK} | _ | _ | ns |
| SCLK low time ^{1 2 3} | t _{SCLK_LO} | | 2.5*t _{PCLK} | _ | _ | ns |
| CS active to MISO ^{1 2} | t _{CS_ACT_MI} | | 32 | _ | 73 | ns |
| CS disable to MISO ^{1 2} | t _{CS_DIS_MI} | | 24 | _ | 55 | ns |
| MOSI setup time ^{1 2} | t _{SU_MO} | | 7 | _ | _ | ns |
| MOSI hold time ^{1 2 3} | t _{H_MO} | | 9 | _ | _ | ns |
| SCLK to MISO ^{1 2 3} | tsclk_mi | | 28 + 1.5*t _{PCLK} | _ | 51 + 2.5*t _{PCLK} | ns |

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply (figure shows 50%).
- 3. t_{PCLK} is one period of the selected PCLK.

4.27.4 USART SPI Secondary Timing, Voltage Scaling = VSCALE1, 1.2 V ≤ IOVDD < 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD). All GPIO set to slew rate = 6.

Table 4.68. USART SPI Secondary Timing, Voltage Scaling = VSCALE1, 1.2 V ≤ IOVDD < 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------------------------------|------------------------|----------------|-------------------------------|-----|-------------------------------|------|
| SCLK period ^{1 2 3} | t _{SCLK} | | 6*t _{PCLK} | _ | _ | ns |
| SCLK high time ^{1 2 3} | t _{SCLK_HI} | | 2.5*t _{PCLK} | _ | _ | ns |
| SCLK low time ^{1 2 3} | t _{SCLK_LO} | | 2.5*t _{PCLK} | _ | _ | ns |
| CS active to MISO ^{1 2} | t _{CS_ACT_MI} | | 37 | _ | 88 | ns |
| CS disable to MISO ^{1 2} | t _{CS_DIS_MI} | | 32 | _ | 74 | ns |
| MOSI setup time ^{1 2} | t _{SU_MO} | | 10 | _ | _ | ns |
| MOSI hold time ^{1 2 3} | t _{H_MO} | | 14 | _ | _ | ns |
| SCLK to MISO ^{1 2 3} | t _{SCLK_MI} | | 31 + 1.5*t _{PCLK} | _ | 65 + 2.5*t _{PCLK} | ns |

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply (figure shows 50%).
- 3. t_{PCLK} is one period of the selected PCLK.

4.28 EUSART SPI Main Timing

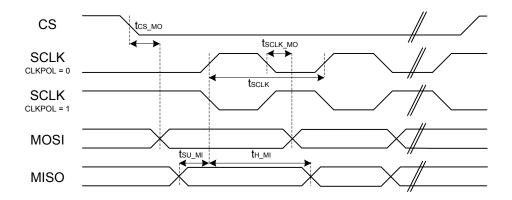


Figure 4.7. SPI Main Timing

4.28.1 EUSART SPI Main Timing, Voltage Scaling = VSCALE2, IOVDD ≥ 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.69. EUSART SPI Main Timing, Voltage Scaling = VSCALE2, IOVDD ≥ 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------|----------------------|----------------|------------------|-----|-----|------|
| SCLK period ^{1 2 3} | t _{SCLK} | | t _{CLK} | _ | _ | ns |
| CS to MOSI ^{1 2} | t _{CS_MO} | | -13 | _ | 11 | ns |
| SCLK to MOSI ^{1 2} | t _{SCLK_MO} | | -4 | _ | 10 | ns |
| MISO setup time ^{1 2} | t _{SU_MI} | | 3 | _ | _ | ns |
| MISO hold time ^{1 2} | t _{H_MI} | | -7 | _ | _ | ns |

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1.
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply.
- $3.\,t_{PCLK}$ is one period of the selected PCLK.

4.28.2 EUSART SPI Main Timing, Voltage Scaling = VSCALE1, IOVDD ≥ 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.70. EUSART SPI Main Timing, Voltage Scaling = VSCALE1, IOVDD ≥ 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------|----------------------|----------------|------------------|-----|-----|------|
| SCLK period ^{1 2 3} | t _{SCLK} | | t _{CLK} | _ | _ | ns |
| CS to MOSI ^{1 2} | t _{CS_MO} | | -24 | _ | 19 | ns |
| SCLK to MOSI ^{1 2} | t _{SCLK_MO} | | -7 | _ | 17 | ns |
| MISO setup time ^{1 2} | t _{SU_MI} | | 12 | _ | _ | ns |
| MISO hold time ^{1 2} | t _{H_MI} | | 7 | _ | _ | ns |

Note:

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1.
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply.
- 3. t_{PCLK} is one period of the selected PCLK.

4.28.3 EUSART SPI Main Timing, Voltage Scaling = VSCALE2, 1.2 V ≤ IOVDD < 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.71. EUSART SPI Main Timing, Voltage Scaling = VSCALE2, 1.2 V ≤ IOVDD < 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------|----------------------|----------------|------------------|-----|-----|------|
| SCLK period ^{1 2 3} | t _{SCLK} | | t _{CLK} | _ | _ | ns |
| CS to MOSI ^{1 2} | t _{CS_MO} | | -16 | _ | 16 | ns |
| SCLK to MOSI ^{1 2} | t _{SCLK_MO} | | -4 | _ | 13 | ns |
| MISO setup time ^{1 2} | t _{SU_MI} | | 5 | _ | _ | ns |
| MISO hold time ^{1 2} | t _{H_MI} | | -8 | _ | _ | ns |

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1.
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply.
- 3. t_{PCLK} is one period of the selected PCLK.

4.28.4 EUSART SPI Main Timing, Voltage Scaling = VSCALE1, 1.2 V ≤ IOVDD < 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.72. EUSART SPI Main Timing, Voltage Scaling = VSCALE1, 1.2 V ≤ IOVDD < 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------------|----------------------|----------------|------------------|-----|-----|------|
| SCLK period ^{1 2 3} | tsclk | | t _{CLK} | _ | _ | ns |
| CS to MOSI ^{1 2} | t _{CS_MO} | | -27 | _ | 24 | ns |
| SCLK to MOSI ^{1 2} | t _{SCLK_MO} | | -7 | _ | 19 | ns |
| MISO setup time ^{1 2} | t _{SU_MI} | | 14 | _ | _ | ns |
| MISO hold time ^{1 2} | t _{H_MI} | | 6 | _ | _ | ns |

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1.
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply.
- $3.\,t_{PCLK}$ is one period of the selected PCLK.

4.29 EUSART SPI Secondary Timing

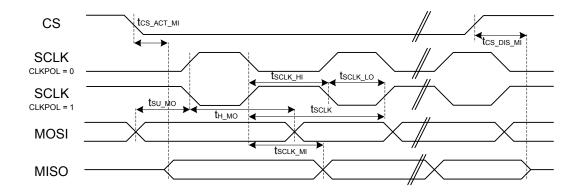


Figure 4.8. SPI Secondary Timing

4.29.1 EUSART SPI Secondary Timing, Voltage Scaling = VSCALE2, IOVDD ≥ 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.73. EUSART SPI Secondary Timing, Voltage Scaling = VSCALE2, IOVDD ≥ 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------------------------------|------------------------|----------------|-----|-----|-----|------|
| SCLK high time ^{1 2} | t _{SCLK_HI} | | 50 | _ | _ | ns |
| SCLK low time ^{1 2} | t _{SCLK_LO} | | 50 | _ | _ | ns |
| CS active to MISO ^{1 2} | t _{CS_ACT_MI} | | 4 | _ | 51 | ns |
| CS disable to MISO ^{1 2} | t _{CS_DIS_MI} | | 5 | _ | 35 | ns |
| MOSI setup time ^{1 2} | t _{SU_MO} | | 8 | _ | _ | ns |
| MOSI hold time ^{1 2} | t _{H_MO} | | 7 | _ | _ | ns |
| SCLK to MISO ^{1 2} | tsclk_MI | IOVDD = 1.8 V | 9 | _ | 41 | ns |
| | | IOVDD = 3.3 V | 9 | _ | 31 | ns |

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply (figure shows 50%).

4.29.2 EUSART SPI Secondary Timing, Voltage Scaling = VSCALE1, IOVDD ≥ 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.74. EUSART SPI Secondary Timing, Voltage Scaling = VSCALE1, IOVDD ≥ 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------------------------------|------------------------|----------------|-----|-----|-----|------|
| SCLK high time ^{1 2} | t _{SCLK_HI} | | 50 | _ | _ | ns |
| SCLK low time ^{1 2} | tsclk_lo | | 50 | _ | _ | ns |
| CS active to MISO ^{1 2} | tcs_act_mi | | 5 | _ | 78 | ns |
| CS disable to MISO ^{1 2} | t _{CS_DIS_MI} | | 5 | _ | 56 | ns |
| MOSI setup time ^{1 2} | t _{SU_MO} | | 12 | _ | _ | ns |
| MOSI hold time ^{1 2} | t _{H_MO} | | 12 | _ | _ | ns |
| SCLK to MISO ^{1 2} | t _{SCLK_MI} | IOVDD = 1.8 V | 10 | _ | 51 | ns |
| | | IOVDD = 3.3 V | 10 | _ | 43 | ns |

Note:

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply (figure shows 50%).

4.29.3 EUSART SPI Secondary Timing, Voltage Scaling = VSCALE0, IOVDD ≥ 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.75. EUSART SPI Secondary Timing, Voltage Scaling = VSCALE0, IOVDD ≥ 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------------------------------|------------------------|----------------|-----|-----|-----|------|
| SCLK high time ^{1 2} | t _{SCLK_HI} | | 100 | _ | _ | ns |
| SCLK low time ^{1 2} | t _{SCLK_LO} | | 100 | _ | _ | ns |
| CS active to MISO ^{1 2} | t _{CS_ACT_MI} | | 8 | _ | 112 | ns |
| CS disable to MISO ^{1 2} | tcs_dis_mi | | 7 | _ | 83 | ns |
| MOSI setup time ^{1 2} | t _{SU_MO} | | 12 | _ | _ | ns |
| MOSI hold time ^{1 2} | t _{H_MO} | | 33 | _ | _ | ns |
| SCLK to MISO ^{1 2} | t _{SCLK_MI} | IOVDD = 1.8 V | 11 | _ | 92 | ns |
| | | IOVDD = 3.3 V | 11 | _ | 83 | ns |

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply (figure shows 50%).

4.29.4 EUSART SPI Secondary Timing, Voltage Scaling = VSCALE2, 1.2 V ≤ IOVDD < 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.76. EUSART SPI Secondary Timing, Voltage Scaling = VSCALE2, 1.2 V ≤ IOVDD < 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------------------------------|------------------------|----------------|-----|-----|-----|------|
| SCLK high time ^{1 2} | t _{SCLK_HI} | | 100 | _ | _ | ns |
| SCLK low time ^{1 2} | tsclk_lo | | 100 | _ | _ | ns |
| CS active to MISO ^{1 2} | t _{CS_ACT_MI} | | 16 | _ | 56 | ns |
| CS disable to MISO ^{1 2} | t _{CS_DIS_MI} | | 14 | _ | 39 | ns |
| MOSI setup time ^{1 2} | t _{SU_MO} | | 8 | _ | _ | ns |
| MOSI hold time ^{1 2} | t _{H_MO} | | 7 | _ | _ | ns |
| SCLK to MISO ^{1 2} | t _{SCLK_MI} | | 34 | _ | 63 | ns |

Note:

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply (figure shows 50%).

4.29.5 EUSART SPI Secondary Timing, Voltage Scaling = VSCALE1, 1.2 V ≤ IOVDD < 1.8 V

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.77. EUSART SPI Secondary Timing, Voltage Scaling = VSCALE1, 1.2 V ≤ IOVDD < 1.8 V

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------------------------------|------------------------|----------------|-----|-----|-----|------|
| SCLK high time ^{1 2} | t _{SCLK_HI} | | 100 | _ | _ | ns |
| SCLK low time ^{1 2} | t _{SCLK_LO} | | 100 | _ | _ | ns |
| CS active to MISO ^{1 2} | t _{CS_ACT_MI} | | 20 | _ | 83 | ns |
| CS disable to MISO ^{1 2} | t _{CS_DIS_MI} | | 17 | _ | 60 | ns |
| MOSI setup time ^{1 2} | t _{SU_MO} | | 13 | _ | _ | ns |
| MOSI hold time ^{1 2} | t _{H_MO} | | 12 | _ | _ | ns |
| SCLK to MISO ^{1 2} | t _{SCLK_MI} | | 38 | _ | 75 | ns |

- 1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
- 2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply (figure shows 50%).

4.30 I2C Electrical Specifications

4.30.1 I2C Standard-mode (Sm)

CLHR is set to 0 in the I2Cn_CTRL register.

Table 4.78. I2C Standard-mode (Sm)

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------|----------------|-----|-----|-----|------|
| SCL clock frequency ¹ | f _{SCL} | | 0 | _ | 100 | kHz |
| SCL clock low time | t _{LOW} | | 4.7 | _ | _ | μs |
| SCL clock high time | tніgн | | 4 | _ | _ | μs |
| SDA set-up time | t _{SU_DAT} | | 250 | _ | _ | ns |
| SDA hold time | t _{HD_DAT} | | 0 | _ | _ | ns |
| Repeated START condition set-up time | t _{SU_STA} | | 4.7 | _ | _ | μs |
| Repeated START condition hold time | t _{HD_STA} | | 4.0 | _ | _ | μs |
| STOP condition set-up time | t _{SU_STO} | | 4.0 | _ | _ | μs |
| Bus free time between a STOP and START condition | t _{BUF} | | 4.7 | _ | _ | μs |

^{1.} The maximum SCL clock frequency listed is assuming that an arbitrary clock frequency is available. The maximum attainable SCL clock frequency may be slightly less using the HFXO or HFRCO due to the limited frequencies available. The CLKDIV should be set to a value that keeps the SCL clock frequency below the max value listed.

4.30.2 I2C Fast-mode (Fm)

CLHR is set to 1 in the I2Cn_CTRL register.

Table 4.79. I2C Fast-mode (Fm)

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------|----------------|-----|-----|-----|------|
| SCL clock frequency ¹ | f _{SCL} | | 0 | _ | 400 | kHz |
| SCL clock low time | t _{LOW} | | 1.3 | _ | _ | μs |
| SCL clock high time | tніgн | | 0.6 | _ | _ | μs |
| SDA set-up time | t _{SU_DAT} | | 100 | _ | _ | ns |
| SDA hold time | t _{HD_DAT} | | 0 | _ | _ | ns |
| Repeated START condition set-up time | tsu_sta | | 0.6 | _ | _ | μs |
| Repeated START condition hold time | t _{HD_STA} | | 0.6 | _ | _ | μs |
| STOP condition set-up time | t _{SU_STO} | | 0.6 | _ | _ | μs |
| Bus free time between a STOP and START condition | t _{BUF} | | 1.3 | _ | _ | μs |

^{1.} The maximum SCL clock frequency listed is assuming that an arbitrary clock frequency is available. The maximum attainable SCL clock frequency may be slightly less using the HFXO or HFRCO due to the limited frequencies available. The CLKDIV should be set to a value that keeps the SCL clock frequency below the max value listed.

4.30.3 I2C Fast-mode Plus (Fm+)

CLHR is set to 1 in the I2Cn_CTRL register.

Table 4.80. I2C Fast-mode Plus (Fm+)

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--|---------------------|----------------|------|-----|------|------|
| SCL clock frequency ¹ | f _{SCL} | | 0 | _ | 1000 | kHz |
| SCL clock low time | t _{LOW} | | 0.5 | _ | _ | μs |
| SCL clock high time | t _{HIGH} | | 0.26 | _ | _ | μs |
| SDA set-up time | t _{SU_DAT} | | 50 | _ | _ | ns |
| SDA hold time | t _{HD_DAT} | | 0 | _ | _ | ns |
| Repeated START condition set-up time | t _{SU_STA} | | 0.26 | _ | _ | μs |
| Repeated START condition hold time | t _{HD_STA} | | 0.26 | _ | _ | μs |
| STOP condition set-up time | t _{SU_STO} | | 0.26 | _ | _ | μs |
| Bus free time between a STOP and START condition | t _{BUF} | | 0.5 | _ | _ | μs |

Note:

4.31 Typical Performance Curves

Typical performance curves indicate typical characterized performance under the stated conditions.

^{1.} The maximum SCL clock frequency listed is assuming that an arbitrary clock frequency is available. The maximum attainable SCL clock frequency may be slightly less using the HFXO or HFRCO due to the limited frequencies available. The CLKDIV should be set to a value that keeps the SCL clock frequency below the max value listed.

4.31.1 Supply Current

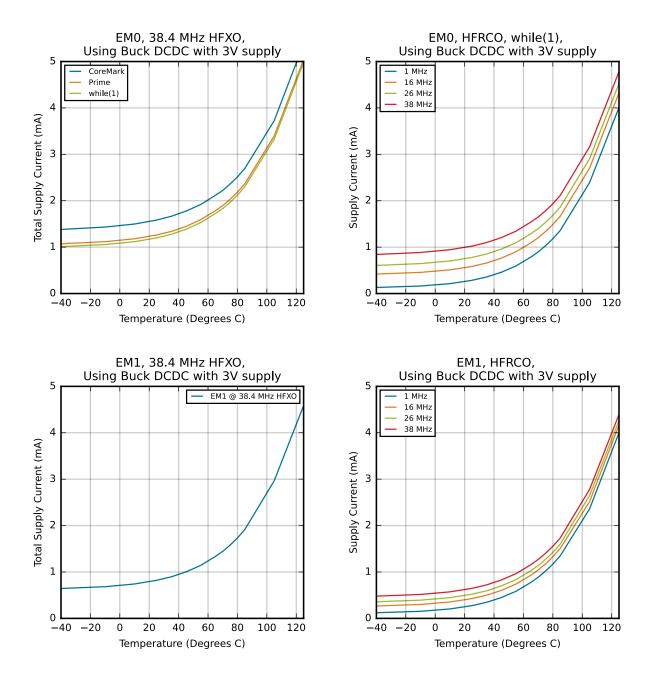


Figure 4.9. EM0 and EM1 Typical Supply Current vs. Temperature (Buck DCDC)

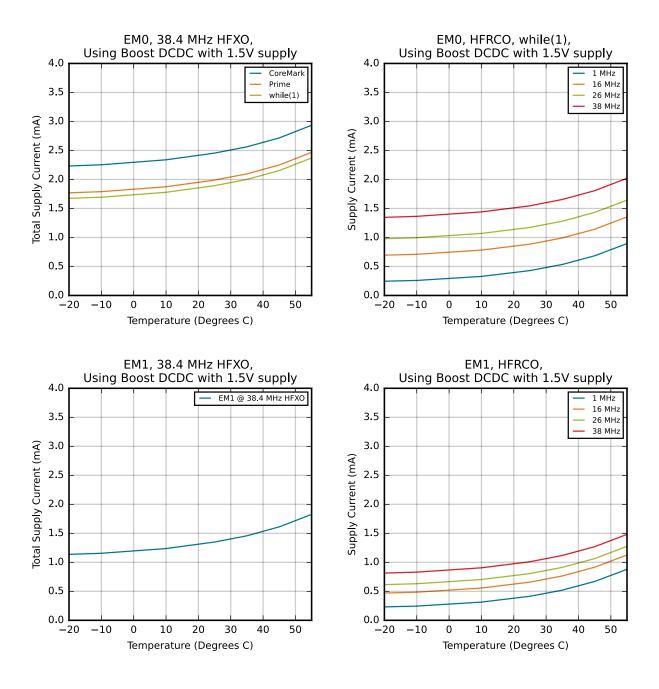


Figure 4.10. EM0 and EM1 Typical Supply Current vs. Temperature (Boost DCDC)

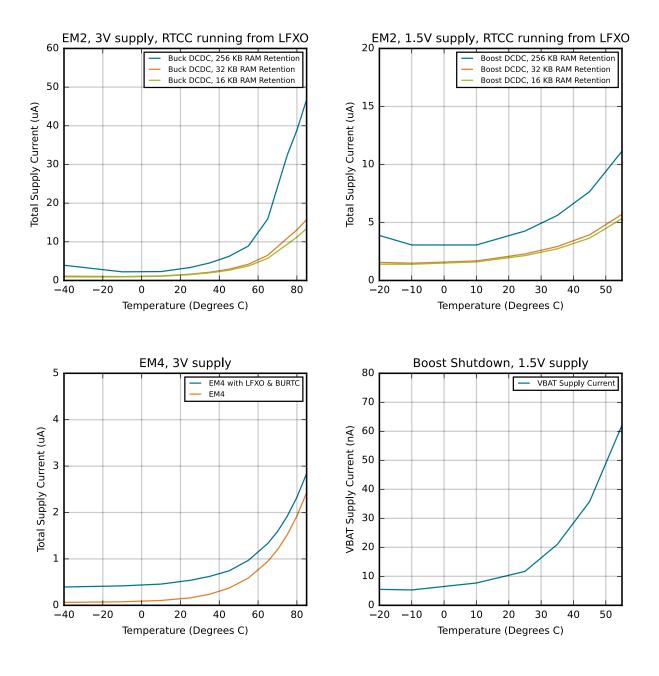


Figure 4.11. EM2, EM4, and Boost Shutdown Typical Supply Current vs. Temperature

4.31.2 RF Characteristics

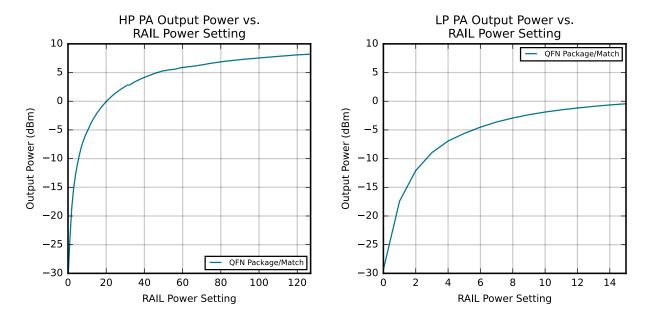


Figure 4.12. Transmitter Output Power, QFN Package / Matching

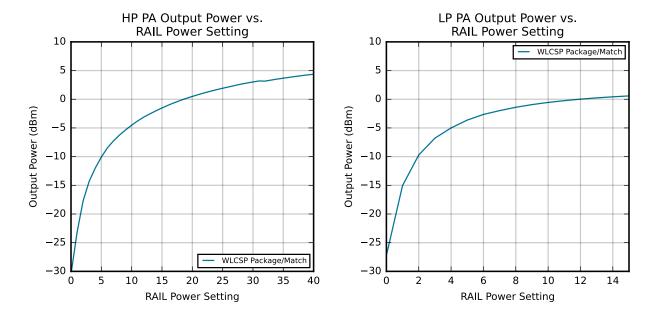


Figure 4.13. Transmitter Output Power, WLCSP Package / Matching

4.31.3 DC-DC Converter

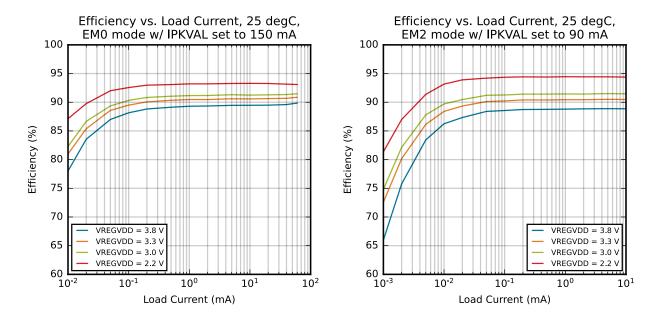


Figure 4.14. Buck DC-DC Efficiency

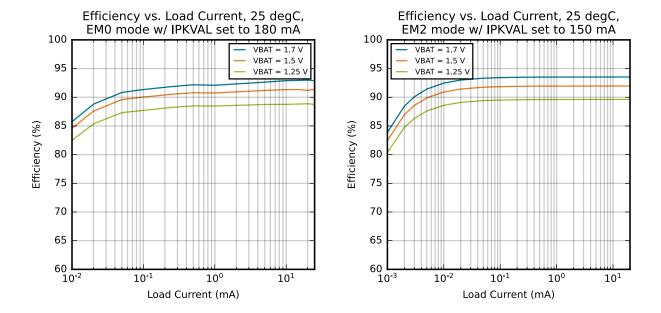


Figure 4.15. Boost DC-DC Efficiency

4.31.4 IADC

Typical performance is shown using 10 MHz ADC clock for fastest sampling speed and adjusting oversampling ratio (OSR).

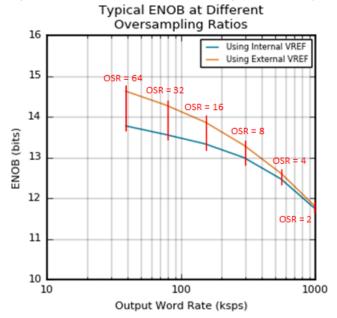


Figure 4.16. Typical ENOB vs. Oversampling Ratio

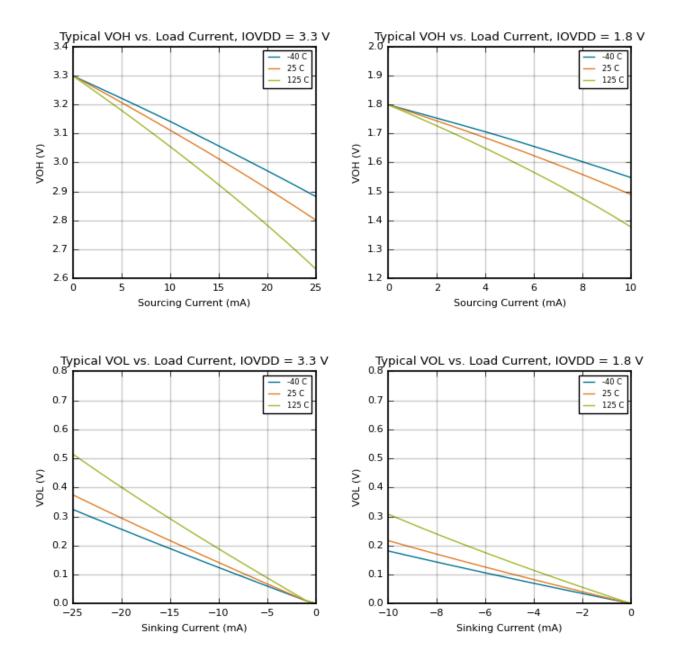


Figure 4.17. VOH and VOL vs. Load Current at 3.3 V and 1.8 V

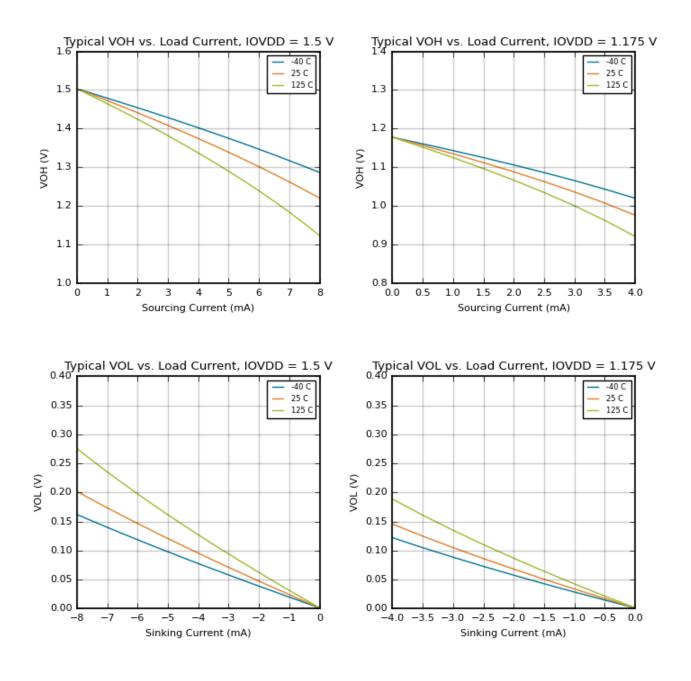


Figure 4.18. VOH and VOL vs. Load Current at 1.5 V and 1.175 V $\,$

5. Typical Connections

5.1 Power

Typical power supply connections are shown in the following figures.

Note: PAVDD, RFVDD, AVDD, and IOVDD supply connections are flexible. They may be connected in other configurations or to external supplies as long as the supply limits described in 4.1 Electrical Characteristics are met.

QFN40 Package Connections

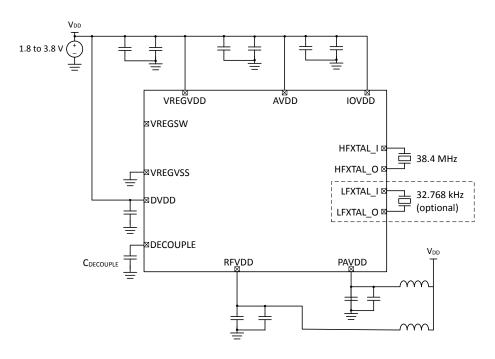


Figure 5.1. Typical Application Circuit: Direct Supply Configuration without DCDC (EFR32xG29B14x)

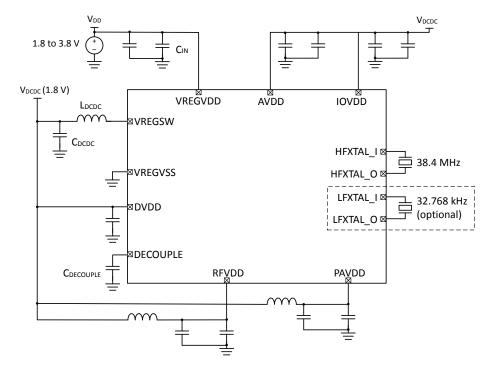


Figure 5.2. Typical Application Circuit: Buck DCDC Configuration with PAVDD, RFVDD, AVDD, and IOVDD from DCDC output (EFR32xG29B14x)

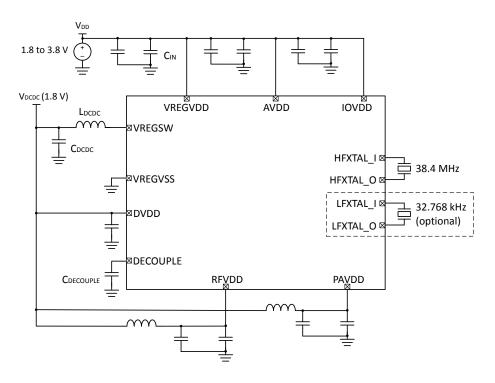
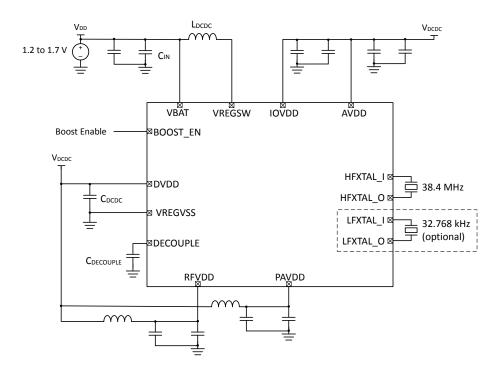
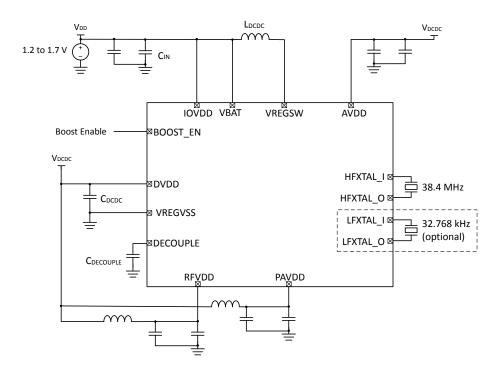


Figure 5.3. Typical Application Circuit: Buck DCDC Configuration with PAVDD and RFVDD from DCDC output (EFR32xG29B14x)



For DCDC always-on configuration, tie BOOST_EN to VBAT.

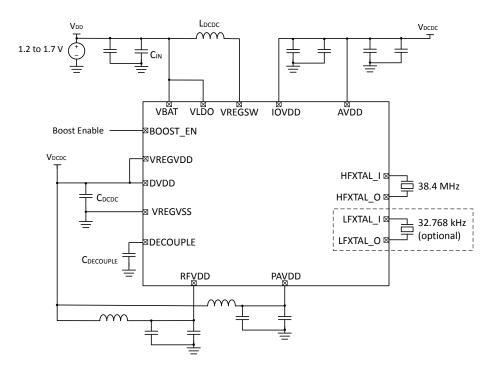
Figure 5.4. Typical Application Circuit: Boost DCDC Configuration with PAVDD, RFVDD, AVDD, and IOVDD from DCDC output (EFR32xG29B23x)



For DCDC always-on configuration, tie BOOST_EN to VBAT.

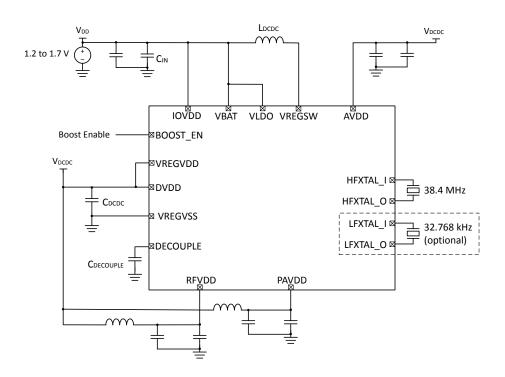
Figure 5.5. Typical Application Circuit: Boost DCDC Configuration with PAVDD, RFVDD and AVDD from DCDC output, IOVDD from VBAT (EFR32xG29B23x)

WLCSP45 Package Connections



For DCDC always-on configuration, tie BOOST_EN to VBAT.

Figure 5.6. Typical Application Circuit: Boost DCDC Configuration with PAVDD, RFVDD, AVDD, and IOVDD from DCDC output (EFR32xG29B22x)



For DCDC always-on configuration, tie BOOST_EN to VBAT.

Figure 5.7. Typical Application Circuit: Boost DCDC Configuration with PAVDD, RFVDD and AVDD from DCDC output, IOVDD from VBAT (EFR32xG29B22x)

5.2 RF Matching Networks

5.2.1 2.4 GHz Matching Network

The RF matching network circuit diagram used for RF characterization is shown in Figure 5.8 Typical RF impedance-matching network circuit on page 137. Typical component values are shown in Table 5.1 Component Values for QFN40 package on page 137 and Table 5.2 Component Values for WLCSP45 package on page 137. Refer to the development board Bill of Materials for specific part recommendation including tolerance, component size, recommended manufacturer, and recommended part number.

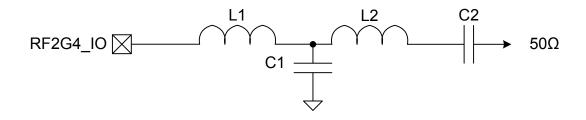


Figure 5.8. Typical RF impedance-matching network circuit

Table 5.1. Component Values for QFN40 package

| Designator | Value |
|------------|--------|
| L1 | 2.0 nH |
| C1 | 1.6 pF |
| L2 | 3.2 nH |
| C2 | 18 pF |

Table 5.2. Component Values for WLCSP45 package

| Designator | Value |
|------------|--------|
| L1 | 3.5 nH |
| C1 | 1.3 pF |
| L2 | 3.8 nH |
| C2 | 18 pF |

5.3 Other Connections

Other components or connections may be required to meet the system-level requirements. Application Note AN0002.2: "EFR32 Wireless Gecko Series 2 Hardware Design Considerations" contains detailed information on these connections. Application Notes can be accessed on the Silicon Labs website (www.silabs.com/32bit-appnotes).

6. Pin Definitions

6.1 WLCSP45 with Boost DC-DC Device Pinout

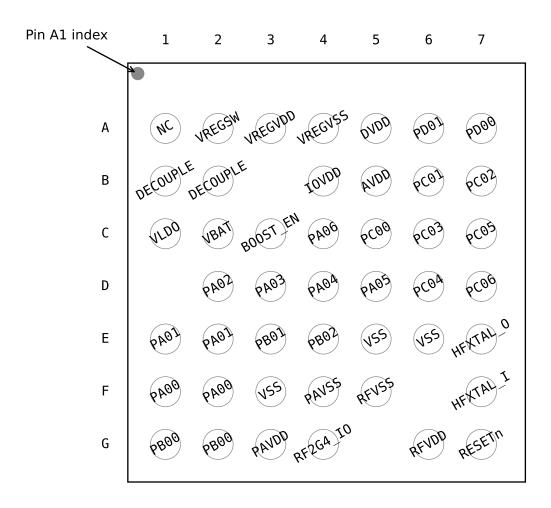


Figure 6.1. WLCSP45 with Boost DC-DC Device Pinout

The following table provides package pin connections and general descriptions of pin functionality. For detailed information on the supported features for each GPIO pin, see 6.4 Alternate Function Table, 6.5 Analog Peripheral Connectivity, and 6.6 Digital Peripheral Connectivity.

Table 6.1. WLCSP45 with Boost DC-DC Device Pinout

| Pin Name | Pin(s) | Description | Pin Name | Pin(s) | Description |
|----------|--------|--|----------|--------|-------------------------------|
| NC | A1 | No internal connection. This pin can be connected to other device pins. | VREGSW | A2 | DCDC regulator switching node |
| VREGVDD | А3 | DCDC feedback. This pin must be connected directly to DVDD for Boost DCDC operation. | VREGVSS | A4 | DCDC ground |
| DVDD | A5 | Digital power supply | PD01 | A6 | GPIO |

| Pin Name | Pin(s) | Description | Pin Name | Pin(s) | Description |
|----------|--------|---|----------|--------|---|
| PD00 | A7 | GPIO | DECOUPLE | B1 | Decouple output for on-chip voltage regulator. An external decoupling capacitor is required at this pin. The two DECOUPLE pins are electrically connected inside the device. One or both may be connected on the PCB. |
| DECOUPLE | B2 | Decouple output for on-chip voltage regulator. An external decoupling capacitor is required at this pin. The two DECOUPLE pins are electrically connected inside the device. One or both may be connected on the PCB. | IOVDD | B4 | I/O power supply |
| AVDD | B5 | Analog power supply | PC01 | В6 | GPIO |
| PC02 | В7 | GPIO | VLDO | C1 | Digital LDO input supply. This pin should be tied to VBAT for Boost DCDC operation. |
| VBAT | C2 | DCDC Boost regulator input supply. | BOOST_EN | C3 | Boost DCDC enable |
| PA06 | C4 | GPIO | PC00 | C5 | GPIO |
| PC03 | C6 | GPIO | PC05 | C7 | GPIO |
| PA02 | D2 | GPIO | PA03 | D3 | GPIO |
| PA04 | D4 | GPIO | PA05 | D5 | GPIO |
| PC04 | D6 | GPIO | PC06 | D7 | GPIO |
| PA01 | E1 | GPIO. The two PA01 pins are electrically connected inside the device. One or both may be connected on the PCB. | PA01 | E2 | GPIO. The two PA01 pins are electrically connected inside the device. One or both may be connected on the PCB. |
| PB01 | E3 | GPIO | PB02 | E4 | GPIO |
| VSS | E5 | Ground | VSS | E6 | Ground |
| HFXTAL_O | E7 | High-frequency crystal output | PA00 | F1 | GPIO. The two PA00 pins are electrically connected inside the device. One or both may be connected on the PCB. |
| PA00 | F2 | GPIO. The two PA00 pins are electrically connected inside the device. One or both may be connected on the PCB. | VSS | F3 | Ground |
| PAVSS | F4 | Power Amplifier (PA) ground | RFVSS | F5 | Radio ground |
| HFXTAL_I | F7 | High-frequency crystal input | PB00 | G1 | GPIO. The two PB00 pins are electrically connected inside the device. One or both may be connected on the PCB. |
| PB00 | G2 | GPIO. The two PB00 pins are electrically connected inside the device. One or both may be connected on the PCB. | PAVDD | G3 | Power Amplifier (PA) power supply |
| RF2G4_IO | G4 | 2.4 GHz Single-ended RF input/output | RFVDD | G6 | Radio power supply |
| RESETn | G7 | Reset. The RESETn pin is internally pulled up to DVDD. | | | |

6.2 QFN40 with Buck DC-DC Device Pinout

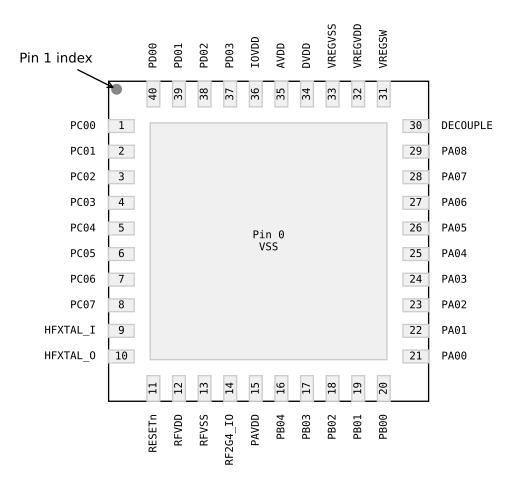


Figure 6.2. QFN40 with Buck DC-DC Device Pinout

The following table provides package pin connections and general descriptions of pin functionality. For detailed information on the supported features for each GPIO pin, see 6.4 Alternate Function Table, 6.5 Analog Peripheral Connectivity, and 6.6 Digital Peripheral Connectivity.

Table 6.2. QFN40 with Buck DC-DC Device Pinout

| Pin Name | Pin(s) | Description | Pin Name | Pin(s) | Description | |
|----------|--------|--|----------|--------|-------------------------------|--|
| PC00 | 1 | GPIO | PC01 | 2 | GPIO | |
| PC02 | 3 | GPIO | PC03 | 4 | GPIO | |
| PC04 | 5 | GPIO | PC05 | 6 | GPIO | |
| PC06 | 7 | GPIO | PC07 | 8 | GPIO | |
| HFXTAL_I | 9 | High-frequency crystal input | HFXTAL_O | 10 | High-frequency crystal output | |
| RESETn | 11 | Reset. The RESETn pin is internally pulled up to DVDD. | RFVDD | 12 | Radio power supply | |

| Pin Name | Pin(s) | Description | Pin Name | Pin(s) | Description | |
|----------|--------|-----------------------------------|----------|--------|--|--|
| RFVSS | 13 | Radio Ground | RF2G4_IO | 14 | 2.4 GHz Single-ended RF input/output | |
| PAVDD | 15 | Power Amplifier (PA) power supply | PB04 | 16 | GPIO | |
| PB03 | 17 | GPIO | PB02 | 18 | GPIO | |
| PB01 | 19 | GPIO | PB00 | 20 | GPIO | |
| PA00 | 21 | GPIO | PA01 | 22 | GPIO | |
| PA02 | 23 | GPIO | PA03 | 24 | GPIO | |
| PA04 | 25 | GPIO | PA05 | 26 | GPIO | |
| PA06 | 27 | GPIO | PA07 | 28 | GPIO | |
| PA08 | 29 | GPIO | DECOUPLE | 30 | Decouple output for on-chip voltage regulator. An external decoupling capacitor is required at this pin. | |
| VREGSW | 31 | DCDC regulator switching node | VREGVDD | 32 | DCDC Buck regulator input supply | |
| VREGVSS | 33 | DCDC ground | DVDD | 34 | Digital power supply | |
| AVDD | 35 | Analog power supply | IOVDD | 36 | I/O power supply | |
| PD03 | 37 | GPIO | PD02 | 38 | GPIO | |
| PD01 | 39 | GPIO | PD00 | 40 | GPIO | |

6.3 QFN40 with Boost DC-DC Device Pinout

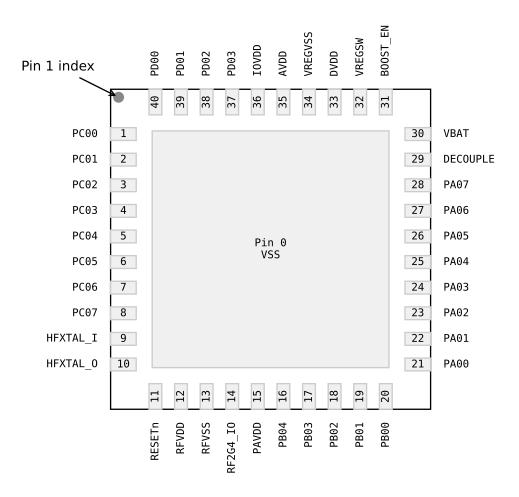


Figure 6.3. QFN40 with Boost DC-DC Device Pinout

The following table provides package pin connections and general descriptions of pin functionality. For detailed information on the supported features for each GPIO pin, see 6.4 Alternate Function Table, 6.5 Analog Peripheral Connectivity, and 6.6 Digital Peripheral Connectivity.

Table 6.3. QFN40 with Boost DC-DC Device Pinout

| Pin Name | Pin(s) | Description | Pin Name | Pin(s) | Description | |
|----------|--------|--|----------|--------|-------------------------------|--|
| PC00 | 1 | GPIO | PC01 | 2 | GPIO | |
| PC02 | 3 | GPIO | PC03 | 4 | GPIO | |
| PC04 | 5 | GPIO | PC05 | 6 | GPIO | |
| PC06 | 7 | GPIO | PC07 | 8 | GPIO | |
| HFXTAL_I | 9 | High-frequency crystal input | HFXTAL_O | 10 | High-frequency crystal output | |
| RESETn | 11 | Reset. The RESETn pin is internally pulled up to DVDD. | RFVDD | 12 | Radio power supply | |

| Pin Name | Pin(s) | Description | Pin Name | Pin(s) | Description | |
|----------|--------|--|----------|--------|--------------------------------------|--|
| RFVSS | 13 | Radio ground | RF2G4_IO | 14 | 2.4 GHz Single-ended RF input/output | |
| PAVDD | 15 | Power Amplifier (PA) power supply | PB04 | 16 | GPIO | |
| PB03 | 17 | GPIO | PB02 | 18 | GPIO | |
| PB01 | 19 | GPIO | PB00 | 20 | GPIO | |
| PA00 | 21 | GPIO | PA01 | 22 | GPIO | |
| PA02 | 23 | GPIO | PA03 | 24 | GPIO | |
| PA04 | 25 | GPIO | PA05 | 26 | GPIO | |
| PA06 | 27 | GPIO | PA07 | 28 | GPIO | |
| DECOUPLE | 29 | Decouple output for on-chip voltage regulator. An external decoupling capacitor is required at this pin. | VBAT | 30 | DCDC boost regulator input supply | |
| BOOST_EN | 31 | Boost DCDC enable | VREGSW | 32 | DCDC regulator switching node | |
| DVDD | 33 | Digital power supply | VREGVSS | 34 | DCDC ground | |
| AVDD | 35 | Analog power supply | IOVDD | 36 | I/O power supply | |
| PD03 | 37 | GPIO | PD02 | 38 | GPIO | |
| PD01 | 39 | GPIO | PD00 | 40 | GPIO | |

6.4 Alternate Function Table

A wide selection of alternate functionality is available for multiplexing to various pins. The following table shows GPIO pins with support for dedicated functions across the different package options.

Table 6.4. GPIO Alternate Function Table

| GPIO | Alternate Functions | WLCSP45 with Boost DC-DC Package ¹ | QFN40 with Buck DC-DC Package ² | QFN40 with Boost DC-DC Package ³ |
|------|-----------------------|--|---|--|
| PA00 | IADC0.VREFP | Yes | Yes | Yes |
| PA01 | GPIO.SWCLK | Yes | Yes | Yes |
| PA02 | GPIO.SWDIO | Yes | Yes | Yes |
| | GPIO.SWV | Yes | Yes | Yes |
| PA03 | GPIO.TDO | Yes | Yes | Yes |
| | GPIO.TRACEDATA0 | Yes | Yes | Yes |
| PA04 | GPIO.TDI | Yes | Yes | Yes |
| PAU4 | GPIO.TRACECLK | Yes | Yes | Yes |
| PA05 | GPIO.TRACEDATA1 | Yes | Yes | Yes |
| PAUS | GPIO.EM4WU0 | Yes | Yes | Yes |
| PA06 | GPIO.TRACEDATA2 | Yes | Yes | Yes |
| PA07 | GPIO.TRACEDATA3 | | Yes | Yes |
| PB01 | ETAMPDET.ETAMPIN0 | Yes | Yes | Yes |
| PBUT | GPIO.EM4WU3 | Yes | Yes | Yes |
| PB03 | GPIO.EM4WU4 | | Yes | Yes |
| | ETAMPDET.ETAMPIN1 | Yes | Yes | Yes |
| PC00 | GPIO.EM4WU6 | Yes | Yes | Yes |
| PC00 | GPIO.THMSW_EN | Yes | Yes | Yes |
| | GPIO.THMSW_HALFSWITCH | Yes | Yes | Yes |
| PC01 | ETAMPDET.ETAMPOUT0 | Yes | Yes | Yes |
| PCUI | GPIO.EFP_TX_SDA | Yes | Yes | Yes |
| DC02 | ETAMPDET.ETAMPOUT1 | Yes | Yes | Yes |
| PC02 | GPIO.EFP_TX_SCL | Yes | Yes | Yes |
| DCOF | GPIO.EFP_INT | Yes | Yes | Yes |
| PC05 | GPIO.EM4WU7 | Yes | Yes | Yes |
| PC07 | GPIO.EM4WU8 | | Yes | Yes |
| PD00 | LFXO.LFXTAL_O | Yes | Yes | Yes |
| PD01 | LFXO.LFXTAL_I | Yes | Yes | Yes |
| | LFXO.LF_EXTCLK | Yes | Yes | Yes |
| PD02 | GPIO.EM4WU9 | | Yes | Yes |

| GPIO Alternate Functions | WLCSP45 with Boost DC-DC Package ¹ | QFN40 with Buck DC-DC Package ² | QFN40 with Boost DC-DC Package ³ | | | |
|--|--|---|--|--|--|--|
| Note: | | | | | | |
| WLCSP45 with Boost DC-DC Package includes OPN EFR32BG29B220F1024CJ45-B QFN40 with Buck DC-DC Package includes OPN EFR32BG29B140F1024IM40-B | | | | | | |
| 3. QFN40 with Boost DC-DC Package includes OPN EFR32BG29B230F1024CM40-B | | | | | | |

6.5 Analog Peripheral Connectivity

Many analog resources are routable and can be connected to numerous GPIOs. The following table indicates which peripherals are available on each GPIO port. When a differential connection is being used, positive inputs are restricted to the EVEN pins and negative inputs are restricted to the ODD pins. When a single-ended connection is being used, positive input is available on all pins. See the device reference manual for more details on the ABUS and analog peripherals. Note that some functions may not be available on all device variants.

Table 6.5. ABUS Routing Table

| Peripheral | Signal | F | PA | F | В | F | C | F | סי |
|------------|---------|------|-----|------|-----|------|-----|------|-----|
| | | EVEN | ODD | EVEN | ODD | EVEN | ODD | EVEN | ODD |
| ACMP0 | ANA_NEG | Yes | Yes | Yes | Yes | Yes | Yes | Yes | Yes |
| | ANA_POS | Yes | Yes | Yes | Yes | Yes | Yes | Yes | Yes |
| IADC0 | ANA_NEG | Yes | Yes | Yes | Yes | Yes | Yes | Yes | Yes |
| | ANA_POS | Yes | Yes | Yes | Yes | Yes | Yes | Yes | Yes |

6.6 Digital Peripheral Connectivity

Many digital resources are routable and can be connected to numerous GPIOs. The following table indicates which peripherals are available on each GPIO port. Note that some functions may not be available on all device variants.

Table 6.6. DBUS Routing Table

| Peripheral.Resource | PORT | | | |
|---------------------|-----------|-----------|-----------|-----------|
| | PA | РВ | PC | PD |
| ACMP0.DIGOUT | Available | Available | Available | Available |
| CMU.CLKIN0 | | | Available | Available |
| CMU.CLKOUT0 | | | Available | Available |
| CMU.CLKOUT1 | | | Available | Available |
| CMU.CLKOUT2 | Available | Available | | |
| EUSART0.CS | Available | Available | Available | Available |
| EUSART0.CTS | Available | Available | Available | Available |
| EUSART0.RTS | Available | Available | Available | Available |
| EUSART0.RX | Available | Available | Available | Available |
| EUSART0.SCLK | Available | Available | Available | Available |
| EUSART0.TX | Available | Available | Available | Available |
| EUSART1.CS | Available | Available | Available | Available |
| EUSART1.CTS | Available | Available | Available | Available |
| EUSART1.RTS | Available | Available | Available | Available |
| EUSART1.RX | Available | Available | Available | Available |
| EUSART1.SCLK | Available | Available | Available | Available |
| EUSART1.TX | Available | Available | Available | Available |
| FRC.DCLK | | | Available | Available |
| FRC.DFRAME | | | Available | Available |
| FRC.DOUT | | | Available | Available |
| I2C0.SCL | Available | Available | Available | Available |
| I2C0.SDA | Available | Available | Available | Available |
| I2C1.SCL | | | Available | Available |
| I2C1.SDA | | | Available | Available |
| LETIMER0.OUT0 | Available | Available | | |
| LETIMER0.OUT1 | Available | Available | | |
| MODEM.ANTO | Available | Available | Available | Available |
| MODEM.ANT1 | Available | Available | Available | Available |
| MODEM.ANT_ROLL_OVER | | | Available | Available |
| MODEM.ANT_RR0 | | | Available | Available |
| MODEM.ANT_RR1 | | | Available | Available |

| Peripheral.Resource | PORT | | | |
|---------------------|-----------|-----------|-----------|-----------|
| | PA | РВ | PC | PD |
| MODEM.ANT_RR2 | | | Available | Available |
| MODEM.ANT_RR3 | | | Available | Available |
| MODEM.ANT_RR4 | | | Available | Available |
| MODEM.ANT_RR5 | | | Available | Available |
| MODEM.ANT_SW_EN | | | Available | Available |
| MODEM.ANT_SW_US | | | Available | Available |
| MODEM.ANT_TRIG | | | Available | Available |
| MODEM.ANT_TRIG_STOP | | | Available | Available |
| MODEM.DCLK | Available | Available | | |
| MODEM.DIN | Available | Available | | |
| MODEM.DOUT | Available | Available | | |
| PDM.CLK | Available | Available | Available | Available |
| PDM.DAT0 | Available | Available | Available | Available |
| PDM.DAT1 | Available | Available | Available | Available |
| PRS.ASYNCH0 | Available | Available | | |
| PRS.ASYNCH1 | Available | Available | | |
| PRS.ASYNCH2 | Available | Available | | |
| PRS.ASYNCH3 | Available | Available | | |
| PRS.ASYNCH4 | Available | Available | | |
| PRS.ASYNCH5 | Available | Available | | |
| PRS.ASYNCH6 | | | Available | Available |
| PRS.ASYNCH7 | | | Available | Available |
| PRS.ASYNCH8 | | | Available | Available |
| PRS.ASYNCH9 | | | Available | Available |
| PRS.ASYNCH10 | | | Available | Available |
| PRS.ASYNCH11 | | | Available | Available |
| PRS.SYNCH0 | Available | Available | Available | Available |
| PRS.SYNCH1 | Available | Available | Available | Available |
| PRS.SYNCH2 | Available | Available | Available | Available |
| PRS.SYNCH3 | Available | Available | Available | Available |
| TIMER0.CC0 | Available | Available | Available | Available |
| TIMER0.CC1 | Available | Available | Available | Available |
| TIMER0.CC2 | Available | Available | Available | Available |
| TIMER0.CDTI0 | Available | Available | Available | Available |
| TIMER0.CDTI1 | Available | Available | Available | Available |
| TIMER0.CDTI2 | Available | Available | Available | Available |

| Peripheral.Resource | PORT | | | |
|---------------------|-----------|-----------|-----------|-----------|
| | PA | РВ | PC | PD |
| TIMER1.CC0 | Available | Available | Available | Available |
| TIMER1.CC1 | Available | Available | Available | Available |
| TIMER1.CC2 | Available | Available | Available | Available |
| TIMER1.CDTI0 | Available | Available | Available | Available |
| TIMER1.CDTI1 | Available | Available | Available | Available |
| TIMER1.CDTI2 | Available | Available | Available | Available |
| TIMER2.CC0 | Available | Available | | |
| TIMER2.CC1 | Available | Available | | |
| TIMER2.CC2 | Available | Available | | |
| TIMER2.CDTI0 | Available | Available | | |
| TIMER2.CDTI1 | Available | Available | | |
| TIMER2.CDTI2 | Available | Available | | |
| TIMER3.CC0 | | | Available | Available |
| TIMER3.CC1 | | | Available | Available |
| TIMER3.CC2 | | | Available | Available |
| TIMER3.CDTI0 | | | Available | Available |
| TIMER3.CDTI1 | | | Available | Available |
| TIMER3.CDTI2 | | | Available | Available |
| TIMER4.CC0 | Available | Available | | |
| TIMER4.CC1 | Available | Available | | |
| TIMER4.CC2 | Available | Available | | |
| TIMER4.CDTI0 | Available | Available | | |
| TIMER4.CDTI1 | Available | Available | | |
| TIMER4.CDTI2 | Available | Available | | |
| USART0.CLK | Available | Available | Available | Available |
| USART0.CS | Available | Available | Available | Available |
| USART0.CTS | Available | Available | Available | Available |
| USART0.RTS | Available | Available | Available | Available |
| USART0.RX | Available | Available | Available | Available |
| USART0.TX | Available | Available | Available | Available |
| USART1.CLK | Available | Available | | |
| USART1.CS | Available | Available | | |
| USART1.CTS | Available | Available | | |
| USART1.RTS | Available | Available | | |
| USART1.RX | Available | Available | | |
| USART1.TX | Available | Available | | |

7. QFN40 Package Specifications

7.1 QFN40 Package Dimensions

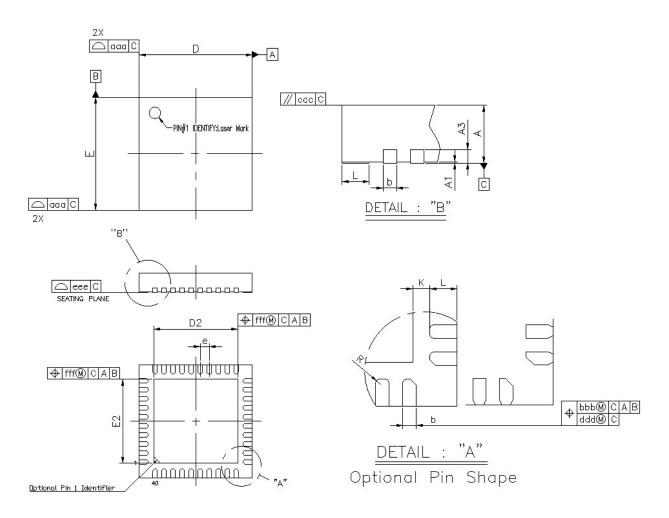


Figure 7.1. QFN40 Package Drawing

Table 7.1. QFN40 Package Dimensions

| Dimension | Min | Тур | Max | | | |
|-----------|-------|----------|------|--|--|--|
| A | 0.80 | 0.85 | 0.90 | | | |
| A1 | 0.00 | 0.02 | 0.05 | | | |
| A3 | | 0.20 REF | | | | |
| b | 0.15 | 0.20 | 0.25 | | | |
| D | 4.90 | 5.00 | 5.10 | | | |
| E | 4.90 | 5.00 | 5.10 | | | |
| D2 | 3.55 | 3.70 | 3.85 | | | |
| E2 | 3.55 | 3.70 | 3.85 | | | |
| е | | 0.40 BSC | | | | |
| L | 0.30 | 0.40 | 0.50 | | | |
| К | 0.20 | _ | _ | | | |
| R | 0.075 | _ | _ | | | |
| aaa | | 0.10 | | | | |
| bbb | | 0.07 | | | | |
| ccc | | 0.10 | | | | |
| ddd | | 0.05 | | | | |
| eee | | 0.08 | | | | |
| fff | | 0.10 | | | | |

Note:

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. Dimensioning and tolerancing per ANSI Y14.5M-1994.
- 3. This drawing conforms to the JEDEC Solid State Outline MO-220, Variation VKKD-4.
- 4. Recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.
- 5. Package external pad (epad) may have pin one chamfer.

7.2 QFN40 PCB Land Pattern

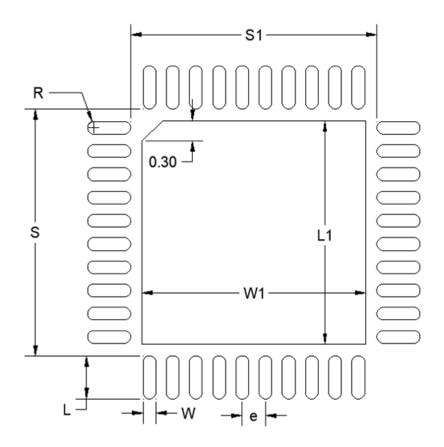


Figure 7.2. QFN40 PCB Land Pattern Drawing

Table 7.2. QFN40 PCB Land Pattern Dimensions

| Dimension | Тур |
|-----------|------|
| S1 | 4.25 |
| S | 4.25 |
| L1 | 3.85 |
| W1 | 3.85 |
| е | 0.40 |
| W | 0.22 |
| L | 0.74 |
| R | 0.11 |

Dimension Typ

Note:

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. This Land Pattern Design is based on the IPC-7351 guidelines.
- 3. A stainless steel, laser-cut, and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
- 4. The stencil thickness should be 0.101 mm (4 mils).
- 5. The ratio of stencil aperture to land pad size can be 1:1 for all perimeter pads.
- 6. A 3x3 array of 0.90 mm square openings on a 1.20 mm pitch can be used for the center ground pad.
- 7. A No-clean, Type-3 solder paste is recommended.
- 8. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.
- 9. Above notes and stencil design are shared as recommendations only. A customer or user may find it necessary to use different parameters and fine tune their SMT process as required for their application and tooling.

7.3 QFN40 Package Marking

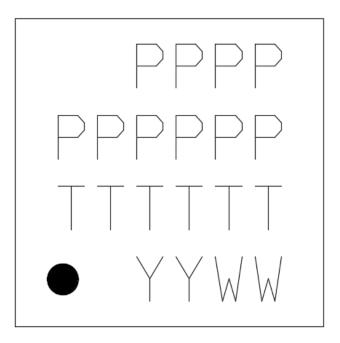


Figure 7.3. QFN40 Package Marking

The package marking consists of:

- FFFF The product family codes (BG29 | MG29)
- PPPPP The product option codes:
 - 1) Security (B = Secure Vault High)
 - 2-4) Product Feature Codes
 - 5) Flash (J = 1024K)
 - 6) Temperature grade (C = -20 to 55 °C | I = -40 to 125 °C)
- TTTTTT A trace or manufacturing code. The first letter is the device revision.
- · YY The last 2 digits of the assembly year.
- WW The 2-digit workweek when the device was assembled.

8. WLCSP45 Package Specifications

8.1 WLCSP45 Package Dimensions

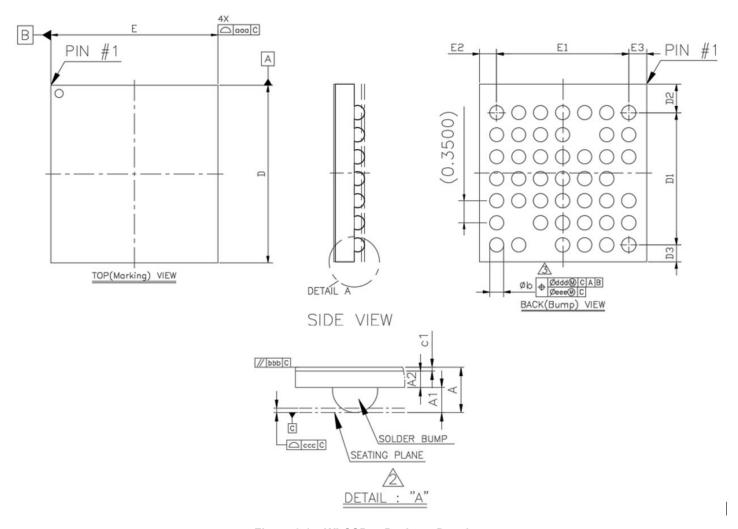


Figure 8.1. WLCSP45 Package Drawing

Table 8.1. WLCSP45 Package Dimensions

| Dimension | Min | Тур | Max | |
|-----------|-------|--------|-------|--|
| A | 0.465 | 0.495 | 0.525 | |
| A1 | 0.150 | 0.165 | 0.180 | |
| A2 | 0.280 | 0.305 | 0.330 | |
| c1 | 0.022 | 0.025 | 0.028 | |
| D | 2.795 | 2.825 | 2.855 | |
| Е | 2.627 | 2.657 | 2.687 | |
| b | 0.195 | 0.225 | 0.255 | |
| D1 | _ | 2.100 | _ | |
| E1 | _ | 2.100 | _ | |
| D2 | _ | 0.4543 | _ | |
| E2 | _ | 0.2713 | _ | |
| D3 | _ | 0.2707 | _ | |
| E3 | _ | 0.2858 | _ | |
| aaa | 0.030 | | | |
| bbb | 0.060 | | | |
| ccc | 0.050 | | | |
| ddd | 0.015 | | | |
| eee | 0.015 | | | |

Note:

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. Primary datum C and seating plane are defined by the spherical crowns of the solder bumps.
- 3. Dimension b is measured at the maximum solder bump diameter, parallel to primary datum C.
- 4. Minimum bump pitch 0.35mm
- 5. Dimensioning and Tolerancing per ANSI Y14.5M-1994.
- 6. This drawing conforms to the JEDEC Solid State Outline MO-220.
- 7. Recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

8.2 WLCSP45 PCB Land Pattern

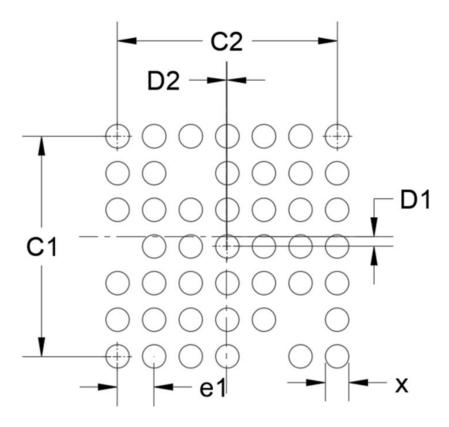


Figure 8.2. WLCSP45 PCB Land Pattern Drawing

Table 8.2. WLCSP45 PCB Land Pattern Dimensions

| Dimension | NOM |
|---|--------|
| X | 0.20 |
| C1 | 2.10 |
| C2 | 2.10 |
| e1 | 0.35 |
| D1 offset between array center and package center | 0.0918 |
| D2 offset between array center and package center | 0.0073 |

Note:

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
- 3. This Land Pattern Design is based on the IPC-7351 guidelines.
- 4. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 μm minimum, all the way around the pad.
- 5. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
- 6. The stencil thickness should be 0.101 mm (4 mils).
- 7. The ratio of stencil aperture to land pad size should be 1:1.
- 8. A No-Clean, Type-3 solder paste is recommended.
- 9. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.
- 10. Above notes and stencil design are shared as recommendations only. A customer or user may find it necessary to use different parameters and fine tune their SMT process as required for their application and tooling.

8.3 WLCSP45 Package Marking

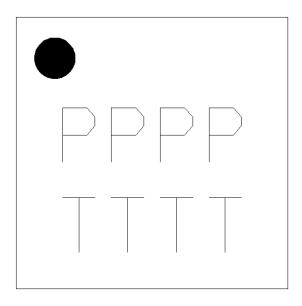


Figure 8.3. WLCSP45 Package Marking

The package marking consists of:

- PPPP The product option codes:
 - 1) Security (B = Secure Vault High)
 - 2-4) Product Feature Codes
- TTTT A trace or manufacturing code.

9. Revision History

Revision 1.0

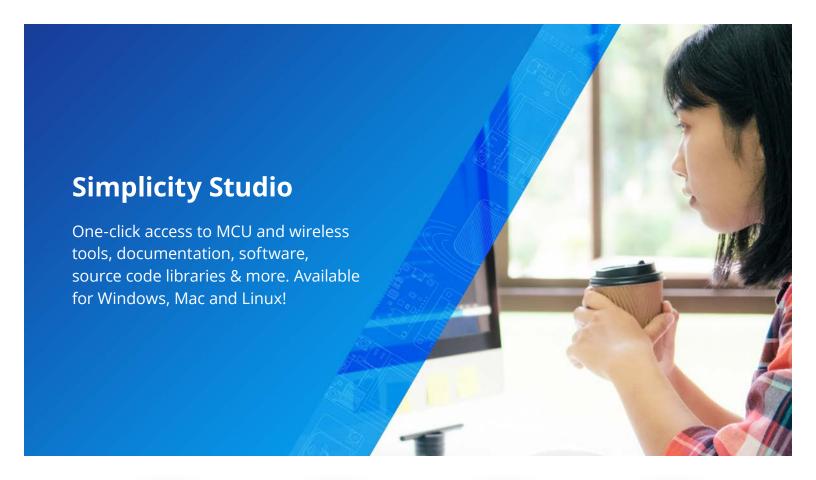
May, 2025

- 4.1 Electrical Characteristics: Specifications updated from characterization data and test limits.
- 2. Ordering Information: Ordering details updated for revision B OPNs.

Revision 0.1

July, 2024

Initial release.





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